

LSM6DS3TR-C: always-on 3D accelerometer and 3D gyroscope

Introduction

This document is intended to provide usage information and application hints related to ST's LSM6DS3TR-C iNEMO inertial module.

The LSM6DS3TR-C is a 3D digital accelerometer and 3D digital gyroscope system-in-package with a digital I²C/SPI serial interface standard output, performing at 0.90 mA in combo High-Performance mode. Thanks to the ultra-low noise performance of both the gyroscope and the accelerometer, the device combines always-on low-power features with superior sensing precision for an optimal motion experience for the consumer. Furthermore, the accelerometer features smart sleep-to-wake-up (Activity) and return-to-sleep (Inactivity) functions that allow advanced power saving.

The device has a dynamic user-selectable full-scale acceleration range of $\pm 2/\pm 4/\pm 8/\pm 16$ g and an angular rate range of $\pm 125/\pm 250/\pm 500/\pm 1000/\pm 2000$ dps.

The LSM6DS3TR-C can be configured to generate interrupt signals by using hardware recognition of free-fall events, 6D orientation, tap and double-tap sensing, activity or inactivity, and wake-up events.

The availability of a dedicated connection mode to external sensors allows the implementation of the sensor hub functionality.

The LSM6DS3TR-C is compatible with the requirements of the leading OSs, offering real, virtual and batch-mode sensors. It has been designed to implement in hardware significant motion, relative tilt, absolute wrist tilt, pedometer functions, timestamp and to support the data acquisition of an external magnetometer with ironing correction (hard, soft).

The LSM6DS3TR-C has an integrated smart first-in first-out (FIFO) buffer of up to 4 Kbyte size, allowing dynamic batching of significant data (i.e. external sensors, step counter, timestamp and temperature).

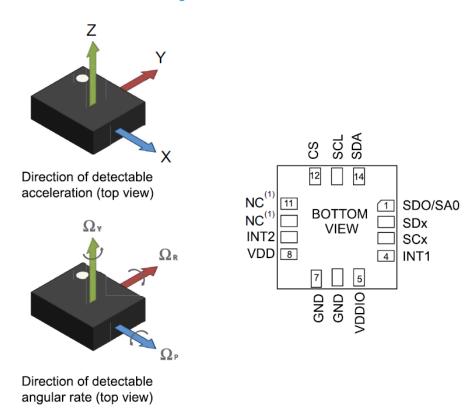
The LSM6DS3TR-C is available in a small plastic land grid array package (LGA-14L) and it is guaranteed to operate over an extended temperature range from -40 °C to +85 °C.

The ultra-small size and weight of the SMD package make it an ideal choice for handheld portable applications such as smartphones, IoT connected devices, and wearables or any other application where reduced package size and weight are required.



1 Pin description

Figure 1. Pin connections



1. Leave pin electrically unconnected and soldered to PCB.

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Table 1. Pin status

Pin#	Name	Mode 1 function	Mode 2 function	Pin status Mode 1	Pin status Mode 2
	SDO	SPI 4-wire interface serial data output (SDO)	SPI 4-wire interface serial data output (SDO)	Default: Input without pull-up.	Default: Input without pull-up. Pull-up is enabled
1	SA0	I ² C least significant bit of the device address (SA0)	I ² C least significant bit of the device address (SA0)	if bit SIM = 1 (SPI 3-wire) in reg 12h.	if bit SIM = 1 (SPI 3-wire) in reg 12h.
2	SDx	Connect to VDDIO or GND	I ² C serial data master (MSDA)	Default: input without pull-up. Pull-up is enabled if bit PULL_UP_EN = 1 in reg 1Ah.	Default: input without pull-up. Pull-up is enabled if bit PULL_UP_EN = 1 in reg 1Ah.
3	SCx	Connect to VDDIO or GND	I ² C serial clock master (MSCL)	Default: input without pull-up. Pull-up is enabled if bit PULL_UP_EN = 1 in reg 1Ah.	Default: input without pull-up. Pull-up is enabled if bit PULL_UP_EN = 1 in reg 1Ah.
4	INT1	Programmable interrupt 1	Programmable interrupt 1	Default: Output forced to ground	Default: Output forced to ground
5	Vdd_IO	Power supply for I/O pins	Power supply for I/O pins		
6	GND	0 V supply	0 V supply		
7	GND	0 V supply	0 V supply		
8	Vdd	Power supply	Power supply		
9	INT2	Programmable interrupt 2 (INT2) / Data enabled (DEN)	Programmable interrupt 2 (INT2) / Data enabled (DEN) / I ² C master external synchronization signal (MDRDY)	Default: Output forced to ground	Default: Output forced to ground
10	NC	Leave unconnected ⁽¹⁾	Leave unconnected ⁽¹⁾	Default: Input with pull-up. (See note below to disable pull-up)	Default: Input with pull-up. (See note below to disable pull-up)
11	NC	Leave unconnected ⁽¹⁾	Leave unconnected ⁽¹⁾	Default: Input with pull-up. (See note below to disable pull-up)	Default: Input with pull-up. (See note below to disable pull-up)
12	cs	I ² C/SPI mode selection (1: SPI idle mode / I ² C communication enabled; 0: SPI communication mode / I ² C disabled)	I ² C/SPI mode selection (1: SPI idle mode / I ² C communication enabled; 0: SPI communication mode / I ² C disabled)	Default: Input with pull-up. Pull-up is disabled if bit I2C_disable = 1 in reg 13h.	Default: Input with pull-up. Pull-up is disabled if bit I2C_disable = 1 in reg 13h.
13	SCL	I ² C serial clock (SCL) / SPI serial port clock (SPC)	I ² C serial clock (SCL) / SPI serial port clock (SPC)	Input without pull-up	Input without pull-up
14	SDA	l ² C serial data (SDA) / SPI serial data input (SDI) / 3-wire interface serial data output (SDO)	I ² C serial data (SDA) / SPI serial data input (SDI) / 3-wire interface serial data output (SDO)	Input without pull-up	Input without pull-up

1. Leave pin electrically unconnected and soldered to PCB.

Internal pull-up value is from 30 k Ω to 50 k Ω , depending on VDDIO.

Note: Procedure to disable pull-up on pins 10-11

- 1. From primary I²C/SPI interface: write 80h in register at address 00h
- 2. From primary I²C/SPI interface: write 01h in register at address 05h (disable the pull-up on pins 10 & 11)
- 3. From primary I²C/SPI interface: write 00h in register at address 00h

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Registers 2



Table 2. Registers

Register name	Address	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
FUNC_CFG_ACCESS	01h	FUNC_CFG _EN	0	FUNC_CFG _EN_B	0	0	0	0	0
SENSOR_SYNC_ TIME_FRAME	04h	0	0	0	0	TPH_3	TPH_2	TPH_1	TPH_0
SENSOR_SYNC_ RES_RATIO	05h	0	0	0	0	0	0	RR_1	RR_0
FIFO_CTRL1	06h	FTH_7	FTH_6	FTH_5	FTH_4	FTH_3	FTH_2	FTH_1	FTH_0
FIFO_CTRL2	07h	TIMER_PEDO_FIF O_EN	TIMER_PEDO_FIF O_DRDY	0	0	FIFO_TEMP_EN	FTH_10	FTH_9	FTH_8
FIFO_CTRL3	08h	0	0	DEC_FIFO _GYRO2	DEC_FIFO _GYRO1	DEC_FIFO _GYRO0	DEC_FIFO _XL2	DEC_FIFO _XL1	DEC_FIFO_XL0
FIFO_CTRL4	09h	STOP_ON _FTH	ONLY_HIGH _DATA	DEC_DS4 _FIFO2	DEC_DS4 _FIFO1	DEC_DS4_FIFO0	DEC_DS3_FIFO2	DEC_DS3_FIFO1	DEC_DS3_FIFO0
FIFO_CTRL5	0Ah	0	ODR_FIFO	ODR_FIFO	ODR_FIFO	ODR_FIFO	FIFO_MODE	FIFO_MODE	FIFO_MODE
TII O_CTIVES	VAII	J G	_3	_2	_1	_0	_2	_1	_0
DRDY_PULSE_CFG	0Bh	DRDY _PULSED	0	0	0	0	0	0	INT2_WRIST _TILT
INT1_CTRL	0Dh	INT1_STEP _DETECTOR	INT1_SIGN _MOT	INT1_FULL _FLAG	INT1_FIFO _OVR	INT1_FTH	INT1_BOOT	INT1_DRDY_G	INT1_DRDY _XL
INT2_CTRL	0Eh	INT2_STEP _DELTA	INT2_STEP _COUNT_OV	INT2_FULL _FLAG	INT2_FIFO _OVR	INT2_FTH	INT2_DRDY _TEMP	INT2_DRDY _G	INT2_DRDY _XL
WHO_AM_I	0Fh	0	1	1	0	1	0	1	0
CTRL1_XL	10h	ODR_XL3	ODR_XL2	ODR_XL1	ODR_XL0	FS_XL1	FS_XL0	LPF1_BW _SEL	BW0_XL
CTRL2_G	11h	ODR_G3	ODR_G2	ODR_G1	ODR_G0	FS_G1	FS_G0	FS_125	0
CTRL3_C	12h	воот	BDU	H_LACTIVE	PP_OD	SIM	IF_INC	BLE	SW_RESET
CTRL4_C	13h	DEN_XL_EN	SLEEP	INT2_on _INT1	DEN_DRDY_INT1	DRDY_MASK	I2C_disable	LPF1_SEL _G	0
CTRL5_C	14h	ROUNDING2	ROUNDING1	ROUNDING0	DEN_LH	ST1_G	ST0_G	ST1_XL	ST0_XL
CTRL6_C	15h	TRIG_EN	LVL1_EN	LVL2_EN	XL_HM _MODE	USR_OFF_W	0	FTYPE_1	FTYPE_0
CTRL7_G	16h	G_HM_MODE	HP_G_EN	HPM1_G	HPM0_G	0	ROUNDING _STATUS	0	0

SENSORHUB11_REG

38h

SHub11 7

SHub11 6

SHub11 5

SHub11 4

SHub11 3

SHub11 2

SHub11 1

SHub11 0

4

AN5130 Registers

Register name	Address	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
SENSORHUB12_REG	39h	SHub12_7	SHub12_6	SHub12_5	SHub12_4	SHub12_3	SHub12_2	SHub12_1	SHub12_0
FIEO CTATUCA	246	DIFF_FIFO	DIFF_FIFO	DIFF_FIFO	DIFF_FIFO	DIFF_FIFO	DIFF_FIFO	DIFF_FIFO	DIFF_FIFO
FIFO_STATUS1	3Ah	_7	_6	_5	_4	_3	_2	_1	_0
FIFO STATUS2	3Bh	WaterM	OVER RUN	FIFO_FULL	FIFO EMPTY	0	DIFF_FIFO	DIFF_FIFO	DIFF_FIFO
111 O_31A1032	JDII	vvaterivi	OVER_ROW	_SMART	THO_EWITT	U	_10	_9	_8
FIFO_STATUS3	3Ch	FIFO_PATTERN_7	FIFO_PATTERN_6	FIFO_PATTERN_5	FIFO_PATTERN_4	FIFO_PATTERN_3	FIFO_PATTERN_2	FIFO_PATTERN_1	FIFO_PATTERN_0
FIFO_STATUS4	3Dh	0	0	0	0	0	0	FIFO_PATTERN_9	FIFO_PATTERN_8
FIFO_DATA_OUT_L	3Eh	DATA_OUT _FIFO_L_7	DATA_OUT _FIFO_L_6	DATA_OUT _FIFO_L_5	DATA_OUT _FIFO_L_4	DATA_OUT _FIFO_L_3	DATA_OUT _FIFO_L_2	DATA_OUT _FIFO_L_1	DATA_OUT _FIFO_L_0
FIFO_DATA_OUT_H	3Fh	DATA_OUT _FIFO_H_7	DATA_OUT _FIFO_H_6	DATA_OUT _FIFO_H_5	DATA_OUT _FIFO_H_4	DATA_OUT _FIFO_H_3	DATA_OUT _FIFO_H_2	DATA_OUT _FIFO_H_1	DATA_OUT _FIFO_H_0
TIMESTAMP0 REG	40h	TIMESTAMP	TIMESTAMP	TIMESTAMP	TIMESTAMP	TIMESTAMP	TIMESTAMP	TIMESTAMP	TIMESTAMP
TIMESTAMPO_REG	4011	0_7	0_6	0_5	0_4	0_3	0_2	0_1	0_0
TIMESTAMP1 REG	41h	TIMESTAMP	TIMESTAMP	TIMESTAMP	TIMESTAMP	TIMESTAMP	TIMESTAMP	TIMESTAMP	TIMESTAMP
TIMESTAMI I_ILEG	4111	1_7	1_6	1_5	1_4	1_3	1_2	1_1	1_0
TIMESTAMP2 REG	42h	TIMESTAMP	TIMESTAMP	TIMESTAMP	TIMESTAMP	TIMESTAMP	TIMESTAMP	TIMESTAMP	TIMESTAMP
TIMEOTAMI 2_ILEO	7211	2_7	2_6	2_5	2_4	2_3	2_2	2_1	2_0
STEP_TIMESTAMP_L	49h	STEP_TIME	STEP_TIME	STEP_TIME	STEP_TIME	STEP_TIME	STEP_TIME	STEP_TIME	STEP_TIME
	1011	STAMP_L_7	STAMP_L_6	STAMP_L_5	STAMP_L_4	STAMP_L_3	STAMP_L_2	STAMP_L_1	STAMP_L_0
STEP TIMESTAMP H	4Ah	STEP_TIME	STEP_TIME	STEP_TIME	STEP_TIME	STEP_TIME	STEP_TIME	STEP_TIME	STEP_TIME
	,, ,,,	STAMP_H_7	STAMP_H_6	STAMP_H_5	STAMP_H_4	STAMP_H_3	STAMP_H_2	STAMP_H_1	STAMP_H_0
STEP COUNTER L	4Bh	STEP_	STEP_	STEP_	STEP_	STEP_	STEP_	STEP_	STEP_
	.5	COUNTER_L_7	COUNTER_L_6	COUNTER_L_5	COUNTER_L_4	COUNTER_L_3	COUNTER_L_2	COUNTER_L_1	COUNTER_L_0
STEP COUNTER H	4Ch	STEP_	STEP_	STEP_	STEP_	STEP_	STEP_	STEP_	STEP_
		COUNTER_H_7	COUNTER_H_6	COUNTER_H_5	COUNTER_H_4	COUNTER_H_3	COUNTER_H_2	COUNTER_H_1	COUNTER_H_0
SENSORHUB13_REG	4Dh	SHub13_7	SHub13_6	SHub13_5	SHub13_4	SHub13_3	SHub13_2	SHub13_1	SHub13_0
SENSORHUB14_REG	4Eh	SHub14_7	SHub14_6	SHub14_5	SHub14_4	SHub14_3	SHub14_2	SHub14_1	SHub14_0
SENSORHUB15_REG	4Fh	SHub15_7	SHub15_6	SHub15_5	SHub15_4	SHub15_3	SHub15_2	SHub15_1	SHub15_0
SENSORHUB16_REG	50h	SHub16_7	SHub16_6	SHub16_5	SHub16_4	SHub16_3	SHub16_2	SHub16_1	SHub16_0
SENSORHUB17_REG	51h	SHub17_7	SHub17_6	SHub17_5	SHub17_4	SHub17_3	SHub17_2	SHub17_1	SHub17_0
SENSORHUB18_REG	52h	SHub18_7	SHub18_6	SHub18_5	SHub18_4	SHub18_3	SHub18_2	SHub18_1	SHub18_0
FUNC_SRC1	53h	STEP_ COUNT _DELTA_IA	SIGN_MOTION_IA	TILT_IA	STEP_DETECTED	STEP_ OVERFLOW	HI_FAIL	SI_END_OP	SENSORHUB_ END_OP
FUNC SRC2	54h	0	SLAVE3	SLAVE2	SLAVE1	SLAVE0	0	0	WRIST_TILT
	J		_NACK	_NACK	_NACK	_NACK	•	Ů	_IA

Register name	Address	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
WRIST_TILT_IA	55h	WRIST_TILT _IA_Xpos	WRIST_TILT _IA_Xneg	WRIST_TILT _IA_Ypos	WRIST_TILT _IA_Yneg	WRIST_TILT _IA_Zpos	WRIST_TILT _IA_Zneg	0	0
TAP_CFG	58h	INTERRUPTS_ENA BLE	INACT_EN1	INACT_EN0	SLOPE _FDS	TAP_X_EN	TAP_Y_EN	TAP_Z_EN	LIR
TAP_THS_6D	59h	D4D_EN	SIXD_THS1	SIXD_THS0	TAP_THS4	TAP_THS3	TAP_THS2	TAP_THS1	TAP_THS0
INT_DUR2	5Ah	DUR3	DUR2	DUR1	DUR0	QUIET1	QUIET0	SHOCK1	SHOCK0
WAKE_UP_THS	5Bh	SINGLE_ DOUBLE_TAP	0	WK_THS5	WK_THS4	WK_THS3	WK_THS2	WK_THS1	WK_THS0
WAKE_UP_DUR	5Ch	FF_DUR5	WAKE _DUR1	WAKE _DUR0	TIMER_HR	SLEEP_DUR3	SLEEP_DUR2	SLEEP_DUR1	SLEEP _DUR0
FREE_FALL	5Dh	FF_DUR4	FF_DUR3	FF_DUR2	FF_DUR1	FF_DUR0	FF_THS2	FF_THS1	FF_THS0
MD1_CFG	5Eh	INT1_INACT _STATE	INT1_SINGLE_TAP	INT1_WU	INT1_FF	INT1_ DOUBLE_TAP	INT1_6D	INT1_TILT	INT1_TIMER
MD2_CFG	5Fh	INT2_INACT _STATE	INT2_SINGLE_TAP	INT2_WU	INT2_FF	INT2_ DOUBLE_TAP	INT2_6D	INT2_TILT	INT2_IRON
MACTER OND CODE	001-	MASTER_	MASTER_	MASTER_	MASTER_	MASTER_	MASTER_	MASTER_	MASTER_
MASTER_CMD_CODE	60h	CMD_CODE7	CMD_CODE6	CMD_CODE5	CMD_CODE4	CMD_CODE3	CMD_CODE2	CMD_CODE1	CMD_CODE0
SENS_SYNC_SPI_	61h	ERROR	ERROR	ERROR	ERROR	ERROR	ERROR	ERROR	ERROR
ERROR_CODE	OIII	_CODE7	_CODE6	_CODE5	_CODE4	_CODE3	_CODE2	_CODE1	_CODE0
OUT_MAG_RAW_X_L	66h	D7	D6	D5	D4	D3	D2	D1	D0
OUT_MAG_RAW_X_H	67h	D15	D14	D13	D12	D11	D10	D9	D8
OUT_MAG_RAW_Y_L	68h	D7	D6	D5	D4	D3	D2	D1	D0
OUT_MAG_RAW_Y_H	69h	D15	D14	D13	D12	D11	D10	D9	D8
OUT_MAG_RAW_Z_L	6Ah	D7	D6	D5	D4	D3	D2	D1	D0
OUT_MAG_RAW_Z_H	6Bh	D15	D14	D13	D12	D11	D10	D9	D8
X_OFS_USR	73h	X_OFS_USR_7	X_OFS_USR_6	X_OFS_USR_5	X_OFS_USR_4	X_OFS_USR_3	X_OFS_USR_2	X_OFS_USR_1	X_OFS_USR_0
Y_OFS_USR	74h	Y_OFS_USR_7	Y_OFS_USR_6	Y_OFS_USR_5	Y_OFS_USR_4	Y_OFS_USR_3	Y_OFS_USR_2	Y_OFS_USR_1	Y_OFS_USR_0
Z_OFS_USR	75h	Z_OFS_USR_7	Z_OFS_USR_6	Z_OFS_USR_5	Z_OFS_USR_4	Z_OFS_USR_3	Z_OFS_USR_2	Z_OFS_USR_1	Z_OFS_USR_0

2.1 Embedded functions registers

The list of the registers for embedded functions available in the device is given in Table 3. Embedded functions registers (bank A) and in Table 4. Embedded functions registers (bank B).

Embedded functions registers of the first (A) bank are accessible when the FUNC_CFG_EN bit is set to '1' and the FUNC_CFG_EN_B bit is set to '0' in the FUNC_CFG_ACCESS register.

Embedded functions register of the second (B) bank are accessible when both the FUNC_CFG_EN and the FUNC_CFG_EN_B bits are set to '1' in the FUNC_CFG_ACCESS register.

Note: All modifications to the content of the embedded functions registers have to be performed with both the accelerometer and the gyroscope sensor in Power-Down mode.

Table 3. Embedded functions registers (bank A)

Register name	Address	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
SLV0 ADD	02h	Slave0	Slave0	Slave0	Slave0	Slave0	Slave0	Slave0	nu 0
SLVU_ADD	UZII	_add6	_add5	_add4	_add3	_add2	_add1	_add0	rw_0
SLV0 SUBADD	03h	Slave0	Slave0	Slave0	Slave0	Slave0	Slave0	Slave0	Slave0
3LV0_30BADD	0311	_reg7	_reg6	_reg5	_reg4	_reg3	_reg2	_reg1	_reg0
SLAVE0 CONFIG	04h	Slave0	Slave0	Aux_sens	Aux_sens	Src mode	Slave0 numop2	Slave0 numop1	Slave0 numon0
	0411	_rate1	_rate0	_on1	_on0	Sic_illoue	_mode Slaveu _numop2 Slaveu _numop1	Slave0 _numop0	
SLV1 ADD	05h	Slave1	Slave1	Slave1	Slave1	Slave1	Slave1	Slave1	r 1
SLV I_ADD	uon	_add6	_add5	_add4	_add3	_add2	_add1	_add0	r_1
SLV1_SUBADD 0	06h	Slave1	Slave1	Slave1	Slave1	Slave1	Slave1	Slave1	Slave1
	OOH	_reg7	_reg6	_reg5	_reg4	_reg3	_reg2	_reg1	_reg0
01.11/54.001/510	07h	Slave1	Slave1	write_once	0	0	Slave1 numop2	Slave1 numop1	Slave1_numop0
SLAVE1_CONFIG	Oni	_rate1	_rate0	write_orice		O	Slave i _liulliop2	Slave i _liulliop i	
SLV2 ADD	08h	Slave2	Slave2	Slave2	Slave2	Slave2	Slave2	Slave2	r_2
SLV2_ADD	USII	_add6	_add5	_add4	_add3	_add2	_add1	_add0	1_2
SLV2 SUBADD	09h	Slave2	Slave2	Slave2	Slave2	Slave2	Slave2	Slave2	Slave2
3LV2_30BADD	0911	_reg7	_reg6	_reg5	_reg4	_reg3	_reg2	_reg1	_reg0
SLAVE2 CONFIG	0Ah	Slave2	Slave2	0	0	0	Slave2 numop2	Slave2 numop1	Slave2 _numor
SLAVEZ_CONFIG	VAII	_rate1	_rate0	0	0	O	Slavez _Humopz	Slavez _numop1	Slavez _numor
SLV3 ADD	0Bh	Slave3	Slave3	Slave3	Slave3	Slave3	Slave3	Slave3	r 2
SLV3_ADD	VDII	_add6	_add5	_add4	_add3	_add2	_add1	_add0	r_3
SIVA SUBADD	0Ch	Slave3	Slave3	Slave3	Slave3	Slave3	Slave3	Slave3	Slave3
SLV3_SUBADD	UCII	_reg7	_reg6	_reg5	_reg4	_reg3	_reg2	_reg1	_reg0
SI AVE3 CONFIC	ODb	Slave3	Slave3	0	0	0	Clove2 nume=2	Clave2 nume=4	Clave? numer
SLAVE3_CONFIG	0Dh	_rate1	_rate0	0	0	0	Slave3 _numop2	Slave3 _numop1	Slave3 _numor

Register name	Address	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
DATAWRITE_SRC	0Eh	Slave_	Slave_	Slave_	Slave_	Slave_	Slave_	Slave_	Slave_
_MODE_SUB_SLV0	UEN	dataw7	dataw6	dataw5	dataw4	dataw3	dataw2	dataw1	dataw0
CONFIG_PEDO_THS_MIN	0Fh	PEDO_FS	0	0	ths_min_4	ths_min_3	ths_min_2	ths_min_1	ths_min_0
SM_THS	13h	SM_THS_7	SM_THS_6	SM_THS_5	SM_THS_4	SM_THS_3	SM_THS_2	SM_THS_1	SM_THS_0
DEDO DED DEO	4.45	DEB	DEB	DEB	DEB	DEB	DEB	DEB	DEB
PEDO_DEB_REG	14h	_TIME_4	_TIME_3	_TIME_2	_TIME_1	_TIME_0	_STEP_2	_STEP_1	_STEP_0
STEP_COUNT_	15h	SC_DELTA	SC_DELTA	SC_DELTA	SC_DELTA	SC_DELTA	SC_DELTA	SC_DELTA	SC_DELTA
DELTA	1311	_7	_6	_5	_4	_3	_2	_1	_0
MAG_SI_XX	24h	MAG_SI_XX_7	MAG_SI_XX_6	MAG_SI_XX_5	MAG_SI _XX_4	MAG_SI _XX_3	MAG_SI _XX_2	MAG_SI _XX_1	MAG_SI_XX_0
MAG_SI_XY	25h	MAG_SI_XY_7	MAG_SI_XY_6	MAG_SI_XY_5	MAG_SI_XY_4	MAG_SI_XY_3	MAG_SI _XY_2	MAG_SI_XY_1	MAG_SI_XY_0
MAG_SI_XZ	26h	MAG_SI_XZ_7	MAG_SI_XZ_6	MAG_SI_XZ_5	MAG_SI _XZ_4	MAG_SI_XZ_3	MAG_SI_XZ_2	MAG_SI _XZ_1	MAG_SI_XZ_0
MAG_SI_YX	27h	MAG_SI_YX_7	MAG_SI_YX_6	MAG_SI_YX_5	MAG_SI_YX_4	MAG_SI _YX_3	MAG_SI _YX_2	MAG_SI_YX_1	MAG_SI_YX_0
MAG_SI_YY	28h	MAG_SI _YY_7	MAG_SI_YY_6	MAG_SI_YY_5	MAG_SI_YY_4	MAG_SI _YY_3	MAG_SI _YY_2	MAG_SI_YY_1	MAG_SI_YY_0
MAG_SI_YZ	29h	MAG_SI_YZ_7	MAG_SI _YZ_6	MAG_SI _YZ_5	MAG_SI_YZ_4	MAG_SI_YZ_3	MAG_SI_YZ_2	MAG_SI _YZ_1	MAG_SI _YZ_0
MAG_SI_ZX	2Ah	MAG_SI_ZX_7	MAG_SI_ZX_6	MAG_SI _ZX_5	MAG_SI _ZX_4	MAG_SI _ZX_3	MAG_SI _ZX_2	MAG_SI _ZX_1	MAG_SI _ZX_0
MAG_SI_ZY	2Bh	MAG_SI_ZY_7	MAG_SI_ZY_6	MAG_SI _ZY_5	MAG_SI_ZY_4	MAG_SI_ZY_3	MAG_SI_ZY_2	MAG_SI _ZY_1	MAG_SI_ZY_0
MAG_SI_ZZ	2Ch	MAG_SI _ZZ_7	MAG_SI_ZZ_6	MAG_SI_ZZ_5	MAG_SI_ZZ_4	MAG_SI _ZZ_3	MAG_SI _ZZ_2	MAG_SI_ZZ_1	MAG_SI_ZZ_0
MAG_OFFX_L	2Dh	MAG_OFFX_L_7	MAG_OFFX_L_6	MAG_OFFX_L_5	MAG_OFFX_L_4	MAG_OFFX _L_3	MAG_OFFX _L_2	MAG_OFFX_L_1	MAG_OFFX_L_0
MAG_OFFX_H	2Eh	MAG_OFFX_H_7	MAG_OFFX_H_6	MAG_OFFX_H_5	MAG_OFFX _H_4	MAG_OFFX _H_3	MAG_OFFX_H_2	MAG_OFFX_H_1	MAG_OFFX_H_0
MAG_OFFY_L	2Fh	MAG_OFFY_L_7	MAG_OFFY_L_6	MAG_OFFY_L_5	MAG_OFFY_L_4	MAG_OFFY _L_3	MAG_OFFY _L_2	MAG_OFFY_L_1	MAG_OFFY_L_0
MAG_OFFY_H	30h	MAG_OFFY_H_7	MAG_OFFY_H_6	MAG_OFFY_H_5	MAG_OFFY _H_4	MAG_OFFY_H_3	MAG_OFFY_H_2	MAG_OFFY_H_1	MAG_OFFY_H_0
MAG_OFFZ_L	31h	MAG_OFFZ_L_7	MAG_OFFZ_L_6	MAG_OFFZ_L_5	MAG_OFFZ_L_4	MAG_OFFZ_L_3	MAG_OFFZ_L_2	MAG_OFFZ_L_1	MAG_OFFZ_L_0
MAG_OFFZ_H	32h	MAG_OFFZ_H_7	MAG_OFFZ_H_6	MAG_OFFZ_H_5	MAG_OFFZ_H_4	MAG_OFFZ_H_3	MAG_OFFZ _H_2	MAG_OFFZ_H_1	MAG_OFFZ_H_0

Table 4. Embedded functions registers (bank B)

Register name	Address	Bit7	Bit6	Bit5	Bit4	Bit3	Bit2	Bit1	Bit0
A MODEL THE LAT	EOb	WRIST_TILT							
A_WRIST_TILT_LAT	50h	_TIMER7	_TIMER6	_TIMER5	_TIMER4	_TIMER3	_TIMER2	_TIMER1	_TIMER0
A MODEL THE THE	54h	WRIST_TILT							
A_WRIST_TILT_THS		_THS7	_THS6	_THS5	_THS4	_THS3	_THS2	_THS1	_THS0
A_WRIST_TILT_Mask	59h	WRIST_TILT	WRIST_TILT	WRIST_TILT	WRIST_TILT	WRIST_TILT	WRIST_TILT	0	0
		_MASK_Xpos	_MASK_Xneg	_MASK_Ypos	_MASK_Yneg	_MASK_Zpos	_MASK_Zneg	U	0



3 Operating modes

The LSM6DS3TR-C provides three possible operating configurations:

- only accelerometer active and gyroscope in Power-Down;
- only gyroscope active and accelerometer in Power-Down;
- both accelerometer and gyroscope active with independent ODR.

The device offers a wide VDD voltage range from 1.71 V to 3.6 V and a VDDIO range from 1.62 V to 3.6 V. In order to avoid potential conflicts, during the power-on sequence it is recommended to set the lines connected to the the device IO pins to high-impedance state on the host side. Furthermore, to guarantee proper power-off of the device it is recommended to maintain the duration of the VDD line to GND for at least $100 \, \mu s$.

After the power supply is applied, the LSM6DS3TR-C performs a 15 ms boot procedure to load the trimming parameters. After the boot is completed, both the accelerometer and the gyroscope are automatically configured in Power-Down mode.

The accelerometer and the gyroscope can be independently configured in four different power modes: Power-Down, Low-Power, Normal and High-Performance mode. They are allowed to have different data rates without any limit. The gyroscope sensor can also be set in Sleep mode to reduce its power consumption.

When both the accelerometer and gyroscope are on, the accelerometer is synchronized with the gyroscope, and the data rates of the two sensors are integer multiples of each other.

Referring to the LSM6DS3TR-C datasheet, the output data rate (ODR_XL) bits of the CTRL1_XL register and the High-Performance disable (XL_HM_MODE) bit of the CTRL6_C register are used to select the power mode and the output data rate of the accelerometer (Table 5. Accelerometer ODR and power mode selection).

ODR_XL [3:0]	ODR [Hz] when	ODR [Hz] when
	XL_HM_MODE = 1	XL_HM_MODE = 0
0000	Power Down	Power Down
1011	1.6 Hz (Low Power only)	12.5 Hz (High Performance)
0001	12.5 Hz (Low Power)	12.5 Hz (High Performance)
0010	26 Hz (Low Power)	26 Hz (High Performance)
0011	52 Hz (Low Power)	52 Hz (High Performance)
0100	104 Hz (Normal mode)	104 Hz (High Performance)
0101	208 Hz (Normal mode)	208 Hz (High Performance)
0110	416 Hz (High Performance)	416 Hz (High Performance)
0111	833 Hz (High Performance)	833 Hz (High Performance)
1000	1.66 kHz (High Performance)	1.66 kHz (High Performance)
1001	3.33 kHz (High Performance)	3.33 kHz (High Performance)
1010	6.66 kHz (High Performance)	6.66 kHz (High Performance)

Table 5. Accelerometer ODR and power mode selection

The output data rate (ODR_G) bits of the CTRL2_G register and the High-Performance disable (G_HM_MODE) bit of the CTRL7_G register are used to select the power mode and output data rate of the gyroscope sensor (Table 6. Gyroscope ODR and power mode selection).

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Table 6. Gyroscope ODR and power mode selection

ODR_G [3:0]	ODR [Hz] when	ODR [Hz] when
	G_HM_MODE = 1	G_HM_MODE = 0
0000	Power Down	Power Down
0001	12.5 Hz (Low Power)	12.5 Hz (High Performance)
0010	26 Hz (Low Power)	26 Hz (High Performance)
0011	52 Hz (Low Power)	52 Hz (High Performance)
0100	104 Hz (Normal mode)	104 Hz (High Performance)
0101	208 Hz (Normal mode)	208 Hz (High Performance)
0110	416 Hz (High Performance)	416 Hz (High Performance)
0111	833 Hz (High Performance)	833 Hz (High Performance)
1000	1.66 kHz (High Performance)	1.66 kHz (High Performance)
1001	3.33 kHz (High Performance)	3.33 kHz (High Performance)
1010	6.66 kHz (High Performance)	6.66 kHz (High Performance)

Table 7. Power consumption shows the typical values of power consumption for the different operating modes.

Table 7. Power consumption

ODR [Hz]	Accelerometer only	Gyroscope only	Combo [Acc + Gyro]
	(at Vdd = 1.8 V)	(at Vdd = 1.8 V)	(at Vdd = 1.8 V)
Power Down	-	-	3 μΑ
1.6 Hz (Low Power)	4.5 μΑ	-	-
12.5 Hz (Low Power)	9 μΑ	232 μΑ	240 μΑ
26 Hz (Low Power)	14 μΑ	245 μΑ	260 μΑ
52 Hz (Low Power)	25 μΑ	270 μΑ	290 μΑ
104 Hz (Normal mode)	44 μΑ	325 µA	360 μΑ
208 Hz (Normal mode)	85 μΑ	430 µA	450 µA
12.5 Hz (High Perf.)	150 µA	625 µA	900 μΑ
26 Hz (High Perf.)	150 µA	625 µA	900 μΑ
52 Hz (High Perf.)	150 µA	625 µA	900 μΑ
104 Hz (High Perf.)	150 µA	625 µA	900 μΑ
208 Hz (High Perf.)	150 µA	625 µA	900 μΑ
416 Hz (High Perf.)	150 µA	625 µA	900 μΑ
833 Hz (High Perf.)	150 µA	625 µA	900 μΑ
1.66 kHz (High Perf.)	160 μΑ	625 µA	900 μΑ
3.33 kHz (High Perf.)	160 μΑ	625 µA	900 μΑ
6.66 kHz (High Perf.)	160 μΑ	625 μΑ	900 μΑ

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3.1 Power-Down mode

When the accelerometer/gyroscope is in Power-Down mode, almost all internal blocks of the device are switched off to minimize power consumption. The digital interfaces (I²C and SPI) are still active to allow communication with the device. The content of the configuration registers is preserved and the output data registers are not updated, keeping the last data sampled in memory before going into Power-Down mode.

3.2 High-Performance mode

In High-Performance mode, all accelerometer/gyroscope circuitry is always on and data are generated at the data rate selected through the ODR_XL/ODR_G bits.

Data interrupt generation is active.

3.3 Normal mode

While High-Performance mode guarantees the best performance in terms of noise, Normal mode further reduces the current consumption. The accelerometer/gyroscope data reading chain is automatically turned on and off to save power. In the gyroscope device, only the driving circuitry is always on.

Data interrupt generation is active.

3.4 Low-Power mode

Low-Power mode differs from Normal mode in the available output data rates. In Low-Power mode low-speed ODRs are enabled. Four low-speed ODRs can be chosen for the accelerometer through the ODR_XL bits: 1.6 Hz, 12.5 Hz, 26 Hz and 52 Hz. Three low-speed ODRs can be chosen for the gyroscope thorough the ODR_G bits: 12.5 Hz, 26 Hz and 52 Hz.

Data interrupt generation is active.

3.5 Gyroscope Sleep mode

While the gyroscope is in Sleep mode the circuitry that drives the oscillation of the gyroscope mass is kept active. Compared to gyroscope Power-Down, turn-on time from Sleep mode to Low-Power/Normal/High-Performance mode is drastically reduced.

If the gyroscope is not configured in Power-Down mode, it enters in Sleep mode when the Sleep mode enable (SLEEP) bit of the CTRL4 C register is set to 1, regardless of the selected gyroscope ODR.

3.6 Connection modes

The LSM6DS3TR-C offers two different connection modes, described in detail in this document:

- Mode 1: it is the connection mode enabled by default; I²C slave interface or SPI (3- / 4-wire) serial interface
 is available. When the device is configured in connection Mode 1, the SCx/SDx pins cannot be left floating.
 It's recommended to connect both of them to VDDIO in order to optimize power consumption during the
 device start-up sequence.
- Mode 2: it is the sensor hub mode; I²C slave interface or SPI (3- / 4-wire) serial interface and I²C interface
 master for external sensor connections are available. This connection mode is described in Section 7 Mode
 2 Sensor hub mode.

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3.7 Accelerometer bandwidth

The accelerometer sampling chain is represented by a cascade of four main blocks: an analog anti-aliasing low-pass filter, an ADC converter, a digital low-pass filter and the composite group of digital filters.

As shown in Figure 2. Accelerometer filtering chain, the analog signal coming from the mechanical parts is filtered by an analog low-pass anti-aliasing filter before being converted by the ADC. The anti-aliasing filter is enabled in High-Performance mode only and its bandwidth depends on the selected accelerometer ODR as shown in the following table.

Accelerometer ODR [Hz]	Analog filter BW [Hz]
≥ 1666	1500
< 1666	400

Table 8. Accelerometer analog filter bandwidth

The analog filter bandwidth can be set to 400 Hz also for accelerometer ODR ≥ 1666 Hz by setting the BW0_XL bit to 1 in the CTRL1 XL register.

The digital LPF1 filter provides two outputs having different cutoff frequencies from each other; the desired LPF1 output can be selected through the LPF1_BW_SEL bit in the CTRL1_XL register and the INPUT_COMPOSITE bit in the CTRL8_XL register.

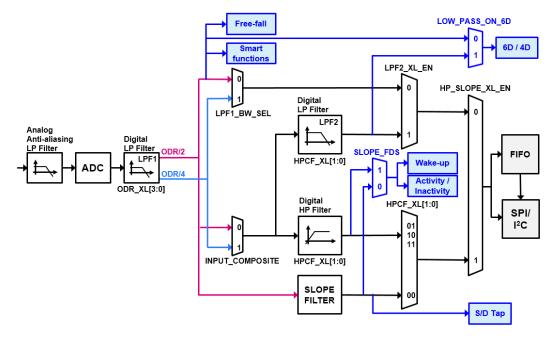


Figure 2. Accelerometer filtering chain

Referring to Figure 2. Accelerometer filtering chain, the cutoff frequency of the "ODR/2" output of the LPF1 filter is equal to ODR/2 in High-Performance mode and it is equal to 740 Hz in Low Power / Normal modes. The cutoff frequency of the "ODR/4" output is always equal to ODR/4, regardless of the selected power mode. The smart functions block in these figures refer to pedometer, step detector and step counter, significant motion and tilt functions described in Section 6 Embedded functions .

Finally, the composite group of filters composed of a low-pass digital filter (LPF2), a high-pass digital filter and a slope filter processes the digital signal.

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The CTRL8_XL register can be used to configure the composite filter group and the overall bandwidth of the accelerometer filtering chain, as shown in Table 9. Accelerometer bandwidth selection. Referring to this table, on the low-pass path side, the Bandwidth column refers to the LPF1 bandwidth if LPF2_XL_EN = 0; it refers to the LPF2 bandwidth if LPF2_XL_EN = 1. On the high-pass path side, the Bandwidth column refers to the Slope filter bandwidth if HPCF XL[1:0] = 00b; it refers to the HP filter bandwidth if HPCF XL[1:0] = 01b / 10b / 11b.

Table 9. Accelerometer bandwidth selection also provides the maximum (worst case) settling time in terms of samples to be discarded for the various configurations of the accelerometer filtering chain. Further details are described in Section 3.9 Accelerometer and gyroscope turn-on/off time.

HP_SLOPE_XL_EN	LPF2_XL_EN	LPF1_BW_SEL	HPCF_XL[1:0]	INPUT_COMPOSITE	Bandwidth	Max. overall settling time ⁽¹⁾ (samples to be discarded)
	0	-	-	ODR/2	14	
	0	1	-	-	ODR/4	14
0			00		ODR/50	40
(Low-Pass path) 1		1 -	01	1 (low noise) 0 (low latency)	ODR/100	80
	1		10		ODR/9	15
		11		ODR/400	320	
			00		ODR/4	14
1 - (High-Pass path)		-	01		ODR/100	80
		-	10	0	ODR/9	15
			11		ODR/400	320

Table 9. Accelerometer bandwidth selection

1. Settling time @ 99% of the final value

Setting the HP_SLOPE_XL_EN bit to 0, the low-pass path of the composite filter block is selected. If the LPF2_XL_EN bit is set to 0, no additional filter is applied; if the LPF2_XL_EN bit is set to 1, the LPF2 filter is applied in addition to LPF1 and the overall bandwidth of the accelerometer chain can be set by configuring the HPCF_XL[1:0] field of the CTRL8_XL register.

The LPF2 low-pass filter can also be used in the 6D/4D functionality by setting the LOW_PASS_ON_6D bit of the CTRL8 XL register to 1.

Setting the HP_SLOPE_XL_EN bit to 1, the high-pass path of the composite filter block is selected: the HPCF_XL[1:0] field is used in order to enable, in addition to the LPF1 filter, either the Slope filter usage (when HPCF_XL[1:0] = 00b) or the digital high-pass filter (other HPCF_XL[1:0] configurations). The HPCF_XL[1:0] field is also used to select the cutoff frequencies of the HP filter.

The reference mode feature is available for the accelerometer sensor: when this feature is enabled, the current X, Y, Z accelerometer sample is internally stored and subtracted from all subsequent output values. In order to enable the reference mode, both the HP_REF_MODE bit and the HP_SLOPE_XL_EN bit of the CTRL8_XL register have to be set to 1, and the value of the HPCF_XL[1:0] field has to be different than 00b. When the reference mode feature is enabled, both the LPF2 filter and the HP filter are not available. The first accelerometer output data after enabling the reference mode has to be discarded.

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3.7.1 Accelerometer slope filter

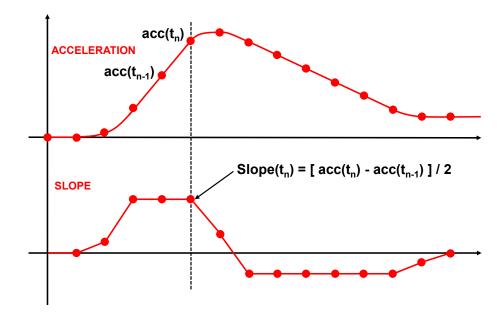
As shown in Figure 2. Accelerometer filtering chain, the LSM6DS3TR-C device embeds a digital Slope filter, which can also be used for some embedded features such as single/double-tap recognition, wake-up detection and activity/inactivity.

The slope filter output data is calculated using the following formula:

$$\mathsf{slope}(\mathsf{t}_\mathsf{n}) = [\mathsf{acc}(\mathsf{t}_\mathsf{n}) - \mathsf{acc}(\mathsf{t}_\mathsf{n-1})]/2$$

An example of a slope data signal is illustrated in Figure 3. Accelerometer slope filter.

Figure 3. Accelerometer slope filter



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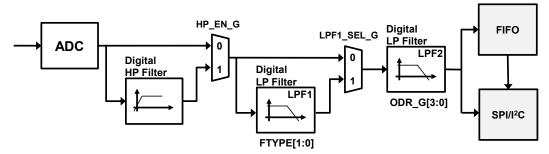


3.8 Gyroscope bandwidth

In the LSM6DS3TR-C device, the gyroscope filtering chain depends on the connection mode in use.

The gyroscope filtering chain configuration is shown in Figure 4. Gyroscope digital chain). It is a cascade of three filters: a selectable digital high-pass filter (HPF), a selectable digital low-pass filter (LPF1) and a digital low-pass filter (LPF2).

Figure 4. Gyroscope digital chain



The digital HP filter can be enabled by setting the HP_EN_G bit of the CTRL7_G register to 1. The digital HP filter cutoff frequency can be selected through the field HPM_G[1:0] of the CTRL7_G register, according to the table below.

Note: The embedded HP filter is available in High-Performance mode only. If the gyroscope is configured in Low-Power / Normal mode, the high-pass filter is bypassed regardless of the configuration of the HP_G_EN bit of CTRL7_G register.

HPM_G[1:0]	High-pass filter cutoff frequency [Hz]
00	0.016
01	0.065
10	0.260
11	1.040

Table 10. Gyroscope digital HP filter cutoff selection

The digital LPF1 filter can be enabled by setting the LPF1_SEL_G bit of CTRL4_C register to 1 and its bandwidth can be selected through the field FTYPE_[1:0] of the CTRL6_C register.

Note: The digital LPF1 filter is available in High-Performance mode only. If the gyroscope is configured in Low-Power / Normal mode, the LPF1 filter is bypassed regardless of the configuration of the LPF1_SEL_G bit of CTRL4 C register.

The digital LPF2 filter cannot be configured by the user (regardless of the selected power mode) and its cutoff frequency depends on the selected gyroscope ODR. When the gyroscope ODR is equal to 6.66 kHz, the LPF2 filter is bypassed.

The overall gyroscope bandwidth for different configurations of the LPF1_SEL_G bit of the CTRL4_C register and FTYPE [1:0] of the CTRL6 C register is summarized in the following table.

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Table 11. Gyroscope overall bandwidth selection

Gyroscope ODR [Hz]	LPF1_SEL_G	FTYPE[1:0]	Cutoff [Hz] (Phase delay @ 20 Hz)
	0	-	4
	1	00	4
12.5	1	01	4
	1	10	4
	1	11	4
	0	-	8
	1	00	8
26	1	01	8
	1	10	8
	1	11	8
	0	-	17
	1	00	17 (144°)
52	1	01	17 (146°)
	1	10	17 (149°)
	1	11	17 (142°)
	0	-	33
	1	00	33 (75°)
104	1	01	33 (77°)
	1	10	33 (79°)
	1	11	33 (73°)
	0	-	67
	1	00	67 (40°)
208	1	01	67 (42°)
	1	10	67 (45°)
	1	11	67 (39°)
	0	-	137
	1	00	138 (23°)
416	1	01	131 (25°)
	1	10	121 (28°)
	1	11	138 (21°)
	0	-	312
	1	00	245 (14°)
833	1	01	195 (17°)
	1	10	155 (19°)
	1	11	293 (13°)
	0	-	988
	1	00	315 (10°)
1666	1	01	224 (12°)
	1	10	168 (15°)
	1	11	505 (8°)

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Gyroscope ODR [Hz]	LPF1_SEL_G	FTYPE[1:0]	Cutoff [Hz] (Phase delay @ 20 Hz)
	0	-	1161
	1	00	343 (8°)
3333	1	01	234 (10°)
	1	10	172 (12°)
	1	11	925 (6°)
6666	0	-	1250
	1	00	351 (7°)
	1	01	237 (9°)
	1	10	173 (11°)
	1	11	937 (5°)

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3.9 Accelerometer and gyroscope turn-on/off time

The accelerometer reading chain contains low-pass filtering to improve signal-to-noise performance and to reduce aliasing effects. For this reason, it is necessary to take into account the settling time of the filters when the accelerometer power mode is switched or when the accelerometer ODR is changed.

The maximum overall turn-on/off time (with LPF2 and HP filters disabled) in order to switch accelerometer power modes or accelerometer ODR is shown in Table 12. Accelerometer turn-on/off time (LPF2 and HP disabled)

Note: The accelerometer ODR timing is not impacted by power mode changes (a new configuration is effective after the completion of the current period).

Table 12. Accelerometer turn-on/off time (LPF2 and HP disabled)

Starting mode	Target mode	Max turn-on/off time ⁽¹⁾
Power-Down	Low-Power / Normal	See Table 13. Accelerometer samples to be discarded
Power-Down	High-Performance	See Table 13. Accelerometer samples to be discarded
Low-Power / Normal	High-Performance	See Table 13. Accelerometer samples to be discarded + discard 1 additional sample
Low-Power / Normal	Low-Power / Normal (ODR Change)	See Table 13. Accelerometer samples to be discarded
High-Performance	Low-Power / Normal	See Table 13. Accelerometer samples to be discarded + discard 1 additional sample
High-Performance	High-Performance	See Table 13. Accelerometer samples to be discarded + discard 1
@ ODR ≤ 833 Hz	@ ODR ≤ 833 Hz	additional sample
High-Performance	High-Performance	See Table 13. Accelerometer samples to be discarded + discard 1
@ ODR ≤ 833 Hz	@ ODR > 833 Hz	additional sample
High-Performance	High-Performance	See Table 13. Accelerometer samples to be discarded + discard 1
@ ODR > 833 Hz	@ ODR ≤ 833 Hz	additional sample
High-Performance	High-Performance	Discard 5 samples
@ ODR > 833 Hz	@ ODR > 833 Hz	
Low-Power / Normal / High- Performance	Power-Down	1 μs

^{1.} Settling time @ 99% of the final value

Table 13. Accelerometer samples to be discarded

Target mode Accelerometer ODR [Hz]	Number of sample to be discarded with (LPF1_BW_SEL = 0 and LPF2_XL_EN = 0 and HP_SLOPE_XL_EN = 0)	Number of sample to be discarded with (LPF1_BW_SEL = 1 and LPF2_XL_EN = 0 and HP_SLOPE_XL_EN = 0) OR (HPCF_XL = 00 and HP_SLOPE_XL_EN = 1)
1.6 (Low-Power)	0 (first sample correct)	1
12.5 (Low-Power)	0 (first sample correct)	1
26 (Low-Power)	0 (first sample correct)	1
52 (Low-Power)	0 (first sample correct)	1
104 (Normal)	0 (first sample correct)	1
208 (Normal)	0 (first sample correct)	1

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Target mode Accelerometer ODR [Hz]	Number of sample to be discarded with (LPF1_BW_SEL = 0 and LPF2_XL_EN = 0 and HP_SLOPE_XL_EN = 0)	Number of sample to be discarded with (LPF1_BW_SEL = 1 and LPF2_XL_EN = 0 and HP_SLOPE_XL_EN = 0) OR (HPCF_XL = 00 and HP_SLOPE_XL_EN = 1)
12.5 (High-Performance)	0 (first sample correct)	1
26 (High-Performance)	0 (first sample correct)	1
52 (High-Performance)	1	1
104 (High-Performance)	1	2
208 (High-Performance)	1	2
416 (High-Performance)	1	2
833 (High-Performance)	1	2
1666 (High-Performance)	2	2
3333 (High-Performance)	3	4
6666 (High-Performance)	13	13

Turn-on/off time has to be considered also for the gyroscope sensor when switching its modes or when the gyroscope ODR is changed.

The maximum overall turn-on/off time (with HP filter disabled) in order to switch gyroscope power modes or gyroscope ODR is shown in Table 14. Gyroscope turn-on/off time (HP disabled).

Note: The gyroscope ODR timing is not impacted by power mode changes (a new configuration is effective after the completion of the current period).

Table 14. Gyroscope turn-on/off time (HP disabled)

Starting mode	Target mode	Max turn-on/off time ⁽¹⁾
Power-Down	Sleep	70 ms
Power-Down	Low-Power / Normal	70 ms + discard 1 sample
Power-Down	High-Performance	70 ms + see Table 15. Gyroscope samples to be discarded (LPF1 disabled) or Table 16. Gyroscope samples to be discarded (LPF1 enabled) for all ODRs
Sleep	Low-Power / Normal	Discard 1 sample
Sleep	High-Performance	See Table 15. Gyroscope samples to be discarded (LPF1 disabled) or Table 16. Gyroscope samples to be discarded (LPF1 enabled) for all ODRs
Low-Power / Normal	High-Performance	Discard 2 samples
Low-Power / Normal	Low-Power / Normal (ODR change)	Discard 1 sample
High-Performance	Low-Power / Normal	Discard 1 sample
High-Performance	High-Performance (ODR change)	Discard 2 samples
Low-Power / Normal / High-	Power-Down	1 μs if both XL and Gyro in PD
Performance		300 μs if XL not in PD

1. Settling time @ 99% of the final value

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Table 15. Gyroscope samples to be discarded (LPF1 disabled)

Gyroscope ODR [Hz]	Number of samples to be discarded
12.5 Hz	2
26 Hz	3
52 Hz	3
104 Hz	3
208 Hz	3
416 Hz	3
833 Hz	3
1.66 kHz	135
3.33 kHz	270
6.66 kHz	540

Table 16. Gyroscope samples to be discarded (LPF1 enabled) for all ODRs

Gyroscope ODR [Hz]	FTYPE[1:0]	Number of samples to be discarded
	00	2
12.5 Hz	01	2
12.5 П2	10	2
	11	2
	00	3
26 Hz	01	3
20112	10	3
	11	3
	00	3
52 Hz	01	3
32112	10	3
	11	3
	00	4
104 Hz	01	4
104112	10	4
	11	4
	00	4
208 Hz	01	4
200112	10	5
	11	4
	00	5
416 Hz	01	6
710112	10	6
	11	5

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Gyroscope ODR [Hz]	FTYPE[1:0]	Number of samples to be discarded
	00	7
833 Hz	01	8
033 ∏Z	10	9
	11	6
	00	135
1.66 kHz	01	135
1.00 KHZ	10	135
	11	135
	00	270
3.33 kHz	01	270
3.33 KHZ	10	270
	11	270
	00	540
0.00 111-	01	540
6.66 kHz	10	540
	11	540

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4 Mode 1 - Reading output data

4.1 Startup sequence

Once the device is powered up, it automatically downloads the calibration coefficients from the embedded flash to the internal registers. When the boot procedure is completed, i.e. after approximately 15 milliseconds, the accelerometer and gyroscope automatically enter Power-Down mode.

To turn on the accelerometer and gather acceleration data, it is necessary to select one of the operating modes through the CTRL1 XL register.

The following general-purpose sequence can be used to configure the accelerometer:

```
    Write CTRL1_XL = 60h  // Acc = 416 Hz (High-Performance mode)
    Write INT1_CTRL = 01h  // Acc data-ready interrupt on INT1
```

To turn on the gyroscope and gather angular rate data, it is necessary to select one of the operating modes through CTRL2_G.

The following general-purpose sequence can be used to configure the gyroscope:

```
    Write CTRL2_G = 60h  // Gyro = 416 Hz (High-Performance mode)
    Write INT1_CTRL = 02h  // Gyro data-ready interrupt on INT1
```

4.2 Using the status register

The device is provided with a STATUS_REG register which should be polled to check when a new set of data is available. The XLDA bit is set to 1 when a new set of data is available at accelerometer output; the GDA bit is set to 1 when a new set of data is available at gyroscope output.

For the accelerometer (the gyroscope is similar), the read of the output registers should be performed as follows:

- 1. Read STATUS
- 2. If XLDA = 0, then go to 1
- 3. Read OUTX L XL
- 4. Read OUTX H XL
- 5. Read OUTY_L_XL
- 6. Read OUTY_H_XL
- 7. Read OUTZ_L_XL
- Read OUTZ_H_XL
 Data processing
- 10. Go to 1

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4.3 Using the data-ready signal

The device can be configured to have one HW signal to determine when a new set of measurement data is available to be read.

For the accelerometer sensor, the data-ready signal is represented by the XLDA bit of the STATUS_REG register. The signal can be driven to the INT1 pin by setting the INT1_DRDY_XL bit of the INT1_CTRL register to 1 and to the INT2 pin by setting the INT2_DRDY_XL bit of the INT2_CTRL register to 1.

For the gyroscope sensor, the data-ready signal is represented by the GDA bit of the STATUS_REG register. The signal can be driven to the INT1 pin by setting the INT1_DRDY_G bit of the INT1_CTRL register to 1 and to the INT2 pin by setting the INT2_DRDY_G bit of the INT2_CTRL register to 1.

The data-ready signal rises to 1 when a new set of data has been generated and it is available to be read. The data-ready signal can be either latched or pulsed: if the DRDY_PULSED bit of the DRDY_PULSE_CFG register is set to 0 (default value), then the data-ready signal is latched and the interrupt is reset when the higher part of one of the enabled channels is read (29h, 2Bh, 2Dh for the accelerometer; 23h, 25h, 27h for the gyroscope). If the DRDY_PULSED bit of the DRDY_PULSE_CFG register is set to 1, then the data-ready is pulsed and the duration of the pulse observed on the interrupt pins is 75 μ s. Pulsed mode is not applied to the XLDA and GDA bits which are always latched.

DATA
Sample #(N)
Sample #(N+1)

DRDY

DATA READ

Figure 5. Data-ready signal

4.3.1 DRDY mask functionality

Setting the DRDY_MASK bit of the CTRL4_C register to 1, the accelerometer and gyroscope data-ready signals are masked until the settling of the sensor filters is completed.

When FIFO is active and the DRDY_MASK bit is set to 1, accelerometer/gyroscope invalid samples stored in FIFO can be equal to 7FFFh, 7FFEh or 7FFDh. In this way, a tag is applied to the invalid samples stored in the FIFO buffer so that they can be easily identified and discarded during data post-processing.

Note: The DRDY_MASK bit acts only on the accelerometer LPF1 and the gyroscope LPF2 digital filters settling time.

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4.4 Using the block data update (BDU) feature

If reading the accelerometer/gyroscope data is particularly slow and cannot be synchronized (or it is not required) with either the XLDA/GDA bits in the STATUS_REG register or with the DRDY signal driven to the INT1/INT2 pins, it is strongly recommended to set the BDU (Block Data Update) bit to 1 in the CTRL3 C register.

This feature avoids reading values (most significant and least significant parts of output data) related to different samples. In particular, when the BDU is activated, the data registers related to each channel always contain the most recent output data produced by the device, but, in case the read of a given pair (i.e. OUTX_H_XL(G) and OUTX_L_XL(G), OUTY_H_XL(G) and OUTY_L_XL(G), OUTZ_H_XL(G) and OUTZ_L_XL(G)) is initiated, the refresh for that pair is blocked until both MSB and LSB parts of the data are read.

Note: BDU only guarantees that the LSB part and MSB part have been sampled at the same moment. For example, if the reading speed is too slow, X and Y can be read at T1 and Z sampled at T2.

4.5 Understanding output data

The measured acceleration data are sent to the OUTX_H_XL, OUTX_L_XL, OUTY_H_XL, OUTY_L_XL, OUTY_L_XL, OUTZ_H_XL, and OUTZ_L_XL registers. These registers contain, respectively, the most significant part and the least significant part of the acceleration signals acting on the X, Y, and Z axes.

The measured angular rate data are sent to the OUTX_H_G, OUTX_L_G, OUTY_H_G, OUTY_L_G, OUTZ_H_G, and OUTZ_L_G registers. These registers contain, respectively, the most significant part and the least significant part of the angular rate signals acting on the X, Y, and Z axes.

The complete output data for the X, Y, Z channels is given by the concatenation $OUTX_H_XL(G)$ & $OUTX_L_XL(G)$, $OUTY_H_XL(G)$ & $OUTY_L_XL(G)$, $OUTZ_H_XL(G)$ & $OUTZ_L_XL(G)$ and it is expressed as a two's complement number.

Both acceleration data and angular rate data are represented as 16-bit numbers.

4.5.1 Big-little endian selection

The LSM6DS3TR-C allows swapping the content of the lower and the upper part of the output data registers (i.e. OUTX_H_XL(G) with OUTX_L_XL(G), and OUT_TEMP_H with OUT_TEMP_L) in order to be compliant with both little-endian and big-endian data representations.

"Little Endian" means that the low-order byte of the number is stored in memory at the lowest address, and the high-order byte at the highest address. This mode corresponds to the BLE bit of the CTRL3_C register set to 0 (default configuration).

On the contrary, "Big Endian" means that the high-order byte of the number is stored in memory at the lowest address, and the low-order byte at the highest address. This mode corresponds to the BLE bit of the CTRL3_C register set to 1.

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4.5.2 Examples of output data

Table 17. Output data registers content vs. acceleration (FS_XL = ± 2 g) provides a few basic examples of the accelerometer data that is read in the data registers when the device is subject to a given acceleration. Table 18. Output data registers content vs. angular rate (FS_G = ± 250 dps) provides a few basic examples of the gyroscope data that is read in the data registers when the device is subject to a given angular rate.

The values listed in the following tables are given under the hypothesis of perfect device calibration (i.e. no offset, no gain error,....) and practically show the effect of the BLE bit.

Table 17. Output data registers content vs. acceleration (FS_XL = $\pm 2 g$)

	BLE	: = 0	BLE = 1					
Acceleration values	Register address							
	OUTX_H_XL (29h)	OUTX_L_XL (28h)	OUTX_H_XL (29h)	OUTX_L_XL (28h)				
0 g	00h	00h	00h	00h				
350 mg	16h	69h	69h	16h				
1 g	40h	09h	09h	40h				
-350 mg	E9h	97h	97h	E9h				
-1 g	BFh	F7h	F7h	BFh				

Table 18. Output data registers content vs. angular rate (FS_G = ±250 dps)

	BLE	: = 0	BLE = 1				
Angular rate values	es Register address						
	OUTX_H_G (23h)	OUTX_L_G (22h)	OUTX_H_G (23h)	OUTX_L_G (22h)			
0 dps	00h	00h	00h	00h			
100 dps	2Ch	A4h	A4h	2Ch			
200 dps	59h	49h	49h	59h			
-100 dps	D3h	5Ch	5Ch	D3h			
-200 dps	A6h	B7h	B7h	A6h			

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4.6 Accelerometer offset registers

The LSM6DS3TR-C provides the accelerometer offset registers (X_OFS_USR, Y_OFS_USR, Z_OFS_USR) which can be used for zero-g offset correction or, in general, to apply an offset to the accelerometer output data.

The offset value set in the offset registers is internally subtracted from the measured acceleration value for the Z-axis, and it is internally added to the measured acceleration value for the X and Y axes; internally processed data are then sent to the accelerometer output register and to the FIFO (if enabled). These registers values are expressed as an 8-bit word in two's complement and must be in the range [-127, 127].

The weight [g/LSB] to be applied to the offset register values is independent of the accelerometer selected full-scale and can be configured using the USR_OFF_W bit of the CTRL6_C register:

- 2⁻¹⁰ g/LSB if the USR OFF W bit is set to 0;
- 2⁻⁶ g/LSB if the USR OFF W bit is set to 1.

4.7 Rounding functions

The rounding function can be used to auto address the LSM6DS3TR-C registers for a circular burst-mode read. Basically, with a multiple read operation the address of the register that is being read goes automatically from the first register to the last register of the pattern and then goes back to the first one.

4.7.1 Rounding of FIFO output registers

The rounding function is automatically enabled when performing a multiple read operation of the FIFO output registers FIFO DATA OUT L (3Eh) and FIFO DATA OUT H (3Fh).

4.7.2 Rounding of source registers

It is possible to apply the rounding function also to the source registers of the LSM6DS3TR-C device, in order to verify with one multiple read whether new data was generated or a new interrupt event was detected.

The rounding function on the source registers can be enabled by setting the ROUNDING_STATUS bit of the CTRL7_G register to 1. When this function is enabled, with a multiple read operation the address of the register that is being read cycles automatically on WAKE_UP_SRC(1Bh), TAP_SRC(1Ch), D6D_SRC(1Dh), STATUS_REG (1Eh) and FUNC_SRC1 (53h) and goes back to WAKE_UP_SRC (1Bh).

4.7.3 Rounding of sensor output registers

The rounding function can also be enabled for the following groups of output registers:

- Gyroscope output registers, from OUTX_L_G (22h) to OUTZ_H_G (27h);
- Accelerometer output registers, from OUTX_L_XL (28h) to OUTZ_H_XL (2Dh);
- First group of sensor hub output registers, from SENSORHUB1 REG (2Eh) to SENSORHUB6 REG (33h);
- Second group of sensor hub output registers, from SENSORHUB7_REG (34h) to SENSORHUB12_REG (39h)

The output registers rounding pattern can be configured using the bits ROUNDING[2:0] of the CTRL5_C register, as indicated in Table 19. Output registers rounding pattern.

Table 19. Output registers rounding pattern

ROUNDING[2:0]	Rounding pattern
000	No rounding
001	Accelerometer only
010	Gyroscope only
011	Gyroscope + Accelerometer
100	1st group of Sensor Hub only
101	Accelerometer + 1st group of Sensor Hub

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	ROUNDING[2:0]	Rounding pattern					
	110	Gyroscope + Accelerometer +					
		1st group of Sensor Hub + 2nd group of Sensor Hub					
ľ	111	Gyroscope + Accelerometer + 1st group of Sensor Hub					

4.8 Edge-sensitive and level-sensitive data enable (DEN)

The LSM6DS3TR-C allows an external trigger level recognition through enabling the TRIG_EN, LVL1_EN, LVL2_EN bits in CTRL6_C.

Four different modes can be selected (Table 20. DEN configurations):

- Edge-sensitive trigger mode
- Level-sensitive trigger mode
- Level-sensitive latched mode
- Level-sensitive FIFO enable mode

The Data Enable (DEN) input signal is driven on the INT2 pin, which is configured as an input pin when one of the trigger modes is enabled.

The DEN functionality is active by default on the gyroscope data only. To extend this feature to the accelerometer data, the bit DEN_XL_EN in CTRL4_C must be set to 1.

The DEN active level is low by default. It can be changed to active-high by setting the bit DEN LH in CTRL5 C to 1.

Table 20. DEN configurations

TRIG_EN	LVL1_EN	LVL2_EN	Function
1	0	0	Edge-sensitive trigger mode
0	1	0	Level-sensitive trigger mode
0	1	1	Level-sensitive latched mode
1	1	n	Level-sensitive FIFO enable mode

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4.8.1 Edge-sensitive trigger mode

Edge-sensitive trigger mode can be enabled by setting the TRIG_EN bit in CTRL6_C to 1, and LVL1_EN, LVL2_EN bits in CTRL6_C to 0.

The edge-sensitive trigger works only when the low-pass filter LPF2 is disabled (LPF2_XL_EN = 0 in CTRL8_XL register).

Once the edge-sensitive trigger mode is enabled, the FIFO buffer and output registers are filled with the first sample acquired after every rising edge (if DEN_LH bit is equal to 1) or falling edge (if DEN_LH bit is equal to 0) of the DEN input signal.

Figure 6. Edge-sensitive trigger mode, DEN active low shows, with red circles, the samples acquired after the falling edges (DEN active low).

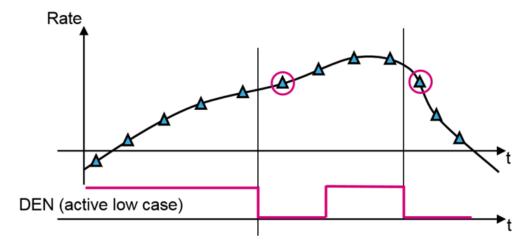


Figure 6. Edge-sensitive trigger mode, DEN active low

Edge-sensitive trigger mode, when enabled, acts only on the gyroscope output registers. The DRDY_G is related only to downsampled data, while the accelerometer output registers and DRDY_XL are updated according to ODR_XL. If the DEN_XL_EN bit is set to 1, the accelerometer sensor is downsampled too. In this case, the gyroscope and accelerometer have to be set in combo mode at the same ODR. The accelerometer standalone mode could be used by setting the gyroscope in Power-Down. In this case, DRDY_XL relates to downsampled data only.

Please note that the DEN trigger is internally latched before the update of the data registers: if a trigger occurs after this event, DEN will be acknowledged in the next ODR.

There are three possible configurations for the edge-sensitive trigger in FIFO, described below:

- Only gyroscope in trigger mode but not saved in FIFO: in this case, FIFO is related only to the
 accelerometer and works as usual.
- 2. Only gyroscope in trigger mode and saved in FIFO: in this case the gyroscope decimation bits DEC_FIFO_GYRO [2:0] of the FIFO_CTRL3 register have to be set to 001 (gyroscope sensor in FIFO without decimation). Doing this, FIFO is driven by an external trigger. With this configuration, since also accelerometer data is written when the trigger occurs, possible repetition or loss of data for the accelerometer may occur.
- Gyroscope and accelerometer in trigger mode and saved in FIFO: this configuration can be used by setting DEN_XL_EN to 1 and the gyroscope and accelerometer decimation bits DEC_FIFO_GYRO [2:0] and DEC_FIFO_XL [2:0] of the FIFO_CTRL3 register to 001 (gyroscope and accelerometers in FIFO without decimation). In this case, data of both sensors are written in FIFO when trigger occurs.

Edge-sensitive trigger mode allows, for example, the synchronization of the camera frames with the samples coming from the gyroscope for Electrical Image Stabilization (EIS) applications. The synchronization signal from the camera module must be connected to the INT2 pin.

In the example shown below, the FIFO has been configured to store both the gyroscope data and the accelerometer data in the FIFO buffer; when the DEN signal toggles, the data are written to FIFO on the rising edge.

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```
    Write 09h to FIFO_CTRL3  // Enable gyroscope and accelerometer in FIFO (no decimation)
    Write 26h to FIFO_CTRL5  // Set FIFO in Continuous mode, FIFO ODR = 104 Hz
    Write 80h to CTRL6_C  // Enable the edge-sensitive trigger  // INT2 pin is switched to input mode (DEN signal)
    Write 80h to CTRL4_C  // Extend DEN functionality to accelerometer sensor
    Write 40h to CTRL1_XL  // Turn on the accelerometer: ODR_XL = 104 Hz, FS_XL = ±2 g
    Write 4Ch to CTRL2_G  // Turn on the gyroscope
    ODR_G = 104 Hz, FS_G = ±2000 dps
```

4.8.2 Level-sensitive trigger mode

Level-sensitive trigger mode can be enabled by setting the LVL1_EN bit in CTRL6_C to 1, and the TRIG_EN, LVL2_EN bits in CTRL6_C to 0.

Once the level-sensitive trigger mode is enabled, the LSB bit of the selected data (in output registers and FIFO) is replaced by 1 if the DEN level is active, or 0 if the DEN level is not active. The selected data can be the X, Y, Z axes of the accelerometer or gyroscope sensor, defined through the DEN_X, DEN_Y, DEN_Z, DEN_XL_G bits in CTRL9_XL.

All data can be stored in the FIFO according to the FIFO settings.

Figure 7. Level-sensitive trigger mode, DEN active low shows with red circles the samples stored in the FIFO with LSB = 0 (DEN not active) and with blue circles the samples stored in the FIFO with LSB = 1 (DEN active).

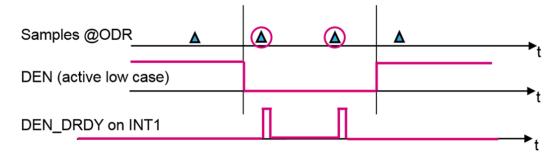
Figure 7. Level-sensitive trigger mode, DEN active low



When the level-sensitive trigger mode is enabled, the DEN signal can also be used to filter the data-ready signal on the INT1 pin. INT1 will show data-ready information only when the DEN pin is in the active state. To do this, the bit DEN_DRDY_INT1 of the CTRL4_C register must be set to 1. The interrupt signal can be latched or pulsed according to the DRDY_PULSED bit of the DRDY_PULSE_CFG register.

Figure 8. Level-sensitive trigger mode, DEN active low, DEN_DRDY on INT1 shows an example of data-ready on INT1 when the DEN level is low (active state).

Figure 8. Level-sensitive trigger mode, DEN active low, DEN_DRDY on INT1



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4.8.3 Level-sensitive latched mode

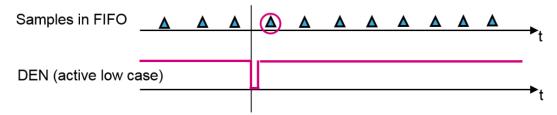
Level-sensitive latched mode can be enabled by setting the LVL1_EN and LVL2_EN bits in CTRL6_C to 1, and the TRIG_EN bit in CTRL6_C to 0.

When the level-sensitive latched mode is enabled, the LSB bit of the selected data (in output registers and FIFO) is normally set to 0 and becomes 1 only on the first sample after a pulse on the DEN pin.

Data can be selected through the DEN_X, DEN_Y, DEN_Z, DEN_XL_G bits in CTRL9_XL.

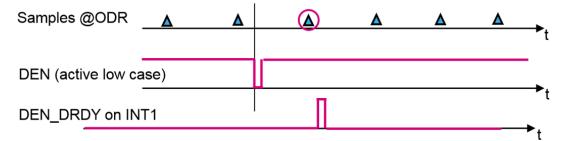
Figure 9. Level-sensitive latched mode, DEN active low shows an example of level-sensitive latched mode with DEN active low. After the pulse on the DEN pin, the sample with a red circle will have the value 1 on the LSB bit. All the other samples will have LSB bit 0.

Figure 9. Level-sensitive latched mode, DEN active low



When the level-sensitive latched mode is enabled and the bit DEN_DRDY_INT1 of the CTRL4_C register is set to 1, a pulse is generated on INT1 pin in corresponding to the availability of the first sample generated after the DEN pulse occurrence (see Figure 10. Level-sensitive latched mode, DEN active low, DEN_DRDY on INT1).

Figure 10. Level-sensitive latched mode, DEN active low, DEN_DRDY on INT1



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4.8.4 Level-sensitive FIFO enabled

Level-sensitive FIFO enable mode can be enabled by setting the TRIG_EN and LVL1_EN bits in CTRL6_C to 1, and the LVL2_EN bit in CTRL6_C to 0.

Once the level-sensitive FIFO enable mode is enabled, data is stored in the FIFO only when the DEN pin is equal to the active state.

In this mode, the LSB bit of the selected data (in output registers and FIFO) is replaced by 0 for odd DEN events and by 1 for even DEN events. This feature allows distinguishing the data stored in FIFO during the current DEN active window from the data stored in FIFO during the next DEN active window.

The selected data can be the X, Y, Z axes of the accelerometer or gyroscope sensor. Data can be selected through the DEN_X, DEN_Y, DEN_Z, DEN_XL_G bits in CTRL9_XL.

An example of level-sensitive FIFO enable mode is shown in Figure 11. Level-sensitive FIFO enable mode, DEN active low, the red circles show the samples stored in the FIFO with LSB bit 0, while the blue circles show the samples with LSB bit 1.

Figure 11. Level-sensitive FIFO enable mode, DEN active low

4.8.5 LSB selection for DEN stamping

When level-sensitive modes (trigger or latched) are used, it is possible to select which LSB have to contain information related to DEN pin behavior. This information can be stamped on the accelerometer or gyroscope axes in accordance with bits DEN_X, DEN_Y, DEN_Z and DEN_XL_G of the CTRL9_XL register. Setting to 1 the DEN_X, DEN_Y, DEN_Z bits, DEN information is stamped in the LSB of the corresponding axes of the sensor selected with the DEN_XL_G bit. By setting DEN_XL_G to 0, the DEN information is stamped in the selected gyroscope axes, while by setting DEN_XL_G to 1, the DEN information is stamped in the selected accelerometer axes.

By default, the bits are configured to have information on all the gyroscope axes.

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5 Interrupt generation

In the LSM6DS3TR-C device the interrupt generation is based on accelerometer data only, so, for interruptgeneration purposes, the accelerometer sensor has to be set in an active operating mode (not in Power-Down); the gyroscope sensor can be configured in Power-Down mode since it's not involved in interrupt generation.

The interrupt generator can be configured to detect:

- Free-fall;
- Wake-up;
- 6D/4D orientation detection;
- Single-tap and double-tap sensing;
- · Activity/Inactivity recognition.

In addition, the LSM6DS3TR-C can efficiently run the sensor-related features specified in Android, saving power and enabling faster reaction time. The following functions are implemented in hardware using only the accelerometer:

- Significant motion;
- Relative tilt;
- Absolute wrist tilt;
- · Pedometer functions;
- · Timestamp.

All these interrupt signals, together with the FIFO interrupt signals, can be independently driven to the INT1 and INT2 interrupt pins or checked by reading the dedicated source register bits.

The H_LACTIVE bit of the CTRL3_C register must be used to select the polarity of the interrupt pins. If this bit is set to 0 (default value), the interrupt pins are active high and they change from low to high level when the related interrupt condition is verified. Otherwise, if the H_LACTIVE bit is set to 1 (active low), the interrupt pins are normally at high level and they change from high to low when interrupt condition is reached.

The PP_OD bit of CTR3_C allows changing the behavior of the interrupt pins from push-pull to open drain. If the PP_OD bit is set to 0, the interrupt pins are in push-pull configuration (low-impedance output for both high and low level). When the PP_OD bit is set to 1, only the interrupt active state is a low-impedance output.

The LIR bit of TAP_CFG allows applying the latched mode to the interrupt signals. When the LIR bit is set to 1, once the interrupt pin is asserted, it must be reset by reading the related interrupt source register. If the LIR bit is set to 0, the interrupt signal is automatically reset when the interrupt condition is no longer verified or after a certain amount of time.

5.1 Interrupt pin configuration

The device is provided with two pins that can be activated to generate either data-ready or interrupt signals. The functionality of these pins is selected through the MD1_CFG and INT1_CTRL registers for the INT1 pin, and through the MD2_CFG and INT2_CTRL registers for the INT2 pin.

A brief description of these interrupt control registers is given in the following summary; the default value of their bits is equal to 0, which corresponds to 'disable'. In order to enable the routing of a specific interrupt signal on the pin, the related bit has to be set to 1.

Table 21. INT1_CTRL register

b7	b6	b5	b4	b3	b2	b1	b0
INT1_	INT1_	INT1_	INT1_	INT1_	INT1_	INT1_	INT1_
STEP_	SIGN_	FULL_	FIFO_	FTH	BOOT	DRDY_G	DRDY_
DETECTOR	MOT	FLAG	OVR				XL

INT1_STEP_DETECTOR: Pedometer step recognition interrupt on INT1

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- INT1 SIGN MOT: Significant motion interrupt on INT1
- INT1 FULL FLAG: FIFO full flag interrupt on INT1
- INT1_FIFO_OVR: FIFO overrun flag interrupt on INT1
- INT1 FTH: FIFO threshold interrupt on INT1
- INT1_BOOT: Boot interrupt on INT1
- INT1_DRDY_G: Gyroscope data-ready on INT1
- INT1_DRDY_XL: Accelerometer data-ready on INT1

Table 22. MD1_CFG register

b7	b6	b5	b4	b3	b2	b1	b0
INT1_	INT1_	INT1_	INT1_	INT1_	INT1_	INT1_	INT1_
INACT_	SINGLE_	WU	FF	DOUBLE_TA	6D	TILT	TIMER
STATE	TAP			Р			

- INT1 INACT STATE: Inactivity interrupt on INT1
- INT1_SINGLE_TAP: Single-tap interrupt on INT1
- INT1 WU: Wake-up interrupt on INT1
- INT1 FF: Free-fall interrupt on INT1
- INT1_DOUBLE_TAP: Double-tap interrupt on INT1
- INT1_6D: 6D detection interrupt on INT1
- INT1_TILT: Tilt interrupt on INT1
- INT1_TIMER: Timer interrupt on INT1

Table 23. INT2_CTRL register

b7	b6	b5	b4	b3	b2	b1	b0
INT2_	INT2_	INT2_	INT2_	INT2_	INT2_	INT2_	INT2_
STEP_	STEP_	FULL_	FIFO_	FTH	DRDY_	DRDY_G	DRDY_
DELTA	COUNT_OV	FLAG	OVR		TEMP		XL

- INT2_STEP_DELTA: Pedometer step recognition on delta time interrupt on INT2
- INT2 STEP COUNT OV: Step counter overflow interrupt on INT2
- INT2_FULL_FLAG: FIFO full flag interrupt on INT2
- INT2_FIFO_OVR: FIFO overrun flag interrupt on INT2
- INT2_FTH: FIFO threshold interrupt on INT2
- INT2_DRDY_TEMP: Temperature data-ready on INT2
- INT2_DRDY_G: Gyroscope data-ready on INT2
- INT2_DRDY_XL: Accelerometer data-ready on INT2

Table 24. MD2 CFG register

b7	b6	b5	b4	b3	b2	b1	b0
INT2_	INT2_	INT2_	INT2_	INT2_	INT2_	INT2_	INT2_
INACT_	SINGLE_	WU	FF	DOUBLE_TA	6D	TILT	IRON
STATE	TAP			Р			

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- INT2_INACT_STATE: Inactivity interrupt on INT2
- INT2 SINGLE TAP: Single-tap interrupt on INT2
- INT2 WU: Wake-up interrupt on INT2
- INT2_FF: Free-fall interrupt on INT2
- INT2 DOUBLE TAP: Double-tap interrupt on INT2
- INT2 6D: 6D detection interrupt on INT2
- INT2 TILT: Tilt interrupt on INT2
- INT2 IRON: Soft-iron / hard-iron interrupt on INT2

If multiple interrupt signals are routed on the same pin (INTx), the logic level of this pin is the "OR" combination of the selected interrupt signals. In order to know which event has generated the interrupt condition, the related source registers have to be read: WAKE_UP_SRC, D6D_SRC, TAP_SRC, FUNC_SRC1 and FUNC_SRC2.

The INT2_on_INT1 pin of CTRL4_C register allows driving all the enabled interrupt signals in logic "OR" on the INT1 pin (by setting this bit to 1). When this bit is set to 0, the interrupt signals are divided between the INT1 and INT2 pins.

The basic interrupts (6D/4D, free-fall, wake-up, tap, inactivity) have to be enabled by setting the INTERRUPTS_ENABLE bit in the TAP_CFG register.

5.2 Free-fall interrupt

Free-fall detection refers to a specific register configuration that allows recognizing when the device is in free-fall: the acceleration measured along all the axes goes to zero. In a real case a "free-fall zone" is defined around the zero-*g* level where all the accelerations are small enough to generate the interrupt. Configurable threshold and duration parameters are associated to free-fall event detection: the threshold parameter defines the free-fall zone amplitude; the duration parameter defines the minimum duration of the free-fall interrupt event to be recognized (Figure 12. Free-fall interrupt).

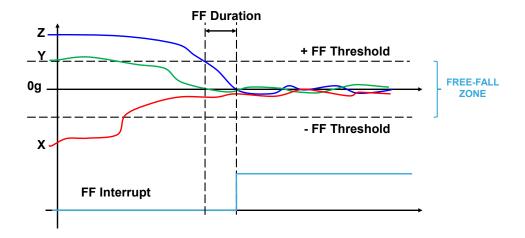


Figure 12. Free-fall interrupt

The free-fall interrupt signal can be enabled by setting the INTERRUPTS_ENABLE bit in the TAP_CFG register to 1 and can be driven to the two interrupt pins by setting the INT1_FF bit of the MD1_CFG register to 1 or the INT2_FF bit of the MD2_CFG register to 1; it can also be checked by reading the FF_IA bit of the WAKE_UP_SRC register.

If latched mode is disabled (LIR bit of TAP_CFG is set to 0), the interrupt signal is automatically reset when the free-fall condition is no longer verified. If latched mode is enabled and the free-fall interrupt signal is driven to the interrupt pins, once a free-fall event has occurred and the interrupt pin is asserted, it must be reset by reading the WAKE_UP_SRC register. If latched mode is enabled but the interrupt signal is not driven to the interrupt pins, the latch feature does not take effect.

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The FREE_FALL register used to configure the threshold parameter; the unsigned threshold value is related to the value of the FF_THS[2:0] field value as indicated in Table 25. Free-fall threshold LSB value. The values given in this table are valid for each accelerometer full-scale value.

FREE FALL - FF THS[2:0] Threshold LSB value [mg] 000 156 001 219 010 250 011 312 100 344 101 406 110 469 111 500

Table 25. Free-fall threshold LSB value

Duration time is measured in N/ODR_XL, where N is the content of the FF_DUR[5:0] field of the FREE_FALL / WAKE_UP_DUR registers and ODR_XL is the accelerometer data rate.

A basic SW routine for free-fall event recognition is given below.

```
    Write 60h to CTRL1_XL  // Turn on the accelerometer  // ODR_XL = 416 Hz, FS_XL = ±2 g
    Write 81h to TAP_CFG  // Enable interrupts and latch interrupt
    Write 00h to WAKE_UP_DUR  // Set event duration (FF_DUR5 bit)
    Write 33h to FREE_FALL  // Set six samples event duration (FF_DUR[5:0] = 000110b)
    Write 10h to MD1_CFG  // FF interrupt driven to INT1 pin
```

The sample code exploits a threshold set to 312 mg for free-fall recognition and the event is notified by hardware through the INT1 pin. The FF_DUR[5:0] field of the FREE_FALL / WAKE_UP_DUR registers is configured like this to ignore events that are shorter than $6/ODR_XL = 6/412$ Hz \sim = 15 msec in order to avoid false detections.

5.3 Wake-up interrupt

In the LSM6DS3TR-C device the wake-up feature can be implemented using either the slope filter (see Section 3.7.1 Accelerometer slope filter for more details) or the high-pass digital filter, as illustrated in Figure 2. Accelerometer filtering chain. The filter to be applied can be selected using the SLOPE_FDS bit of the TAP_CFG register: if this bit is set to 0 (default value), the slope filter is used; if it's set to 1, the HPF digital filter is used.

The wake-up interrupt signal is generated if a certain number of consecutive filtered data exceed the configured threshold (Figure 13. Wake-up interrupt (using the slope filter)).

The unsigned threshold value is defined using the WK_THS[5:0] bits of the WAKE_UP_THS register; the value of 1 LSB of these 6 bits depends on the selected accelerometer full scale: 1 LSB = $(FS_XL)/(2^6)$. The threshold is applied to both positive and negative data: for wake-up interrupt generation, the absolute value of the filtered data must be bigger than the threshold.

The duration parameter defines the minimum duration of the wake-up event to be recognized; its value is set using the WAKE_DUR[1:0] bits of the WAKE_UP_DUR register: 1 LSB corresponds to 1/ODR_XL time, where

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ODR_XL is the accelerometer output data rate. It is important to appropriately define the duration parameter to avoid unwanted wake-up interrupts due to spurious spikes of the input signal.

This interrupt signal can be enabled by setting the INTERRUPTS_ENABLE bit in TAP_CFG register to 1 and can be driven to the two interrupt pins setting to 1 the INT1_WU bit of the MD1_CFG register or the INT2_WU bit of the MD2_CFG register; it can also be checked by reading the WU_IA bit of the WAKE_UP_SRC register. The X_WU, Y_WU, Z_WU bits of the WAKE_UP_SRC register indicate which axis has triggered the wake-up event.

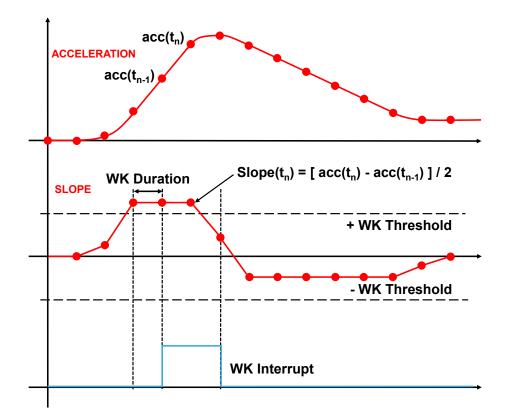


Figure 13. Wake-up interrupt (using the slope filter)

If latch mode is disabled (LIR bit of TAP_CFG is set to 0), the interrupt signal is automatically reset when the filtered data falls below the threshold. If latch mode is enabled and the wake-up interrupt signal is driven to the interrupt pins, once a wake-up event has occurred and the interrupt pin is asserted, it must be reset by reading the WAKE_UP_SRC register. If the latch mode is enabled but the interrupt signal is not driven to the interrupt pins, the latch feature does not take effect.

A basic SW routine for wake-up event recognition using the high-pass digital filter is given below.

Write 60h to CTRL1_XL // Turn on the accelerometer // ODR_XL = 416 Hz, FS_XL = ±2 g
 Write 90h to TAP_CFG // Enable interrupts and apply high-pass digital filter; latched // mode disabled
 Write 00h to WAKE_UP_DUR // No duration
 Write 02h to WAKE_UP_THS // Set wake-up threshold
 Write 20h to MD1_CFG // Wake-up interrupt driven to INT1 pin

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Since the duration time is set to zero, the wake-up interrupt signal is generated for each X,Y,Z filtered data exceeding the configured threshold. The WK_THS field of the WAKE_UP_THS register is set to 000010b, therefore the wake-up threshold is 62.5 mg (= $2 * \text{FS} \times \text{L} / 2^6$).

Since the wake-up functionality is implemented using the slope/high-pass digital filter, it is necessary to consider the settling time of the filter just after this functionality is enabled. For example, when using the slope filter (but a similar consideration can be done for the high-pass digital filter usage) the wake-up functionality is based on the comparison of the threshold value with half of the difference of the acceleration of the current (x,y,z) sample and the previous one (refer to Section 3.7.1 Accelerometer slope filter).

At the very first sample, the slope filter output is calculated as half of the difference of the current sample [e.g. (x,y,z) = (0,0,1g)] with the previous one which is (x,y,z) = (0,0,0) since it doesn't exist. For this reason, on the z-axis the first output value of the slope filter is (1g - 0)/2 = 500 mg and it could be higher than the threshold value in which case a spurious interrupt event is generated. The interrupt signal is kept high for 1 ODR then it goes low.

In order to avoid this spurious interrupt generation, multiple solutions are possible. Hereafter are three alternative solutions (for the slope filter case):

- a. Ignore the first generated wake-up signal;
- b. Add a wait time higher than 1 ODR before driving the interrupt signal to the INT1/2 pin;
- **c.** Initially set a higher ODR (833 Hz) so the first 2 samples are generated in a shorter period of time, reducing the slope filter latency time, then set the desired ODR (e.g. 12.5 Hz) and drive the interrupt signal on the pin, as indicated in the procedure below:

```
1. Write 00h to WAKE UP DUR
                                           // No duration
2. Write 02h to WAKE_UP_THS
                                           // Set wake-up threshold
   Write 80h to TAP CFG
                                           // Enable interrupts and apply slope filter; latch mode disabled
3.
   Write 70h to CTRL1_XL
                                           // Turn on the accelerometer
                                           // ODR_XL = 833 Hz, FS_XL = \pm 2 g
5
   Wait 4 ms
                                           // Insert (reduced) wait time
   Write 10h to CTRL1_XL
                                           // ODR_XL = 12.5 Hz
6.
   Write 20h to MD1_CFG
                                           // Wake-up interrupt driven to INT1 pin
```

5.4 6D/4D orientation detection

The LSM6DS3TR-C device provides the capability to detect the orientation of the device in space, enabling easy implementation of energy-saving procedures and automatic image rotation for mobile devices.

5.4.1 6D orientation detection

Six orientations of the device in space can be detected; the interrupt signal is asserted when the device switches from one orientation to another. The interrupt is not re-asserted as long as the position is maintained.

6D interrupt is generated when, for two consecutive samples, only one axis exceeds a selected threshold and the acceleration values measured from the other two axes are lower than the threshold: the ZH, ZL, YH, YL, XH, XL bits of the D6D_SRC register indicate which axis has triggered the 6D event.

In more detail:

Table 26. D6D_SRC register

b7	b6	b5	b4	b3	b2	b1	b0
DEN_	D6D_IA	ZH	ZL	YH	YL	XH	XL
DRDY							

D6D IA is set high when the device switches from one orientation to another.

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- ZH (YH, XH) is set high when the face perpendicular to the Z (Y, X) axis is almost flat and the acceleration measured on the Z (Y, X) axis is positive and in the absolute value bigger than the threshold.
- ZL (YL, XL) is set high when the face perpendicular to the Z (Y, X) axis is almost flat and the acceleration measured on the Z (Y, X) axis is negative and in the absolute value bigger than the threshold.

The SIXD_THS[1:0] bits of the TAP_THS_6D register are used to select the threshold value used to detect the change in device orientation. The threshold values given in Table 27. Threshold for 4D/6D function are valid for each accelerometer full-scale value.

 SIXD_THS[1:0]
 Threshold value [degrees]

 00
 80

 01
 70

 10
 60

 11
 50

Table 27. Threshold for 4D/6D function

The low-pass filter LPF2 can also be used in 6D functionality by setting the LOW_PASS_ON_6D bit of the CTRL8 XL register to 1.

This interrupt signal can be enabled by setting the INTERRUPTS_ENABLE bit in the TAP_CFG register to 1 and can be driven to the two interrupt pins by setting to 1 the INT1_6D bit of the MD1_CFG register or the INT2_6D bit of the MD2_CFG register; it can also be checked by reading the D6D_IA bit of the D6D_SRC register.

If latched mode is disabled (LIR bit of TAP_CFG is set to 0), the interrupt signal is active only for 1/ODR_XL[s] then it is automatically disserted (ODR_XL is the accelerometer output data rate). If latched mode is enabled and the 6D interrupt signal is driven to the interrupt pins, once an orientation change has occurred and the interrupt pin is asserted, a reading of the D6D_SRC register clears the request and the device is ready to recognize a different orientation. If latched mode is enabled but the interrupt signal is not driven to the interrupt pins, the latch feature does not take effect.

Referring to the six possible cases illustrated in Figure 14. 6D recognized orientations, the content of the D6D_SRC register for each position is shown in Table 28. D6D_SRC register in 6D positions.

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Figure 14. 6D recognized orientations

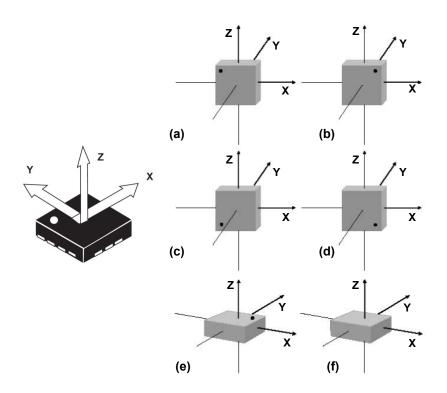


Table 28. D6D_SRC register in 6D positions

Case	D6D_IA	ZH	ZH	YH	YL	ХН	XL
(a)	1	0	0	1	0	0	0
(b)	1	0	0	0	0	0	1
(c)	1	0	0	0	0	1	0
(d)	1	0	0	0	1	0	0
(e)	1	1	0	0	0	0	0
(f)	1	0	1	0	0	0	0

A basic SW routine for 6D orientation detection is as follows.

Write 60h to CTRL1_XL // Turn on the accelerometer // ODR_XL = 416 Hz, FS_XL = ±2 g
 Write 80h to TAP_CFG // Enable interrupts; latched mode disabled
 Write 40h to TAP_THS_6D // Set 6D threshold (SIXD_THS[1:0] = 10b = 60 degrees)
 Write 01h to CTRL8_XL // Enable LPF2 filter to 6D functionality
 Write 04h to MD1_CFG // 6D interrupt driven to INT1 pin

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5.4.2 4D orientation detection

The 4D direction function is a subset of the 6D function especially defined to be implemented in mobile devices for portrait and landscape computation. It can be enabled by setting the D4D_EN bit of the TAP_THS_6D register to 1. In this configuration, the Z-axis position detection is disabled, therefore reducing position recognition to cases (a), (b), (c), and (d) of Table 28. D6D_SRC register in 6D positions.

5.5 Single-tap and double-tap recognition

The single-tap and double-tap recognition functions featured in the LSM6DS3TR-C help to create a man-machine interface with little software loading. The device can be configured to output an interrupt signal on a dedicated pin when tapped in any direction.

If the sensor is exposed to a single input stimulus, it generates an interrupt request on the inertial interrupt pin INT1 and/or INT2. A more advanced feature allows the generation of an interrupt request when a double input stimulus with programmable time between the two events is recognized, enabling a mouse button-like function.

In the LSM6DS3TR-C device the single-tap and double-tap recognition functions use the slope between two consecutive acceleration samples to detect the tap events; the slope data is calculated using the following formula:

$$slope(t_n) = [acc(t_n) - acc(t_{n-1})] / 2$$

This function can be fully programmed by the user in terms of expected amplitude and timing of the slope data by means of a dedicated set of registers.

Single and double-tap recognition work independently of the selected output data rate. Recommended accelerometer ODRs for these functions are 416 Hz and 833 Hz.

In order to enable the single-tap and double-tap recognition functions it is necessary to set the INTERRUPTS_ENABLE bit in TAP_CFG register to 1.

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5.5.1 Single tap

If the device is configured for single-tap event detection, an interrupt is generated when the slope data of the selected channel exceeds the programmed threshold, and returns below it within the Shock time window.

In the single-tap case, if the LIR bit of the TAP_CFG register is set to 0, the interrupt is kept active for the duration of the Quiet window.

In order to enable the latch feature on the single-tap interrupt signal, both the LIR bit and the INT1_DOUBLE_TAP (or INT2_DOUBLE_TAP) bit of MD1_CFG (MD2_CFG) have to be set to 1: the interrupt is kept active until the TAP_SRC register is read.

The SINGLE_DOUBLE_TAP bit of WAKE_UP_THS has to be set to 0 in order to enable single-tap recognition only.

In case (a) of Figure 15. Single-tap event recognition the single-tap event has been recognized, while in case (b) the tap has not been recognized because the slope data falls below the threshold after the Shock time window has expired.

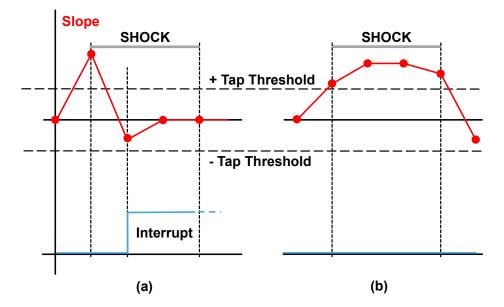


Figure 15. Single-tap event recognition

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5.5.2 Double tap

If the device is configured for double-tap event detection, an interrupt is generated when, after a first tap, a second tap is recognized. The recognition of the second tap occurs only if the event satisfies the rules defined by the Shock, the Latency and the Duration time windows.

In particular, after the first tap has been recognized, the second tap detection procedure is delayed for an interval defined by the Quiet time. This means that after the first tap has been recognized, the second tap detection procedure starts only if the slope data exceeds the threshold after the Quiet window but before the Duration window has expired. In case (a) of Figure 16. Double-tap event recognition (LIR bit = 0), a double-tap event has been correctly recognized, while in case (b) the interrupt has not been generated because the slope data exceeds the threshold after the window interval has expired.

Once the second tap detection procedure is initiated, the second tap is recognized with the same rule as the first: the slope data must return below the threshold before the Shock window has expired.

It is important to appropriately define the Quiet window to avoid unwanted taps due to spurious bouncing of the input signal.

In the double-tap case, if the LIR bit of the TAP_CFG register is set to 0, the interrupt is kept active for the duration of the Quiet window. If the LIR bit is set to 1, the interrupt is kept active until the TAP_SRC register is read

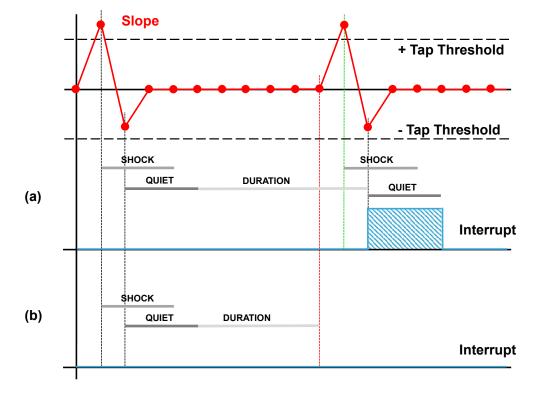


Figure 16. Double-tap event recognition (LIR bit = 0)

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5.5.3 Single-tap and double-tap recognition configuration

The LSM6DS3TR-C device can be configured to output an interrupt signal when tapped (once or twice) in any direction: the TAP_X_EN, TAP_Y_EN and TAP_Z_EN bits of the TAP_CFG register must be set to 1 to enable the tap recognition on the X, Y, Z directions, respectively. In addition, the INTERRUPTS_ENABLE bit of the TAP_CFG register has to be set to 1.

Configurable parameters for tap recognition functionality are the tap threshold and the Shock, Quiet and Duration time windows.

The TAP_THS[4:0] bits of the TAP_THS_6D register are used to select the unsigned threshold value used to detect the tap event. The value of 1 LSB of these 5 bits depends on the selected accelerometer full scale: 1 LSB = $(FS \times L)/(2^5)$. The unsigned threshold is applied to both positive and negative slope data.

Note: Tap threshold (in mg) set through the TAP_THS[4:0] bits of the TAP_THS_6D register must be higher than the wake-up threshold (in mg) set through the WK_THS[5:0] bits of the WAKE_UP_THS register.

The Shock time window defines the maximum duration of the overcoming threshold event: the acceleration must return below the threshold before the Shock window has expired, otherwise the tap event is not detected. The SHOCK[1:0] bits of the INT_DUR2 register are used to set the Shock time window value: the default value of these bits is 00b and corresponds to 4/ODR_XL time, where ODR_XL is the accelerometer output data rate. If the SHOCK[1:0] bits are set to a different value, 1 LSB corresponds to 8/ODR_XL time.

In the double-tap case, the Quiet time window defines the time after the first tap recognition in which there must not be any overcoming threshold event. When latched mode is disabled (LIR bit of TAP_CFG is set to 0), the Quiet time also defines the length of the interrupt pulse (in both single and double-tap case). The QUIET[1:0] bits of the INT_DUR2 register are used to set the Quiet time window value: the default value of these bits is 00b and corresponds to 2/ODR_XL time, where ODR_XL is the accelerometer output data rate. If the QUIET[1:0] bits are set to a different value, 1 LSB corresponds to 4/ODR_XL time.

In the double-tap case, the Duration time window defines the maximum time between two consecutive detected taps. The Duration time period starts just after the completion of the Quiet time of the first tap. The DUR[3:0] bits of the INT_DUR2 register are used to set the Duration time window value: the default value of these bits is 0000b and corresponds to 16/ODR_XL time, where ODR_XL is the accelerometer output data rate. If the DUR[3:0] bits are set to a different value, 1 LSB corresponds to 32/ODR_XL time.

Figure 17. Single and double-tap recognition (LIR bit = 0) illustrates a single-tap event (a) and a double-tap event (b). These interrupt signals can be driven to the two interrupt pins by setting to 1 the INT1_SINGLE_TAP bit of the MD1_CFG register or the INT2_SINGLE_TAP bit of the MD2_CFG register for the single-tap case, and setting to 1 the INT1_DOUBLE_TAP bit of the MD1_CFG register or the INT2_DOUBLE_TAP bit of the MD2_CFG register for the double-tap case.

No single/double-tap interrupt is generated if the accelerometer is in Inactivity status (see Section 5.6 Activity/Inactivity recognition for more details).

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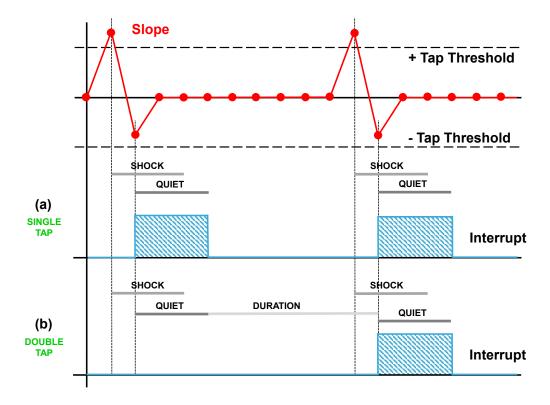


Figure 17. Single and double-tap recognition (LIR bit = 0)

Tap interrupt signals can also be checked by reading the TAP_SRC (1Ch) register, described in Table 29. TAP_SRC register.

b7 b6 b5 b4 b3 b2 b1 b0 TAP_IA 0 SINGLE **DOUBLE** TAP_ X_TAP Y_TAP **Z_TAP** _TAP _TAP SIGN

Table 29. TAP_SRC register

- TAP_IA is set high when a single-tap or double-tap event has been detected.
- SINGLE_TAP is set high when a single tap has been detected.
- DOUBLE_TAP is set high when a double tap has been detected.
- TAP_SIGN indicates the acceleration sign when the tap event is detected. It is set low in case of positive sign and it is set high in case of negative sign.
- X_TAP (Y_TAP, Z_TAP) is set high when the tap event has been detected on the X (Y, Z) axis.

Single and double-tap recognition works independently. Setting the SINGLE_DOUBLE_TAP bit of the WAKE_UP_THS register to 0, only the single-tap recognition is enabled: double-tap recognition is disabled and cannot be detected. When the SINGLE_DOUBLE_TAP is set to 1, both single and double-tap recognition are enabled.

If latched mode is enabled and the interrupt signal is driven to the interrupt pins, the value assigned to SINGLE_DOUBLE_TAP also affects the behavior of the interrupt signal: when it is set to 0, the latched mode is applied to the single-tap interrupt signal; when it is set to 1, the latched mode is applied to the double-tap interrupt signal only. The latched interrupt signal is kept active until the TAP_SRC register is read. If latched mode is enabled but the interrupt signal is not driven to the interrupt pins, the latch feature does not take effect.

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5.5.4 Single-tap example

A basic SW routine for single-tap detection is given below.

```
Write 60h to CTRL1_XL
                                             // Turn on the accelerometer
                                             // ODR XL = 416 Hz, FS XL = \pm 2 q
    Write 8Eh to TAP_CFG
                                             // Enable interrupts and tap detection on X, Y, Z axis
2
3.
    Write 89h to TAP_THS_6D
                                             // Set tap threshold
    Write 06h to INT_DUR2
                                             // Set Quiet and Shock time windows
4.
    Write 00h to WAKE_UP_THS
                                             // Only single-tap enabled (SINGLE_DOUBLE_TAP = 0)
    Write 40h to MD1 CFG
                                             // Single-tap interrupt driven to INT1 pin
```

In this example the TAP_THS field of the TAP_THS_6D register is set to 01001b, therefore the tap threshold is 562.5 mg (= $9 * FS \times L / 2^5$).

The SHOCK field of the INT_DUR2 register is set to 10b: an interrupt is generated when the slope data exceeds the programmed threshold, and returns below it within 38.5 ms (= 2 * 8 / ODR_XL) corresponding to the Shock time window.

The QUIET field of the INT_DUR2 register is set to 01b: since latched mode is disabled, the interrupt is kept high for the duration of the Quiet window, therefore 9.6 ms (= 1 * 4 / ODR XL).

5.5.5 Double-tap example

A basic SW routine for double-tap detection is given below.

1.	Write 60h to CTRL1_XL	// Turn on the accelerometer				
		// ODR_XL = 416 Hz, FS_XL = $\pm 2 g$				
2.	Write 8Eh to TAP_CFG	// Enable interrupts and tap detection on X, Y, Z-axis				
3.	Write 8Ch to TAP_THS_6D	// Set tap threshold				
4.	Write 7Fh to INT_DUR2	// Set Duration, Quiet and Shock time windows				
5.	Write 80h to WAKE_UP_THS	// Single & double-tap enabled (SINGLE_DOUBLE_TAP = 1)				
6.	Write 08h to MD1_CFG	// Double-tap interrupt driven to INT1 pin				

In this example the TAP_THS field of the TAP_THS_6D register is set to 01100b, therefore the tap threshold is 750 mg (= $12 * FS \times L / 2^5$).

For interrupt generation, during the first and the second tap the slope data must return below the threshold before the Shock window has expired. The SHOCK field of the INT_DUR2 register is set to 11b, therefore the Shock time is 57.7 ms (= 3 * 8 / ODR_XL).

For interrupt generation, after the first tap recognition there must not be any slope data overthreshold during the Quiet time window. Furthermore, since latched mode is disabled, the interrupt is kept high for the duration of the Quiet window. The QUIET field of the INT_DUR2 register is set to 11b, therefore the Quiet time is 28.8 ms (= 3 * 4 / ODR_XL).

For the maximum time between two consecutive detected taps, the DUR field of the INT_DUR2 register is set to 0111b, therefore the Duration time is 538.5 ms (= 7 * 32 / ODR_XL).

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5.6 Activity/Inactivity recognition

The Activity/Inactivity recognition function allows reducing system power consumption and developing new smart applications.

When the Activity/Inactivity recognition function is activated, the LSM6DS3TR-C device is able to automatically decrease the accelerometer sampling rate to 12.5 Hz, increasing the accelerometer ODR and bandwidth as soon as the wake-up interrupt event has been detected. In the LSM6DS3TR-C this feature can be extended to gyroscope, with three possible options:

- · Gyroscope configurations do not change;
- Gyroscope enters in Sleep mode;
- Gyroscope enters in Power-Down mode.

With this feature the system may be efficiently switched from low-power consumption to full performance and vice-versa depending on user-selectable acceleration events, thus ensuring power saving and flexibility. The maximum allowed accelerometer ODR (configurable through the ODR_XL [3:0] bits of the CTRL1_XL register) for using the Activity/Inactivity feature is 3.3 kHz.

The Activity/Inactivity recognition function is enabled by setting the INTERRUPTS_ENABLE bit to 1 and configuring the INACT_EN bits of the TAP_CFG register. Possible configurations of the inactivity event are summarized in Table 30. Inactivity event configuration.

INACT_EN[1:0]	Accelerometer	Gyroscope
00	Inactivity event disabled	Inactivity event disabled
01	XL ODR = 12.5 Hz (Low-Power mode)	Gyro configuration unchanged
10	XL ODR = 12.5 Hz (Low-Power mode)	Gyro in Sleep mode
11	XL ODR = 12.5 Hz (Low-Power mode)	Gyro in Power-Down mode

Table 30. Inactivity event configuration

In the LSM6DS3TR-C device the Activity/Inactivity recognition function can be implemented using either the slope filter (see Section 3.7.1 Accelerometer slope filter for more details) or the high-pass digital filter, as illustrated in Figure 2. Accelerometer filtering chain. The filter to be applied can be selected using the SLOPE_FDS bit of the TAP_CFG register: if this bit is set to 0 (default value), the slope filter is used; if it is set to 1, the high-pass digital filter is used.

This function can be fully programmed by the user in terms of expected amplitude and timing of the filtered data by means of a dedicated set of registers (Figure 18. Activity/Inactivity recognition (using the slope filter)).

The unsigned threshold value is defined using the WK_THS[5:0] bits of the WAKE_UP_THS register; the value of 1 LSB of these 6 bits depends on the selected accelerometer full scale: 1 LSB = $(FS_XL)/(2^6)$. The threshold is applied to both positive and negative filtered data.

When a certain number of consecutive X,Y,Z filtered data is smaller than the configured threshold, the ODR_XL [3:0] bits of the CTRL1_XL register are bypassed (Inactivity) and the accelerometer is internally set to 12.5 Hz although the content of CTRL1_XL is left untouched. The gyroscope behavior varies according to the configuration of the INACT_EN bits of the TAP_CFG register. The duration of the Inactivity status to be recognized is defined by the SLEEP_DUR[3:0] bits of the WAKE_UP_DUR register: 1 LSB corresponds to 512/ODR_XL time, where ODR_XL is the accelerometer output data rate.

When the Inactivity status is detected, the interrupt is set high for 1/ODR_XL[s] period then it is automatically deasserted.

When a single sample of X,Y,Z filtered data on one axis becomes bigger than the threshold, the CTRL1_XL register settings are immediately restored (Activity) and the gyroscope is restored to the previous state.

When the Activity status is detected, the interrupt is set high for 1/ODR_XL[s] period then it is automatically deasserted.

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Once the Activity/Inactivity detection function is enabled, the status can be driven to the two interrupt pins by setting to 1 the INT1_INACT_STATE bit of the MD1_CFG register or the INT2_INACT_STATE bit of the MD2_CFG register; it can also be checked by reading the SLEEP_STATE_IA bit of the WAKE_UP_SRC register.

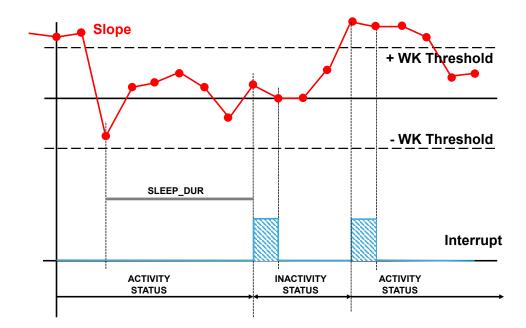


Figure 18. Activity/Inactivity recognition (using the slope filter)

A basic SW routine for Activity/Inactivity detection is as follows:

1.	Write 50h to CTRL1_XL	// Turn on the accelerometer
		// ODR_XL = 208 Hz, FS_XL = $\pm 2 g$
2.	Write 40h to CTRL2_G	// Turn on the gyroscope
		// ODR_G = 104 Hz, FS_G = ±250 dps
3.	Write 02h to WAKE_UP_DUR	// Set duration for Inactivity detection
4.	Write 02h to WAKE_UP_THS	// Set Activity/Inactivity threshold
5.	Write E0h to TAP_CFG	// Enable interrupts
		// Inactivity configuration: acc to 12.5 LP, gyro to Power-Down
		// Enable slope filter
6.	Write 80h to MD1_CFG	// Activity/Inactivity interrupt driven to INT1 pin

In this example the WK_THS field of the WAKE_UP_THS register is set to 000010b, therefore the Activity/Inactivity threshold is 62.5 mg (= $2 * \text{FS}_XL / 2^6$).

Before Inactivity detection, the X,Y,Z slope data must be smaller than the configured threshold for a period of time defined by the SLEEP_DUR field of the WAKE_UP_DUR register: this field is set to 0010b, corresponding to $4.92 \, \text{s}$ (= $2 * 512 / \text{ODR}_X \text{L}$). After this period of time has elapsed, the accelerometer ODR is internally set to $12.5 \, \text{Hz}$ and the gyroscope is internally set to Power-Down mode.

The Activity status is detected, the CTRL1_XL register settings immediately restored and the gyroscope is turned on if the slope data of (at least) one axis are bigger than the threshold.

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5.7 Boot status

After the device is powered up, the LSM6DS3TR-C performs a 15 ms boot procedure to load the trimming parameters. After the boot is completed, both the accelerometer and the gyroscope are automatically configured in Power-Down mode. During the boot time the registers are not accessible.

After power up, the trimming parameters can be re-loaded by setting the BOOT bit of the CTRL3 C register to 1.

No toggle of the device power lines is required and the content of the device control registers is not modified, so the device operating mode doesn't change after boot. If the reset to the default value of the control registers is required, it can be performed by setting the SW_RESET bit of the CTRL3_C register to 1. The SW_RESET procedure can take 50 µs; the status of reset is signaled by the status of the SW_RESET bit of the CTRL3_C register: once the reset is completed, this bit is automatically set low.

The boot status signal is driven to the INT1 interrupt pin by setting the INT1_BOOT bit of the INT1_CTRL register to 1: this signal is set high while the boot is running and it is set low again at the end of the boot procedure.

The reboot flow is as follows:

- 1. Set the gyroscope in Power-Down mode;
- 2. Set the accelerometer in High-Performance mode;
- 3. Set to 1 the BOOT bit of the CTRL3 C register;
- Wait 15 ms.

Reset flow is as follows:

- 1. Set the gyroscope in Power-Down mode;
- Set the accelerometer in High-Performance mode;
- 3. Set to 1 the SW RESET bit of the CTRL3 C register;
- 4. Wait 50 µs (or wait until the SW RESET bit of the CTRL3 C register returns to 0).

In order to avoid conflicts, the reboot and the sw reset must not be executed at the same time (do not set to 1 at the same time both the BOOT bit and SW_RESET bit of CTRL3_C register). The above flows must be performed serially.

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6 Embedded functions

The LSM6DS3TR-C device implements in hardware many embedded functions; specific IP blocks with negligible power consumption and high-level performance implement the following functions using only the accelerometer:

- Pedometer functions (step detector and step counter);
- · Significant motion;
- · Relative tilt;
- Absolute wrist tilt:
- Timestamp.

All these functions work at 26 Hz, so the accelerometer ODR must be set at a value of 26 Hz or higher.

6.1 Pedometer functions: step detector and step counter

A specific IP block of the LSM6DS3TR-C device is dedicated to pedometer functions: the step detector and the step counter.

Pedometer functions work at 26 Hz, so the accelerometer ODR must be set at values of 26 Hz or higher. In order to enable the pedometer functions it is necessary to set to 1 both the FUNC_EN bit and the PEDO_EN bit of the CTRL10 C register.

The step counter indicates the number of steps detected by the step detector algorithm after the pedometer function has been enabled. The step count is given by the concatenation of the STEP_COUNTER_H and STEP_COUNTER_L registers and it is represented as a 16-bit unsigned number.

The step count is not reset to zero when the accelerometer is configured in Power-Down or the pedometer is disabled; it can be reset to zero by setting the PEDO_RST_STEP bit of the CTRL10_C register to 1. After the counter resets, the PEDO_RST_STEP bit is not automatically set back to 0.

The step detector functionality generates an interrupt every time a step is recognized. In case of interspersed step sessions, 7 consecutive steps (debounce steps) have to be detected before the first interrupt generation in order to avoid false step detections (debounce functionality).

The number of debounce steps can be modified through the DEB_STEP field of the PEDO_DEB_REG register: basically, it corresponds to the minimum number of steps to be detected before the first step counter increment. 1 LSB of this field corresponds to 1 step, the default value is 6 steps.

The debounce functionality restarts after around 1 second of device inactivity. This period of time (debouncing time) can be modified through the DEB_TIME field of the PEDO_DEB_REG register. 1LSB corresponds to 80 ms, the default value is 13 (13 * 80 ms = 1040 ms). This value must be greater than 0.

The example in Figure 19. Pedometer debounce explains how the step counter behavior changes by changing the debounce time. In this example, the pedometer algorithm detects 7 steps close to each other and then two more isolated steps after a certain period of time; assuming that the value of the DEB_STEP field of the PEDO_DEB_REG register is set to 6 LSB (= 6 debounce steps, default value) and the initial step counter value in the STEP_COUNTER_H/L registers is zero (no steps previously detected):

a. in case (a), the step count starts increasing after the seventh step and after the first eight detected steps, the value of STEP_COUNTER_H/L registers will be 8. Since the debounce time set in the DEB_TIME field of the PEDO_DEB_REG register is greater than the period of time between the step #8 and the step #9, also the steps #9 and #10 will cause the step counter to increase: the final step count value in STEP_COUNTER_H/L registers will be 10.

b. also in case (b) the step count starts increasing after the seventh step and after the first eight detected steps, the value of STEP_COUNTER_H/L registers will be 8, but since the debounce time set in the DEB_TIME field of the PEDO_DEB_REG register is lower than the period of time between the step #8 and the step #9, the steps #9 and #10 will not cause the step counter to increase: the final step count value in STEP_COUNTER_H/L registers will be 8. Furthermore, if between the step #10 and the following step elapses a period of time greater than the debounce time, the detected steps #9 and #10 will be definitively discarded and no longer considered.

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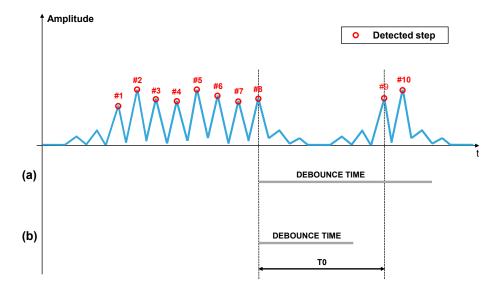


Figure 19. Pedometer debounce

By default, the step counter works at $\pm 2~g$ full scale, independently of the configured device full scale, but it can be configured to work at $\pm 4~g$ full scale which can help to avoid acceleration saturation (e.g. in fast walk). In order to set the $\pm 4~g$ full scale for the step counter, the PEDO_FS bit of the CONFIG_PEDO_THS_MIN register has to be set to 1 and the accelerometer full scale configured in CTRL1_XL register must be $\geq \pm 4~g$.

It is also possible to set the "Minimum Threshold", that is the value at which the threshold for step recognition asymptotically tends if no steps are detected and below which it cannot descend (see Figure 20. Pedometer minimum threshold). This configuration is available in the ths_min field of the CONFIG_PEDO_THS_MIN register. The value of 1 LSB of these 6 bits depends on the selected step counter full scale: 1 LSB = 16 mg if the PEDO_FS bit is 0; 1 LSB = 32 mg if the PEDO_FS bit is 1.

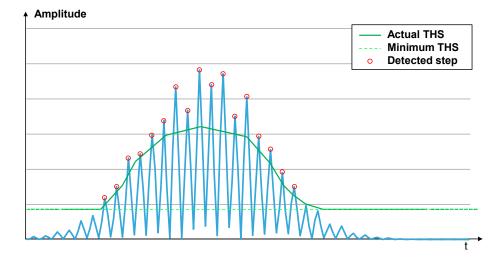


Figure 20. Pedometer minimum threshold

The step detector interrupt signal can be driven to the INT1 interrupt pin by setting the INT1_STEP_DETECTOR bit of the INT1_CTRL register to 1; it can also be checked by reading the STEP_DETECTED bit of the FUNC_SRC1 register.

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Instead of generating an interrupt every time a step is recognized, it is possible to generate it if at least one step is detected within a certain time period. This time period is defined by setting a value higher than 00h in the STEP_COUNT_DELTA register. It is necessary to set the TIMER_EN bit of the CTRL10_C register to 1 (to enable the timer) and the TIMER_HR bit of the WAKE_UP_DUR register to 0 when using this feature: in this case, 1 LSB of the value of the STEP_COUNT_DELTA register corresponds to 1.6384 seconds. This interrupt signal can be driven to the INT2 interrupt pin by setting to 1 the INT2_STEP_DELTA bit of the INT2_CTRL register; it can also be checked by reading the STEP_COUNT_DELTA_IA bit of the FUNC_SRC1 register.

The step counter overflow signal can be driven to the INT2 interrupt pin by setting the INT2_STEP_COUNT_OV bit of the INT2_CTRL register to 1: in this case, when the step count reaches the 2¹⁶ value, an interrupt signal is generated on the INT2 pin and the step count is automatically reset to zero, no need to reset it by setting the PEDO RST STEP bit to 1.

If latched mode is disabled (LIR bit of TAP_CFG is set to 0), the interrupt signal generated by the pedometer functions is pulsed: the duration of the pulse observed on the interrupt pins is about 75 μ s; the duration of the pulse observed on the bits STEP_COUNT_DELTA_IA, STEP_DETECTED and STEP_OVERFLOW of the FUNC SRC1 register is 1/26 Hz.

If latched mode is enabled (LIR bit of TAP_CFG is set to 1) and the interrupt signal is driven to the interrupt pins, once a step has occurred, a reading of the FUNC_SRC1 register clears the request on both the pins and the STEP_COUNT_DELTA_IA, STEP_DETECTED and STEP_OVERFLOW bits of the FUNC_SRC1 register, and the device is ready to recognize the next step. If latched mode is enabled but the interrupt signal is not driven to the interrupt pins, the interrupt signal observed on the bits of the FUNC_SRC1 register is pulsed, with a fixed duration of 1/26 Hz.

Step counter timestamp information is available in the STEP_TIMESTAMP_H and STEP_TIMESTAMP_L registers: when a step is detected, the value of the TIMESTAMP_REG2 register is copied in STEP_TIMESTAMP_H, and the value of the TIMESTAMP_REG1 register is copied in STEP_TIMESTAMP_L, providing the timestamp information of this step. For more details about LSM6DS3TR-C timestamp counter and TIMESTAMP_REG2/TIMESTAMP_REG1, see Section 6.5 Timestamp.

The step counter timestamp resolution depends on the value of the TIMER_HR bit of the WAKE_UP_DUR register: when this bit is set to 0, 1 LSB of the time step count corresponds to 1638.4 ms; when this bit is set to 1, 1 LSB of the time step count corresponds to 6.4 ms.

Step counter data can be stored in FIFO as a fourth data set along with timestamp data (see Section 8.8 Step counter and timestamp data in FIFO for more details).

A basic SW routine which shows how to enable the pedometer functions is as follows:

```
    Write 20h to CTRL1_XL  // Turn on the accelerometer  // ODR_XL = 26 Hz, FS_XL = ±2 g
    Write 14h to CTRL10_C  // Enable embedded functions and pedometer algorithm
    Write 80h to INT1 CTRL  // Step detector interrupt driven to INT1 pin
```

The interrupt signal is generated when a step is recognized and the step count is available by reading the STEP_COUNTER_H / STEP_COUNTER_L registers.

6.2 Significant motion

The significant motion function generates an interrupt when a 'significant motion', that could be due to a change in user location, is detected: in the LSM6DS3TR-C device this function has been implemented in hardware using only the accelerometer.

The significant motion functionality can be used in location-based applications in order to receive a notification indicating when the user is changing location.

The significant motion function works at 26 Hz, so the accelerometer ODR must be set at a value of 26 Hz or higher.

In order to enable significant motion detection it is necessary to set to 1 both the FUNC_EN bit and the SIGN_MOTION_EN bit of the CTRL10_C register.

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The significant motion interrupt signal is driven to the INT1 interrupt pin by setting the INT1_SIGN_MOT bit of the INT1_CTRL register to 1; it can also be checked by reading the SIGN_MOTION_IA bit of the FUNC_SRC1 register.

If latched mode is disabled (LIR bit of TAP_CFG is set to 0), the interrupt signal generated by the significant motion function is pulsed: the duration of the pulse observed on the interrupt pins is about 75 μ s; the duration of the pulse observed on the SIGN_MOTION_IA bit of the FUNC_SRC1 register is 1/26 Hz.

If latched mode is enabled (LIR bit of TAP_CFG is set to 1) and the interrupt signal is driven to the interrupt pins, once a 'significant motion' is detected, a reading of the FUNC_SRC1 register clears the request on both the pins and the SIGN_MOTION_IA bit of the FUNC_SRC1 register, and the device is ready to recognize the next event. If latched mode is enabled but the interrupt signal is not driven to the interrupt pins, the interrupt signal observed on the SIGN_MOTION_IA bit of the FUNC_SRC1 register is pulsed, with a fixed duration of 1/26 Hz.

The embedded function register (accessible by setting the FUNC_CFG_EN bit of FUNC_CFG_ACCESS to 1) used to configure the significant motion threshold parameter is the SM_THS register. The SM_THS_[7:0] bits of this register define the threshold value: it corresponds to the number of steps to be performed by the user upon a change of location before the significant motion interrupt is generated. It is expressed as an 8-bit unsigned value: the default value of this field is equal to 6 (= 00000110b).

When the debounce functionality of the pedometer is active (see Section 6.1 Pedometer functions: step detector and step counter for details), the significant motion threshold is effective only if its value, corresponding to the value of the SM_THS_[7:0] bits of the SM_THS register, is equal to or greater than the pedometer debounce threshold (corresponding to the value of the DEB_STEP[2:0] bits of the PEDO_DEB_REG register).

Basically, three different scenarios are possible for the significant motion threshold value:

- **a.** If the pedometer debounce functionality is not active, the significant motion threshold value is defined by the SM_THS_[7:0] bits;
- **b.** If the pedometer debounce functionality is active and the significant motion threshold value is equal to or greater than the pedometer debounce value, the effective significant motion threshold value is defined by the SM_THS_[7:0] bits;
- **c.** If the pedometer debounce functionality is active and the significant motion threshold value is lower than the pedometer debounce value, the effective significant motion threshold value is defined by the DEB_STEP[2:0] bits.

Note: In case c), if the desired significant motion threshold is lower than the default value, the value of the DEB_STEP[2:0] bits of the PEDO_DEB_REG register has to be decreased accordingly. Note that an excessive reduction of the pedometer debounce threshold can cause the pedometer to report false step detections!

A basic SW routine which shows how to enable significant motion detection is as follows:

1.	Write 80h to FUNC_CFG_ACCESS	// Enable access to embedded functions registers (bank A)
2.	Write 08h to SM_THS	// Set significant motion threshold
3.	Write 00h to FUNC_CFG_ACCESS	// Disable access to embedded functions registers (bank A)
4.	Write 20h to CTRL1_XL	// Turn on the accelerometer
		// ODR_XL = 26 Hz, FS_XL = $\pm 2 g$
5.	Write 05h to CTRL10_C	// Enable embedded functions
		// Enable significant motion detection
6.	Write 40h to INT1_CTRL	// Significant motion interrupt driven to INT1 pin

In this example the SM_THS_[7:0] bits of the SM_THS register are set to 00001000b, therefore the significant motion threshold is equal to 8.

6.3 Relative tilt

The tilt function allows detecting when an activity change occurs (e.g. when phone is in a front pocket and the user goes from sitting to standing or from standing to sitting): in the LSM6DS3TR-C device it has been implemented in hardware using only the accelerometer.

In order to enable the tilt detector it is necessary to set to 1 both the FUNC_EN and the TILT_EN bits of the CTRL10_C register.

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If the device is configured for tilt event detection, an interrupt is generated when the device is tilted by an angle greater than 35 degrees from the start position. The start position is defined as the position of the device when the tilt detection is enabled or the position of the device when the last tilt interrupt was generated.

After this function is enabled, for the generation of the first tilt interrupt the device should be continuously tilted by an angle greater than 35 degrees from the start position for a period of time of 2 seconds. After the first tilt interrupt is generated, the tilt interrupt signal is set high as soon as the device is tilted by an angle greater than 35 degrees from the position of the device corresponding to the last interrupt detection (no need to wait 2 seconds).

In the example shown in Figure 21. Tilt example tilt detection is enabled when the device orientation corresponds to "start position #0": the first interrupt is generated if the device is rotated by an angle greater than 35 degrees from the start position and remains in the blue zone for a period of time of at least 2 seconds. After the first tilt detection interrupt is generated, the new start position (#1) corresponds to the position of the device when the previous interrupt was generated (final position #0), and the next interrupt signal will be generated as soon as the device is tilted by an angle greater than 35 degrees, entering the blue zone surrounding the start position #1.

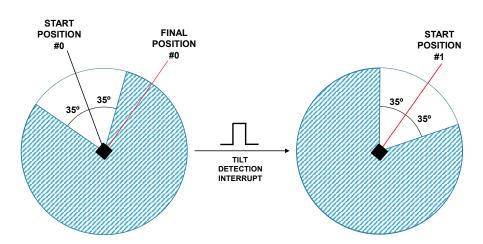


Figure 21. Tilt example

This interrupt signal can be driven to the two interrupt pins by setting to 1 the INT1_TILT bit of the MD1_CFG register or the INT2_TILT bit of the MD2_CFG register; it can also be checked by reading the TILT_IA bit of the FUNC SRC1 register.

If latched mode is disabled (LIR bit of TAP_CFG is set to 0), the interrupt signal generated by the tilt function is pulsed: the duration of the pulse observed on the interrupt pins is about 75 μ s; the duration of the pulse observed on the TILT_IA bit of FUNC_SRC1 register is 1/26 Hz.

If latched mode is enabled (LIR bit of TAP_CFG is set to 1) and the interrupt signal is driven to the interrupt pins, once a tilt is detected, a reading of the FUNC_SRC1 register clears the request on both the pins and the TILT_IA bit of FUNC_SRC1 register, and the device is ready to recognize the next tilt event. If latched mode is enabled but the interrupt signal is not driven to the interrupt pins, the interrupt signal observed on the TILT_IA bit of the FUNC_SRC1 register is pulsed, with a fixed duration of 1/26 Hz.

The tilt function works at 26 Hz, so the accelerometer ODR must be set at values of 26 Hz or higher. Hereafter a basic SW routine which shows how to enable the tilt detection function:

Write 20h to CTRL1_XL // Turn on the accelerometer // ODR_XL = 26 Hz, FS_XL = ±2 g
 Write 0Ch to CTRL10_C // Enable embedded functions // Enable tilt detection
 Write 02h to MD1_CFG // Tilt detector interrupt driven to INT1 pin

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6.4 Absolute wrist tilt

The LSM6DS3TR-C device implements in hardware the Absolute Wrist Tilt (AWT) function: it allows detecting when the angle between a selectable accelerometer semi-axis and the horizontal plane becomes higher than a specific user-selectable value.

The AWT function is based on the accelerometer sensor only and works at 26 Hz: in order to use it, the accelerometer ODR must be set at a value of 26 Hz or higher.

It is possible to enable the AWT function by setting the FUNC_EN and the WRIST_TILT_EN bits of the CTRL10_C register to 1.

If the device is configured for absolute wrist tilt event detection, an interrupt is generated when the device is tilted by an angle greater than a configurable threshold for a minimum configurable time: the AWT interrupt signal is generated if the tilt angle is higher than the threshold angle for a period of time equal to or higher than the latency period.

By default, the AWT interrupt is applied to the positive X-axis. It can be driven to the INT2 interrupt pin by setting the INT2_WRIST_TILT bit of the DRDY_PULSE_CFG register to 1 and it can be also checked by reading the WRIST_TILT_IA bit of the FUNC_SRC2 register (this reading clears the interrupt signal if latched by setting the LIR bit of the register TAP_CFG to 1).

If latched mode is disabled (LIR bit of TAP_CFG is set to 0), the interrupt signal generated by the AWT function is pulsed: the duration of the pulse observed on the interrupt pins is about 75 μ s; the duration of the pulse observed on the WRIST TILT IA bit of the FUNC SRC2 register is 1/26 Hz.

If latched mode is enabled (LIR bit of TAP_CFG is set to 1) and the interrupt signal is driven to the interrupt pins, once a wrist tilt is detected, a reading of the FUNC_SRC2 register clears the request on both the pins and the WRIST_TILT_IA bit of FUNC_SRC2 register, and the device is ready to recognize the next wrist tilt event. If latched mode is enabled but the interrupt signal is not driven to the interrupt pins, the interrupt signal observed on the WRIST_TILT_IA bit of the FUNC_SRC2 register is pulsed, with a fixed duration of 1/26 Hz.

A basic routine to enable the default configuration of AWT function is as follows:

1.	Write 20h to CTRL1_XL	// Turn on the accelerometer
		// ODR_XL = 26 Hz, FS_XL = $\pm 2 g$
2.	Write 84h to CTRL10_C	// Enable embedded functions
		// Enable AWT detection
3.	Write 01h to DRDY_PULSE_CFG	// AWT interrupt driven to the INT2 pin

It is possible to tune the latency value, the threshold and the axes mask through the three related embedded functions registers (bank B): A_WRIST_TILT_LAT, A_WRIST_TILT_THS and A_WRIST_TILT_Mask.

The latency parameter can be modified through the embedded register A_WRIST_TILT_LAT by setting the WRIST_TILT_TIMER field: 1 LSB = 40 ms and the default value is 0Fh, which means 600 ms.

The threshold parameter can be configured through the embedded functions register A_WRIST_TILT_THS by setting the WRIST_TILT_THS field. It is full-scale independent. 1 LSB corresponds to 15.625 mg and the WRIST_TILT_THS field must be < 40h (64d). The tilt angle with respect to the horizontal plane can be calculated as follows:

$$angle[deg] = \frac{180}{\pi} * asin \frac{WRIST_TILT_THS}{64}$$

The default value of register 54h is 20h = 32d = 500 mg, corresponding to a tilt angle of 30 degrees.

The user can select the axes to be considered by the AWT algorithm by configuring the bits WRIST_TILT_MASK_Xpos, WRIST_TILT_MASK_Xneg, WRIST_TILT_MASK_Ypos, WRIST_TILT_MASK_Ypos, WRIST_TILT_MASK_Ypos, WRIST_TILT_MASK_Zpos, WRIST_TILT_MASK_Zneg of the embedded register A_WRIST_TILT_Mask; the default configuration is X-positive axis AWT detection. Another or additional semi-axes can be selected in order to change/modify the AWT detection: the OR combination of these bits is applied.

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Note: These embedded functions registers (bank B) are reset to their default value every time the accelerometer exits Power-Down mode, so they have to be reconfigured every time the power mode is switched from Power-Down to an active mode.

The complete AWT configuration procedure, to be repeated when the accelerometer exits from Power-Down mode, is the following:

1. Write 20h to CTRL1_XL	// Turn on the accelerometer // ODR_XL = 26 Hz, FS_XL = ±2 g
2. Write 04h to CTRL10_C	// Enable embedded functions
3. Wait 50 ms	
4. Write 00h to CTRL10_C	// Disable embedded functions
5. Write A0h to FUNC_CFG_ACCESS	// Enable access to embedded registers (bank B)
6. Set new latency in A_WRIST_TILT_LAT	
7. Set new threshold in A_WRIST_TILT_THS	
8. Set new mask in A_WRIST_TILT_Mask	
9. Write 00h to FUNC_CFG_ACCESS	// Disable access to embedded registers (bank B)
10. Write 84h to CTRL10_C	// Enable embedded functions
	// Enable AWT detection
11. Write 01h to DRDY_PULSE_CFG	// AWT interrupt driven to the INT2 pin

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6.5 Timestamp

Together with sensor data the LSM6DS3TR-C device can provide timestamp information.

If both the accelerometer and the gyroscope are in Power-Down mode, the timestamp counter does not work. To enable this functionality the TIMER_EN bit of the CTRL10_C register has to be set to 1: the time step count is given by the concatenation of the TIMESTAMP_REG2 & TIMESTAMP_REG1 & TIMESTAMP_REG0 registers and is represented as a 24-bit unsigned number.

The timestamp resolution can be configured using the TIMER_HR bit of the WAKE_UP_DUR register: when this bit is set to 0, 1 LSB of the time step count corresponds to 6.4 ms (low-resolution mode); when this bit is set to 1, 1 LSB of the time step count corresponds to 25 μ s (high-resolution mode).

When the maximum value 16777215 LSB (corresponding to FFFFFFh) is reached, the counter is automatically reset to 000000h and continues to count. The timer count can be reset to zero at any time by writing the reset value AAh in the TIMESTAMP REG2 register.

An interrupt is generated around 1.638 seconds before timer saturation in both high-resolution mode (when the timer step count reaches the value FF0000h) and low-resolution mode (when the timer step count reaches the value FFF00h). This interrupt signal can be driven to the INT1 pin by setting the INT1_TIMER bit of the MD1_CFG register to 1. Once the interrupt pin is asserted, it must be reset to 0 by writing AAh in the TIMESTAMP_REG2 register (the timer step count will also be reset).

The timestamp count can be stored in FIFO as a fourth data set along with the step counter data (see Section 8.8 Step counter and timestamp data in FIFO for details).

The timestamp resolution has to be set before enabling the timestamp functionality; a basic SW routine is as follows:

```
    Write 50h to CTRL1_XL  // Turn on the accelerometer  // ODR_XL = 208 Hz, FS_XL = ±2 g
    Write 10h to WAKE_UP_DUR  // Timestamp resolution = 25 µs
    Write 20h to CTRL10_C  // Enable timestamp count
    Write 01h to MD1_CFG  // End counter interrupt driven to INT1 pin
```

When switching from a low timestamp resolution to a high resolution, the timer count must be reset as indicated in the example below:

```
1.
        Write 50h to CTRL1 XL
                                                             // Turn on the accelerometer
                                                             // ODR_XL = 208 Hz, FS_XL = \pm 2 g
2
        Write 00h to WAKE UP DUR
                                                             // Timestamp resolution = 6.4 ms
3.
        Write 20h to CTRL10_C
                                                             // Enable timestamp count
Ν
        Write 10h to WAKE UP DUR
                                                             // Timestamp resolution = 25 µs
N+1
        Write AAh to TIMESTAMP_REG2
                                                             // Reset timer counter
```

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7 Mode 2 - Sensor hub mode

The hardware flexibility of the LSM6DS3TR-C allows connecting the pins with different mode connections to external sensors to expand functionalities such as adding a sensor hub. When sensor hub mode (Mode 2) is enabled, both the primary I²C/SPI (3- and 4-wire) slave interface and the I²C master interface for the connection of external sensors are available. Mode 2 connection mode is described in detail in the following paragraphs.

7.1 Sensor hub mode description

In sensor hub mode (Mode 2) up to 4 external sensors can be connected to the I²C master interface of the LSM6DS3TR-C device. The sensor hub trigger signal can be synchronized with the accelerometer data-ready signal (up to 104 Hz); alternatively, an external signal connected to the INT2 pin can be used as the sensor hub trigger. In this second case, the maximum ODR supported for external sensors depends on the number of read / write operations that can be executed between two consecutive trigger signals.

On the sensor hub trigger signal, all the write and read I²C operations configured through the registers SLVx_ADD, SLVx_SUBADD, SLAVEx_CONFIG and DATAWRITE_SRC_MODE_SUB_SLV0 are performed sequentially from external sensor 0 to external sensor 3 (depending on the external sensors enabled through the Aux sens on[1:0] field in the SLAVE0 CONFIG register).

External sensor data can also be stored in FIFO with a configurable decimation factor (see Section 8 First-in first-out (FIFO) buffer for details).

If both the accelerometer and the gyroscope are in Power-Down mode, the sensor hub does not work.

All external sensors have to be connected in parallel to the SDx/SCx pins of the device, as illustrated in Figure 22. External sensor connections in Mode 2 for a single external sensor.

External pull-up resistors and the external trigger signal connection are optional and depend on the configuration of the registers.

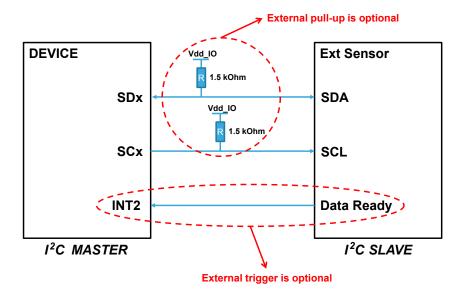


Figure 22. External sensor connections in Mode 2

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7.2 Sensor hub mode registers

In order to enable the embedded functionalities of the LSM6DS3TR-C, the FUNC_EN bit of the CTRL10_C register has to be set to 1; after enabling the embedded functionalities, the MASTER_CONFIG register has to be used for the configuration of the I^2C master interface.

A set of registers SLVx_ADD, SLVx_SUBADD, SLAVEx_CONFIG is dedicated to the configuration of the 4 slave interfaces associated to the 4 connectable external sensors. An additional register,

DATAWRITE_SRC_MODE_SUB_SLV0, is associated to slave #0 only: it can be used to implement the writing and the source mode conditioned reading of the registers of the external sensor associated to slave #0.

Finally, 18 registers (from SENSORHUB1_REG to SENSORHUB18_REG) are available to store the data read from the external sensors.

7.2.1 CTRL10_C (19h)

Table 31. CTRL10_C register

b7	b6	b5	b4	b3	b2	b1	b0
Х	0	X	X	х	FUNC _EN	х	Х

 FUNC_EN must be set to 1 in order to enable the embedded functionalities of the LSM6DS3TR-C (pedometer, tilt, significant motion, ironing).

7.2.2 MASTER_CONFIG (1Ah)

This register is used to configure the I²C master interface.

Table 32. MASTER_CONFIG register

b7	b6	b5	b4	b3	b2	b1	b0
DRDY_ ON_INT1	X	0	START _ CONFIG	PULL_ UP_EN	PASS_ THROUGH _MODE	Х	MASTER _ON

DRDY_ON_INT1 bit has to be set to 1 to drive the I²C master Data-Ready signal on the INT1 pin
 (corresponding to the behavior of the SENSORHUB_END_OP bit of the FUNC_SRC1 register). Please refer
 to Section 7.2.3 FUNC_SRC1 (53h) for more details about the SENSORHUB_END_OP bit. If the
 DRDY_PULSED bit of the DRDY_PULSE_CFG register is set to 1, the I²C master data-ready signal is
 pulsed with a duration of 150 μs.

The START CONFIG bit selects the sensor hub trigger signal.

- When this bit is set to 0, the accelerometer sensor has to be active (not in Power-Down mode) and the sensor hub trigger signal is the accelerometer data-ready signal, with a frequency corresponding to the accelerometer ODR up to 104 Hz.
- When this bit is set to 1, at least one sensor between the accelerometer and the gyroscope has to be active and the sensor hub trigger signal is the INT2 pin; in fact, when both the MASTER_ON bit and START_CONFIG bit are set to 1, the INT2 pin is configured as an input signal. In this case, the INT2 pin has to be connected to the data-ready pin of the external sensor (Figure 22. External sensor connections in Mode 2) in order to trigger the reading/writing operations on the external sensor registers. The sensor hub interrupt from INT2 is 'high-level triggered' (not programmable).

Note: In case of external trigger signal usage (START_CONFIG=1), if the INT2 pin is connected to the Data-Ready pin of the external sensor (Figure 22. External sensor connections in Mode 2) and the latter is in Power-Down mode, then no data-ready signal can be generated by the external sensor. For this reason, the initial

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configuration of the external sensor's register has to be performed using the internal trigger signal (START_CONFIG=0). After the external sensor is activated and the data-ready signal is available, the external trigger signal can be used by switching the START_CONFIG bit to 1.

- PULL_UP_EN bit enables/disables the internal pull-up on the auxiliary I²C line. When this bit is set to 0, the internal pull-up is disabled and the external pull-up resistors on the SDx/SCx pins are required, as shown in Figure 22. External sensor connections in Mode 2. When this bit is set to 1, the internal pull-up is enabled and the external pull-up resistors on the SDx/SCx pins are not required.
- PASS_THROUGH_MODE bit is used to enable/disable the I²C interface pass-through. When this bit is set
 to 1, the main I²C line (e.g. connected to an external microcontroller) is short-circuited with the auxiliary one
 in order to implement a direct access to the external sensor registers. See Section 7.3 Sensor hub passthrough feature for details.
- MASTER_ON bit has to be set to 1 to enable the auxiliary I²C master of the LSM6DS3TR-C device (sensor hub mode).

7.2.3 FUNC_SRC1 (53h)

Table 33. FUNC_SRC1 register

b7	b6	b5	b4	b3	b2	b1	b0
							SENSOR
X	X	X	X	X	X	X	HUB_
							END_OP

SENSORHUB_END_OP bit reports the status of the I²C master: during the idle state of the I²C master, this
bit is equal to 1; it goes to 0 during I²C master read/write operations. When a sensor hub routine is
completed, this bit automatically goes to 1 and the external sensor data are available to be read from the
SENSORHUBX_REG registers (depending on the configuration of the SLVx_ADD, SLVx_SUBADD,
SLAVEX_CONFIG registers).

Note: The SENSORHUB_END_OP bit is cleared by reading the FUNC_SRC1 register if the LIR bit in the TAP_CFG register is set to 1, otherwise it is cleared only during an I²C master read or write operation. Information about the status of the I²C master can be driven to the INT1 interrupt pin by setting the DRDY_ON_INT1 bit of the MASTER_CONFIG register to 1: if the LIR bit of the TAP_CFG register is set to 0, a pulsed interrupt signal (with typical pulse duration of about 150 µs) is generated at the rising edge of the SENSORHUB_END_OP signal. If latched mode is enabled (LIR bit is set to 1) and the interrupt signal is driven to the interrupt pin INT1, this interrupt signal is cleared by reading the FUNC_SRC1 register.

7.2.4 FUNC_SRC2 (54h)

Table 34. FUNC_SRC2 register

b7	b6	b5	b4	b3	b2	b1	b0
0	SLAVE3_	SLAVE2	SLAVE1	SLAVE0	V	0	V
0	_NACK	_NACK	_NACK	_NACK	^	U	^

 SLAVEx_NACK bits are set to 1 if a "not acknowledge" event happens during the communication with the corresponding slave x.

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7.2.5 SLV0_ADD (02h), SLV0_SUBADD (03h), SLAVE0_CONFIG (04h)

The embedded function registers (accessible when the FUNC_CFG_EN bit is set to 1 and the FUNC_CFG_EN_B bit is set to 0 in FUNC_CFG_ACCESS register) used to configure the I²C slave interface associated to the first external sensor are described hereafter.

Table 35. SLV0 ADD register

b7	b6	b5	b4	b3	b2	b1	b0
Slave0 _add6	Slave0 _add5	Slave0 _add4	Slave0 _add3	Slave0 _add2	Slave0 _add1	Slave0 _add0	rw_0

- Slave0 add[6:0] bits are used to indicate the I²C slave address of the first external sensor.
- rw_0 bit configures the read/write operation to be performed on the first external sensor (0: write operation;
 1: read operation). The read/write operation is executed when the next sensor hub trigger event occurs.
 When the rw_0 bit is set to 0 (write operation selected), the content of the SENSORHUBx_REG registers is not updated.

Table 36. SLV0_SUBADD register

b7	b6	b5	b4	b3	b2	b1	b0
Slave0 _reg7	Slave0 _reg6	Slave0 _reg5	Slave0 _reg4	Slave0 _reg3	Slave0 _reg2	Slave0 _reg1	Slave0 _reg0

• Slave0_reg[7:0] bits are used to indicate the address of the register of the first external sensor to be written (if the rw_0 bit of the SLV0_ADD register is set to 0) or the address of the first register to be read (if the rw_0 bit is set to 1).

Table 37. SLAVE0_CONFIG register

b7	b6	b5	b4	b3	b2	b1	b0
Slaven rate1	Slaven raten	Aux_sens	Aux_sens	Src	Slave0 numop2	Slave0 numop1	Slave0 numop0
Slave0 _rate1	Slave0 _rate0	_on1	_on0	_mode	Slaveo _numopz	Slaveo _numopi	Slaveo _numopo

- Slave0_rate[1:0] bits are used to define the decimation factor applied to read operations on the first external sensor starting from the sensor hub trigger:
 - 00: no decimation
 - 01: update every 2 sensor hub trigger events
 - 10: update every 4 sensor hub trigger events
 - 11: update every 8 sensor hub trigger events
- Aux_sens_on[1:0] bits have to be used to indicate the number of external sensors to be managed by the sensor hub:
 - 00: one external sensor
 - 01: two external sensors
 - 10: three external sensors
 - 11: four external sensors
- Src_mode bit enables/disables source mode conditioned reading. When this bit is set to 1, source mode conditioned reading is enabled; before proceeding with the reading of the register address indicated in the SLV0_SUBADD register, the content of the register at the address specified in

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- DATAWRITE_SRC_MODE_SUB_SLV0 is checked: if the content is non-zero the operation continues, else the reading operation is interrupted. Source mode conditioned reading is available on slave 0 only.
- Slave0_numop[2:0] bits are dedicated to define the number of consecutive read operations to be performed
 on the first external sensor starting from the register address indicated in the SLV0_SUBADD register.

7.2.6 SLV1_ADD (05h), SLV1_SUBADD (06h), SLAVE1_CONFIG (07h)

The embedded function registers (accessible when the FUNC_CFG_EN bit is set to 1 and the FUNC_CFG_EN_B bit is set to 0 in FUNC_CFG_ACCESS register) used to configure the I²C slave interface associated to the second external sensor are described hereafter.

Table 38. SLV1 ADD register

b7	b6	b5	b4	b3	b2	b1	b0
Slave1 _add6	Slave1 _add5	Slave1 _add4	Slave1 _add3	Slave1 _add2	Slave1 _add1	Slave1 _add0	r_1

- Slave1 add[6:0] bits are used to indicate the I²C slave address of the second external sensor.
- r_1 bit enables/disables the read operation to be performed on the second external sensor (0: read operation disabled; 1: read operation enabled). The read operation is executed when the next sensor hub trigger event occurs.

Table 39. SLV1_SUBADD register

b7	b6	b5	b4	b3	b2	b1	b0
Slave1_reg7	Slave1 _reg6	Slave1 _reg5	Slave1 _reg4	Slave1 _reg3	Slave1 _reg2	Slave1 _reg1	Slave1 _reg0

• Slave1_reg[7:0] bits are used to indicate the address of the register of the second external sensor to be read when the r_1 bit of SLV1_ADD register is set to 1.

Table 40. SLAVE1_CONFIG register

b7	b6	b5	b4	b3	b2	b1	b0
Slavo1 rato1	Slave1 rate0	write	0	0	Slave1	Slave1	Slave1
Slave1 _rate1	Slave1 _rate0	_once	0	U	_numop2	_numop1	_numop0

- Slave1_rate[1:0] bits are used to define the decimation factor applied to read operations on the second external sensor starting from the sensor hub trigger:
 - 00: no decimation
 - 01: update every 2 sensor hub trigger events
 - 10: update every 4 sensor hub trigger events
 - 11: update every 8 sensor hub trigger events
- write_once bit is used to limit the write operations on slave 0 to only one occurrence (avoiding to repeat the same write operation multiple times). If this bit is not asserted, a write operation is triggered at each ODR.

Note: In order to enable the write_once feature, the field Aux_sens_on in the SLAVEO_CONFIG register must be different than 00b (even if only slave 0 is used).

• Slave1_numop[2:0] bits are dedicated to define the number of consecutive read operations to be performed on the second external sensor starting from the register address indicated in the SLV1_SUBADD register.

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7.2.7 SLV2_ADD (08h), SLV2_SUBADD (09h), SLAVE2_CONFIG (0Ah)

The embedded function registers (accessible when the FUNC_CFG_EN bit is set to 1 and the FUNC_CFG_EN_B bit is set to 0 in the FUNC_CFG_ACCESS register) used to configure the I²C slave interface associated to the third external sensor are described hereafter.

Table 41. SLV2 ADD register

b7	b6	b5	b4	b3	b2	b1	b0
Slave2 _add6	Slave2 _add5	Slave2 _add4	Slave2 _add3	Slave2 _add2	Slave2 _add1	Slave2 _add0	r_2

- Slave2 add[6:0] bits are used to indicate the I²C slave address of the third external sensor.
- r_2 bit enables/disables the read operation to be performed on the third external sensor (0: read operation disabled; 1: read operation enabled). The read operation is executed when the next sensor hub trigger event occurs.

Table 42. SLV2_SUBADD register

b7	b6	b5	b4	b3	b2	b1	b0
Slave2 _reg7	Slave2 _reg6	Slave2 _reg5	Slave2 _reg4	Slave2 _reg3	Slave2 _reg2	Slave2 _reg1	Slave2 _reg0

• Slave2_reg[7:0] bits are used to indicate the address of the register of the third external sensor to be read when the r_2 bit of the SLV2_ADD register is set to 1.

Table 43. SLAVE2_CONFIG register

b7	b6	b5	b4	b3	b2	b1	b0
Slave2 _rate1	Slave2 _rate0	0	0	0	Slave2 _numop2	Slave2 _numop1	Slave2 _numop0

- Slave2_rate[1:0] bits are used to define the decimation factor applied to read operations on the third external sensor starting from the sensor hub trigger:
 - 00: no decimation
 - 01: update every 2 sensor hub trigger events
 - 10: update every 4 sensor hub trigger events
 - 11: update every 8 sensor hub trigger events
- Slave2_numop[2:0] bits are dedicated to define the number of consecutive read operations to be performed
 on the third external sensor starting from the register address indicated in the SLV2_SUBADD register.

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7.2.8 SLV3_ADD (0Bh), SLV3_SUBADD (0Ch), SLAVE3_CONFIG (0Dh)

The embedded function registers (accessible when the FUNC_CFG_EN bit is set to 1 and the FUNC_CFG_EN_B bit is set to 0 in the FUNC_CFG_ACCESS register) used to configure the I²C slave interface associated to the fourth external sensor are described hereafter.

Table 44. SLV3 ADD register

b7	b6	b5	b4	b3	b2	b1	b0
Slave3 _add6	Slave3 _add5	Slave3 _add4	Slave3 _add3	Slave3 _add2	Slave3 _add1	Slave3 _add0	r_3

- Slave3 add[6:0] bits are used to indicate the I²C slave address of the fourth external sensor.
- r_3 bit enables/disables the read operation to be performed on the fourth external sensor (0: read operation disabled; 1: read operation enabled). The read operation is executed when the next sensor hub trigger event occurs.

Table 45. SLV3_SUBADD register

	b7	b6	b5	b4	b3	b2	b1	b0
S	slave3 _reg7	Slave3 _reg6	Slave3 _reg5	Slave3 _reg4	Slave3 _reg3	Slave3 _reg2	Slave3 _reg1	Slave3 _reg0

• Slave3_reg[7:0] bits are used to indicate the address of the register of the fourth external sensor to be read when the r_3 bit of the SLV3_ADD register is set to 1.

Table 46. SLAVE3_CONFIG register

b7	b6	b5	b4	b3	b2	b1	b0
Slave3 _rate1	Slave3 _rate0	0	0	0	Slave3 _numop2	Slave3 _numop1	Slave3 _numop0

- Slave3_rate[1:0] bits are used to define the decimation factor applied to the read operations on the fourth external sensor starting from the sensor hub trigger:
 - 00: no decimation
 - 01: update every 2 sensor hub trigger events
 - 10: update every 4 sensor hub trigger events
 - 11: update every 8 sensor hub trigger events
- Slave3_numop[2:0] bits are dedicated to define the number of consecutive read operations to be performed on the fourth external sensor starting from the register address indicated in the SLV3_SUBADD register.

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7.2.9 DATAWRITE_SRC_MODE_SUB_SLV0 (0Eh)

Table 47. DATAWRITE_SRC_MODE_SUB_SLV0 register

b7	b6	b5	b4	b3	b2	b1	b0
Slave							
_dataw7	_dataw6	_dataw5	_dataw4	_dataw3	_dataw2	_dataw1	_dataw0

• Slave_dataw[7:0] bits are dedicated, when the rw_0 bit of SLV0_ADD register is set to 0 (write operation), to indicate the data to be written to the first external sensor at the address specified in the SLV0_SUBADD register. During read operations (rw_0 = 1), this register is used if the source mode conditioned reading is enabled (Src_mode bit = 1 in the SLAVE0_CONFIG register) and it indicates the address of the external sensor register to be checked before proceeding with the read operation.

7.2.10 SENSORHUBx_REG registers

Once the auxiliary I^2C master is enabled, for each of the external sensors it reads a number of registers equal to the value of the Slavex_numop (x = 0, 1, 2, 3) field, starting from the register address specified in the SLVx_SUBADD (x = 0, 1, 2, 3) register. The number of external sensors to be managed is specified in the Aux sens on bits of the SLAVEO_CONFIG register.

Read data are consecutively stored (in the same order they are read) in the LSM6DS3TR-C registers starting from the SENSORHUB1_REG register, as in the example in Figure 23. SENSORHUBx_REG allocation example; 18 registers, from SENSORHUB1_REG to SENSORHUB18_REG, are available to store the data read from the external sensors.

The values of the registers from SENSORHUB1_REG to SENSORHUB6_REG can be saved in the FIFO buffer as a third data set; the values of the registers from SENSORHUB7_REG to SENSORHUB12_REG can be saved in the FIFO buffer as a fourth data set (see Section 8 First-in first-out (FIFO) buffer for details).

Figure 23. SENSORHUBx_REG allocation example

		SENSORHUB1_REG	Value of reg 28h]
		SENSORHUB2_REG	Value of reg 29h	Sensor #1
		SENSORHUB3_REG	Value of reg 2Ah	
Sensor #1	SLV0_SUBADD(03h) = 28h SLAVE0_CONFIG(04h) - Slave0_numop[2:0] = 3	SENSORHUB4_REG	Value of reg 00h]
Sensor #1		SENSORHUB5_REG	Value of reg 01h	
		SENSORHUB6_REG	Value of reg 02h	Sensor #2
	SLV1_SUBADD(06h) = 00h SLAVE1_CONFIG(07h) - Slave1_numop[2:0] = 6	SENSORHUB7_REG	Value of reg 03h	3611301 #2
Sensor #2		SENSORHUB8_REG	Value of reg 04h	
		SENSORHUB9_REG	Value of reg 05h	<u> </u>
	SLV2_SUBADD(09h) = 20h SLAVE2_CONFIG(0Ah) - Slave2_numop[2:0] = 4	SENSORHUB10_REG	Value of reg 20h	
Sensor #3		SENSORHUB11_REG	Value of reg 21h	Sensor #3
		SENSORHUB12_REG	Value of reg 22h	ochisor #o
		SENSORHUB13_REG	Value of reg 23h	
Sensor #4	SLV3_SUBADD(0Ch) = 40h SLAVE3_CONFIG(0Dh) - Slave3_numop[2:0] = 5	SENSORHUB14_REG	Value of reg 40h	Ī
Sensor #4		SENSORHUB15_REG	Value of reg 41h	
		SENSORHUB16_REG	Value of reg 42h	Sensor #4
		SENSORHUB17_REG	Value of reg 43h	
		SENSORHUB18_REG	Value of reg 44h	

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7.3 Sensor hub pass-through feature

The PASS_THROUGH_MODE bit of the MASTER_CONFIG register is used to enable/disable the I^2C interface pass-through: when it is set to 1, the main I^2C line (e.g. connected to an external microcontroller) is short-circuited with the auxiliary one in order to implement a direct access to the external sensor registers. It is recommended to use this feature when configuring the external sensors.

DEVICE Vdd_IO **Ext Sensor** MCU Vdd IO 10 kOhm 1.5 kOhm SDA SDx **SDA SDA** Vdd_IO Vdd_IO R 10 kOhm 1.5 kOhm SCL SCx SCL SCL PASS_THROUGH_MODE bit INT2

Figure 24. Pass-through feature

Some limitations must be considered when using the sensor hub and the pass-through feature. Three different scenarios are possible:

- 1. The sensor hub is used with the START_CONFIG bit of the MASTER_CONFIG register set to 0 (internal trigger) and the pass-through feature is not used: there is no limitation on INT2 pin usage.
- 2. The sensor hub is used with the START_CONFIG bit of the MASTER_CONFIG register set to 0 (internal trigger) and the pass-through feature is used: the INT2 pin must be connected to GND; it is not possible to switch to external trigger configuration (by setting the START_CONFIG bit to 1) and the INT2 pin cannot be used for the digital interrupts. Specific procedures have to be applied to enable/disable the pass-through feature: they are described in Section 7.3.1 Pass-through feature enable and in Section 7.3.2 Pass-through feature disable.
- 3. The sensor hub is used with the START_CONFIG bit of the MASTER_CONFIG register set to 1 (external trigger): the pass-through feature cannot be used; the INT2 pin has to be connected to the data-ready pin of the external sensor (trigger signal) and the procedure below has to be executed to avoid conflicts with the INT2 line:
 - Set either the TRIG_EN or LVL1_EN or LVL2_EN bit of the CTRL6_C register to 1 (to configure the INT2 pin as input pin);
 - b. Configure the external sensors (do not use the pass-through);
 - c. Configure the sensor hub SLAVEx registers;
 - d. Set the START CONFIG bit of the MASTER CONFIG register to 1;
 - e. Set the MASTER_ON bit of the MASTER_CONFIG register to 1;
 - Reset to 0 the bit in the CTRL6_C register asserted in step a.

Examples of external sensor configurations without using the pass-through are given in Section 7.4 Sensor hub mode example and Section 7.5.4 Ironing example.

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7.3.1 Pass-through feature enable

When the embedded sensor hub functionality is disabled, the pass-through feature can be enabled at any time by setting the PASS_THROUGH_MODE bit of the MASTER_CONFIG register to 1.

When the embedded sensor hub functionality is enabled, a specific procedure has to be followed to enable the pass-through feature in order to prevent I²C bus arbitration loss:

- Set the START_CONFIG bit of the MASTER_CONFIG register to 1 in order to disable the sensor hub trigger (external trigger is enabled, but no trigger can be received on the INT2 pin since it's connected to GND);
- 2. Wait at least 5 ms (running I²C operations will be completed);
- Set the MASTER_ON bit of the MASTER_CONFIG register to 0 in order to disable the embedded sensor hub;
- 4. Set the START_CONFIG bit of the MASTER_CONFIG register to 0 in order to restore the sensor hub trigger;
- 5. Set the PULL UP EN bit of the MASTER CONFIG register to 0 in order to disable the I²C master pull-up;
- 6. Set the PASS_THROUGH_MODE bit of the MASTER_CONFIG register to 1 in order to enable the pass-through feature.

7.3.2 Pass-through feature disable

The procedure below has to be used in order to disable the pass-through:

- 1. Wait for the external microcontroller connected to the main I²C line to complete all running I²C operations. The pass-through must not be disabled in the middle of an I²C transaction;
- 2. Set the PASS THROUGH MODE bit of the MASTER CONFIG register to 0.

At this point, the internal I^2C master pull-up can be restored by setting the PULL_UP_EN bit of the MASTER_CONFIG register to 1, and the auxiliary I^2C master can be enabled by setting the MASTER_ON bit of the MASTER_CONFIG register to 1.

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7.4 Sensor hub mode example

The configuration of the external sensors should be performed using the pass-through feature: this feature can be enabled by setting the PASS_THROUGH_MODE bit of the MASTER_CONFIG register to 1 and implements a direct access to the external sensor registers, allowing quick configuration.

The code provided below gives a basic routine to configure the LSM6DS3TR-C in sensor hub mode. Furthermore, this sequence configures the LIS2MDL external magnetometer sensor (refer to the datasheet for additional details) in continuous mode and reads the magnetometer output registers, saving their values in the SENSORHUB1 REG to SENSORHUB6 REG registers. The pass-through feature is not used in this example.

1.	Write 80h to FUNC_CFG_ACCESS	// Enable access to embedded functions registers (bank A)
2.	Write 3Ch to SLV0_ADD	// LIS2MDL slave address = 0011110b
		// Enable write operation (rw_0=0)
3.	Write 60h to SLV0_SUBADD	// 60h is the LIS2MDL register to be written
4.	Write 8Ch to DATAWRITE_SRC_MODE_SUB_SLV0	// 8Ch is the value to be written in register 60h of
		// LIS2MDL to configure it in continuous mode,
		// ODR = 100 Hz, temperature compensation enabled
5.	Write 10h to SLAVE0_CONFIG	// Set Aux_sens_on bits different from 00b
6.	Write 20h to SLAVE1_CONFIG	// Enable write_once bit
7.	Write 00h to FUNC_CFG_ACCESS	// Disable access to embedded functions registers (bank A)
8.	Write 04h to CTRL10_C	// Enable embedded functions
9.	Write 09h to MASTER_CONFIG	// Enable internal pull-up on SDx/SCx lines
		// Sensor hub trigger signal is XL Data-Ready
		// Enable auxiliary I ² C master
10.	Write 80h to CTRL1_XL	// Turn on the accelerometer (for trigger signal)
11.	Read FUNC_SRC1	// Wait for the sensor hub communication to be concluded
12.	If SENSORHUB_END_OP = 0, go to 9	
13.	Write 00h to CTRL10_C	// Disable embedded functions
14.	Write 00h to MASTER_CONFIG	// Disable auxiliary I ² C master
15.	Write 00h to CTRL1_XL	// Turn off the accelerometer
16.	Write 80h into FUNC_CFG_ACCESS	// Enable access to embedded functions registers (bank A)
17.	Write 3Dh to SLV0_ADD	// LIS2MDL slave address = 0011110b
		// Enable read operation (rw_0=1)
18.	Write 68h to SLV0_SUBADD	// 68h is the first LIS2MDL output register to be read
19.	Write 06h to SLAVE0_CONFIG	// No decimation
		// 1 external sensor connected
		// Number of registers to read = 6
20.	Write 00h to FUNC_CFG_ACCESS	// Disable access to embedded functions registers (bank A)
21.	Write 04h to CTRL10_C	// Enable embedded functions
22.	Write 09h to MASTER_CONFIG	// Enable internal pull-up on SDx/SCx lines
		// Sensor hub trigger signal is XL Data-Ready
		// Enable auxiliary I ² C master
23.	Write 80h to CTRL1_XL	// Turn on the accelerometer (for trigger signal)

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7.5 Magnetometer hard-iron / soft-iron correction

The LSM6DS3TR-C device supports the data acquisition of an external magnetometer with soft-iron and hard-iron correction features. For this purpose, it is required to set the MASTER_ON bit of the MASTER_CONFIG register to 1 to enable the sensor hub mode, to associate the external magnetometer to slave 0 registers (SLV0_ADD, SLV0_SUBADD and SLAVE0_CONFIG) and to set the Slave0_numop field of SLAVE0_CONFIG to 6.

The FUNC_EN bit of CTRL10_C register has to be set to 1 in order to enable the embedded ironing functionalities. Then, distortion correction algorithms can be enabled as described in Table 48. Ironing configuration: the IRON_EN bit of MASTER_CONFIG and the SOFT_EN bit of CTRL9_XL are used to enable hard-iron correction only or both hard-iron and soft-iron corrections. In the latter case, both calibrated (hard-iron & soft-iron) and uncalibrated (soft-iron only) magnetometer data are available.

CTRL9_XL SOFT_EN bit	MASTER_CONFIG IRON_EN bit	Ironing configuration
0	0	No correction applied
0	1	Hard-iron only
1	1	Hard-iron + soft-iron corrections

Table 48. Ironing configuration

7.5.1 Hard-iron correction

Hard-iron distortion is normally generated by ferromagnetic material with permanent magnetic fields that are part of the object (e.g. a tablet) in use; these materials could be permanent magnets or magnetized iron or steel. They are time invariant and deform the local geomagnetic field with different offset on different directions.

Generally, if the user performs many 3D rotations of the object in an ideal environment (no hard-iron/soft-iron distortion) and plots the collected magnetic sensor raw data, the result will be a perfect sphere with no offset. The hard-iron distortion effect is to offset the sphere along the X, Y and Z axes; in the X-Y plane, the hard-iron distortion is identified by an offset of the origin of the ideal circle from (0, 0), as shown in Figure 25. Hard-iron effect (X-Y 2D scatter plot).

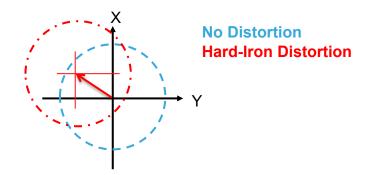


Figure 25. Hard-iron effect (X-Y 2D scatter plot)

In the LSM6DS3TR-C device, the 3x1 hard-iron vector containing the X, Y, Z magnetic offset values calculated by the user have to be indicated in dedicated registers: the MAG_OFFX_L and MAG_OFFX_H registers are dedicated to the X-axis offset, the MAG_OFFY_L and MAG_OFFY_H registers are dedicated to the Y-axis offset, the MAG_OFFZ_L and MAG_OFFZ_H registers are dedicated to the Z-axis offset. These registers values are expressed as a 16-bit word in two's complement; the sensitivity [LSB/Gauss] to be applied to calculate the hard-iron register values corresponds to that of the external magnetometer.

The hard-iron registers are accessible when the FUNC_CFG_EN bit of the FUNC_CFG_ACCESS register is set to 1. In order to enable the hard-iron correction algorithm, it is necessary to set to 1 both the FUNC_EN bit of the CTRL10_C register and the IRON_EN bit of the MASTER_CONFIG register (Table 48. Ironing configuration).

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7.5.2 Soft-iron correction

Soft-iron distortion is generated by magnetically soft materials or current carrying PCB traces. While the hard-iron distortion is constant regardless of the orientation, the soft-iron distortion changes with the orientation of the object in the Earth's field. Basically, the local geomagnetic field is deformed by different gain on different directions.

The effect of the soft-iron distortion is to make the ideal full round sphere become a tilted ellipsoid; in the X-Y plane, the soft-iron distortion is identified by a tilted ellipse with the origin in (0, 0), as shown in Figure 25. Hardinon effect (X-Y 2D scatter plot).

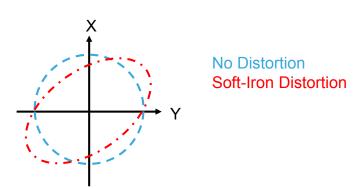


Figure 26. Soft-iron effect (X-Y 2D scatter plot)

In the LSM6DS3TR-C device, the 3x3 soft-iron transformation matrix calculated by the user has to be indicated in 9 dedicated registers: MAG_SI_XX, MAG_SI_XY, MAG_SI_XZ, MAG_SI_YX, MAG_SI_YY, MAG_SI_YZ, MAG_SI_ZX, MAG_SI_ZY, MAG_SI_ZZ. These register values are expressed as an 8-bit word in sign-magnitude format; for these registers 1 LSB corresponds to 1/8, so the matrix parameters calculated by the user must be multiplied by 8 before writing them in the soft-iron registers.

The soft-iron registers are accessible when the FUNC_CFG_EN bit of the FUNC_CFG_ACCESS register is set to 1. In order to enable the soft-iron correction algorithm it is necessary to set to 1 the FUNC_EN bit of the CTRL10_C register, the IRON_EN bit of the MASTER_CONFIG register and the SOFT_EN bit of the CTRL9_XL register (Table 48. Ironing configuration).

7.5.3 Getting compensated magnetometer data

The status of magnetometer data acquisition and hard-iron/soft-iron correction can be checked using the FUNC_SRC1 register:

- SENSORHUB_END_OP bit is set high when the sensor hub routine has completed. The acquired
 magnetometer raw data are available in registers from address 66h (OUT_MAG_RAW_X_L) to 6Bh
 (OUT_MAG_RAW_Z_H).
- SI_END_OP bit is set high when the execution of the enabled hard-iron and soft-iron algorithms has
 completed. If the soft-iron correction is enabled, the magnetometer uncalibrated data (with soft-iron only
 applied) are available in registers from address 4Dh (SENSORHUB13_REG) to 52h
 (SENSORHUB18_REG). The magnetometer calibrated data, with both hard-iron (if enabled) and soft-iron (if
 enabled) correction, are available in registers from address 2Eh (SENSORHUB1_REG) to 33h
 (SENSORHUB6_REG).

If latched mode is disabled (LIR bit of TAP_CFG is set to 0), the SENSORHUB_END_OP and SI_END_OP bits are active only for 1/100 Hz, then they are automatically deasserted. If latched mode is enabled, these two bits are cleared by reading the FUNC_SRC1 register.

The SENSORHUB_END_OP signal can be driven to the INT1 interrupt pin by setting the DRDY_ON_INT1 bit of the MASTER_CONFIG register to 1. The SI_END_OP signal can be driven to the INT2 interrupt pin by setting the INT2 IRON bit of the MD2 CFG register to 1.

A schematic representation of hard-iron and soft-iron correction feature is illustrated in Figure 27. Hard-iron / soft-iron correction block scheme below.

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If the soft-iron correction is enabled and the soft-iron registers still have the default zero value, then the magnetometer calibrated data and the magnetometer uncalibrated data will also be equal to zero. As a consequence, when the soft-iron correction is enabled, the soft-iron transformation matrix must be at least initialized to the identity matrix multiplied by 8, setting the value of the MAG_SI_XX, MAG_SI_YY and MAG_SI_ZZ registers to 08h.

HI(3x1): hard-iron vector SI(3X3): soft-iron rotation matrix MAG_OFFX_H & MAG_OFFX_L MAG_SI_XX MAG_SI_XY MAG_SI_XZ MAG_OFFY_H & MAG_OFFY_L MAG_SI_YX MAG_SI_YY MAG_SI_YZ MAG OFFZ H & MAG OFFZ L MAG SI ZX MAG_SI_ZY MAG SI ZZ MAG RAW DATA: (from reg 66h to reg 6Bh) Mx Hard-iron M raw(3x1) =My Mz HI(3x1) correction algorithm MASTER_CONFIG IRON_EN MAG CALIBRATED DATA: (from reg 2Eh to reg 33h) SI(3x3) * [M_raw(3x1) - HI(3x1)] Soft-iron MAG UNCALIBRATED DATA: SI(3x3) correction (from reg 4Dh to reg 52h) algorithm SI(3x3) * [M_raw(3x1) - HI(3x1)] + HI(3x1) CTRL9_XL SOFT_EN

Figure 27. Hard-iron / soft-iron correction block scheme

7.5.4 Ironing example

The following example demonstrates how to define the values to be assigned to hard-iron and soft-iron correction registers starting from the calculated hard-iron vector and soft-iron rotation matrix. This example refers to the usage of the LIS2MDL magnetometer sensor.

Hard-iron (X,Y,Z) offset values vector (gauss):

$$HI(3x1) = \begin{bmatrix} -0.335605 \\ 0.126487 \\ -0.114722 \end{bmatrix}$$

These three offset values must be divided by the LIS2MDL sensitivity value (0.0015 gauss / LSB) in order the get the LSB values to be written in the hard-iron correction registers (Table 49. Hard-iron register values).

	Offset values [LSB]	Register values
v	X -224 (FF20h)	MAG_OFFX_H = FFh
^		MAG_OFFX_L = 20h
.,	Y 84 (0054h)	MAG_OFFY_H = 00h
Y		MAG_OFFY_L = 54h
Z	-76 (FFB4h)	MAG_OFFZ_H = FFh
		MAG_OFFZ_L = B4h

Table 49. Hard-iron register values

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Soft-iron rotation matrix:

$$SI(3x3) = \begin{bmatrix} 1.229006 & 0.173917 & 0.052327 \\ 0.173917 & 1.033307 & -0.130089 \\ 0.052327 & -0.130089 & 1.243645 \end{bmatrix}$$

These soft-iron matrix elements must be multiplied by 8 in order to get the LSB values to be written in the soft-iron correction registers (Table 50. Soft-iron register values). LSB values are expressed in sign-magnitude format.

Table 50. Soft-iron register values

	Soft-iron matrix elements	Register values
XX	+1.229006	MAG_SI_XX = 0Ah
XY	+0.173917	MAG_SI_XY = 01h
XZ	+0.052327	MAG_SI_XZ = 00h
YX	+0.173917	MAG_SI_YX = 01h
YY	+1.033307	MAG_SI_YY = 08h
YZ	-0.130089	MAG_SI_YZ = 81h
ZX	+0.052327	MAG_SI_ZX = 00h
ZY	-0.130089	MAG_SI_ZY = 81h
ZZ	+1.243645	MAG_SI_ZZ = 0Ah

The code provided below gives a basic routine to configure the LIS2MDL external magnetometer sensor (refer to the datasheet for additional details) in continuous mode, initialize the hard-iron and soft-iron correction registers and read the magnetometer output registers. In this case, the pass-through feature is not used for the magnetometer configuration.

1.	Write 80h to FUNC_CFG_ACCESS	// Enable access to embedded functions registers (bank A)
2.	Write 3Ch to SLV0_ADD	// LIS2MDL slave address = 0011110b
		// Enable write operation (rw_0=0)
3.	Write 60h to SLV0_SUBADD	// 60h is the LIS2MDL register to be written
4.	Write 8Ch to DATAWRITE_SRC_MODE_SUB_SLV0	// 8Ch is the value to be written in register 60h of
		// LIS2MDL to configure it in continuous mode,
		// ODR = 100 Hz, temperature compensation enabled
5.	Write 10h to SLAVE0_CONFIG	// Set Aux_sens_on bits different from 00b
6.	Write 20h to SLAVE1_CONFIG	// Enable write_once bit
7.	Write 00h to FUNC_CFG_ACCESS	// Disable access to embedded functions registers (bank A)
8.	Write 04h to CTRL10_C	// Enable embedded functions
9.	Write 09h to MASTER_CONFIG	// Enable internal pull-up on SDx/SCx lines
		// Sensor hub trigger signal is XL Data Ready
		// Enable auxiliary I ² C master
10.	Write 80h to CTRL1_XL	// Turn on the accelerometer (for trigger signal)
11.	Read FUNC_SRC1	// Wait for the sensor hub communication concluded
12.	If SENSORHUB_END_OP = 0, go to 9	
13.	Write 00h to CTRL10_C	// Disable embedded functions
14.	Write 00h to MASTER_CONFIG	// Disable auxiliary I ² C master
15.	Write 00h to CTRL1_XL	// Turn off the accelerometer

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16.	Write 80h to FUNC_CFG_ACCESS	// Enable access to embedded functions registers (bank A)
17.	Write 3Dh to SLV0_ADD	// LIS2MDL slave address = 0011110b
		// Enable read operation (rw_0=1)
18.	Write 68h to SLV0_SUBADD	// 68h is the first LIS2MDL output register to be read
19.	Write 06h to SLAVE0_CONFIG	// No decimation
		// 1 external sensor connected
		// Number of registers to read = 6
20.	Write FFh to MAG_OFFX_H	// X offset value initialization
21.	Write 20h to MAG_OFFX_L	// X offset value initialization
22.	Write 00h to MAG_OFFY_H	// Y offset value initialization
23.	Write 54h to MAG_OFFY_L	// Y offset value initialization
24.	Write FFh to MAG_OFFZ_H	// Z offset value initialization
25.	Write B4h to MAG_OFFZ_L	// Z offset value initialization
26.	Write 0Ah to MAG_SI_XX	// XX soft-iron element
27.	Write 01h to MAG_SI_XY	// XY soft-iron element
28.	Write 00h to MAG_SI_XZ	// XZ soft-iron element
29.	Write 01h to MAG_SI_YX	// YX soft-iron element
30.	Write 08h to MAG_SI_YY	// YY soft-iron element
31.	Write 81h to MAG_SI_YZ	// YZ soft-iron element
32.	Write 00h to MAG_SI_ZX	// ZX soft-iron element
33.	Write 81h to MAG_SI_ZY	// ZY soft-iron element
34.	Write 0Ah to MAG_SI_ZZ	// ZZ soft-iron element
35.	Write 00h to FUNC_CFG_ACCESS	// Disable access to embedded functions registers (bank A)
36.	Write 04h to CTRL10_C	// Enable embedded functions
37.	Write 0Bh to MASTER_CONFIG	// Enable internal pull-up on SDx/SCx lines
		// Sensor hub trigger signal is XL data-ready
		// Enable hard-iron correction
		// Enable auxiliary I ² C master
38.	Write 04h to CTRL9_XL	// Enable soft-iron correction
39.	Write 80h to CTRL1_XL	// Turn on the accelerometer (for trigger signal)

The acquired magnetometer raw data are available in registers from address 66h (OUT_MAG_RAW_X_L) to 6Bh (OUT_MAG_RAW_Z_L).

The magnetometer uncalibrated data (with soft-iron only applied) are available in registers from address 4Dh (SENSORHUB13_REG) to 52h (SENSORHUB18_REG).

The magnetometer calibrated data, with both hard-iron and soft-iron correction, are available in registers from address 2Eh (SENSORHUB1_REG) to 33h (SENSORHUB6_REG).

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8 First-in first-out (FIFO) buffer

In order to limit intervention by the host processor and facilitate post-processing data for event recognition, the LSM6DS3TR-C embeds a 4 kB first-in first-out buffer (FIFO).

The FIFO can be configured to store the following data:

- · gyroscope sensor data;
- accelerometer sensor data;
- external sensor (connected to sensor hub interface) data;
- step counter and timestamp data;
- temperature sensor data.

Saving data in the FIFO buffer is based on four 'FIFO data sets' consisting of 6 bytes each:

- The 1st FIFO data set is reserved for gyroscope data;
- The 2nd FIFO data set is reserved for accelerometer data;
- The 3rd FIFO data set is reserved for the external sensor data stored in the registers from SENSORHUB1_REG to SENSORHUB6_REG (see Section 7.2.10 SENSORHUBx_REG registers for details on the SENSORHUBx_REG);
- The 4th FIFO data set can be alternately associated to the external sensor data stored in the registers from SENSORHUB7_REG to SENSORHUB12_REG, to the step counter and timestamp info, or to the temperature sensor data.

All these data sets can be stored in FIFO at different ODRs, by setting the decimation factors in the FIFO_CTRL3 and FIFO_CTRL4 registers. Decimation factors are also used to select which FIFO data sets have to be stored in FIFO

Five different FIFO operating modes can be chosen through the FIFO_MODE_[2:0] bits of the FIFO_CTRL5 register:

- Bypass mode;
- FIFO mode:
- · Continuous mode:

INT2 CTRL register.

- · Continuous-to-FIFO mode;
- Bypass-to-Continuous mode.

Note: When the FIFO is used, the IF_INC and BDU bits of the CTRL3_C register must be equal to 1.

Data are retrieved from the FIFO through two dedicated registers: FIFO_DATA_OUT_L and FIFO_DATA_OUT_H. In this way, data can be read either from the FIFO (at a slower ODR) or from the device output registers (at the normal ODR).

To monitor the FIFO status (full, empty, number of samples stored, etc.), four dedicated registers are available: FIFO_STATUS1, FIFO_STATUS2, FIFO_STATUS3, FIFO_STATUS4.

Programmable FIFO thresholds can be set in FIFO_CTRL1 and FIFO_CTRL2 using the FTH_[10:0] bits. FIFO full, FIFO threshold and FIFO overrun events can be enabled to generate dedicated interrupts on the two interrupt pins (INT1 and INT2) through the INT1_FULL_FLAG, INT1_FTH and INT1_FIFO_OVR bits of the INT1_CTRL register, and through the INT2_FULL_FLAG, INT2_FTH and INT2_FIFO_OVR bits of the

In order to increase the number of samples which can be stored in the FIFO, it is also possible to store (as 1st FIFO data set) only the 8 most significant bits of the accelerometer and gyroscope data by setting the bit ONLY_HIGH_DATA in the FIFO_CTRL4 register.

Writing data in the FIFO can be triggered by the accelerometer/gyroscope data-ready; it can also be triggered by the sensor hub data-ready (corresponding to the behavior of the SENSORHUB_END_OP bit of FUNC_SRC1 register): in this case the DATA_VALID_SEL_FIFO bit of the MASTER_CONFIG register must be set to 1. Moreover, if DATA_VALID_SEL_FIFO is set to 0 and the TIMER_PEDO_FIFO_DRDY bit of the FIFO_CTRL2 register is set to 1, data are stored in FIFO every time a step is detected.

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8.1 FIFO registers

The FIFO buffer is managed by:

- five control registers (from FIFO_CTRL1 to FIFO_CTRL5);
- four status registers (from FIFO STATUS1 to FIFO STATUS4);
- two data output registers (FIFO DATA OUT L and FIFO DATA OUT H);
- some additional bits to enable threshold usage (STOP_ON_FTH) and route FIFO full, threshold or overrun events to the two interrupt lines (bits: INT1_FULL_FLAG, INT2_FULL_FLAG, INT1_FTH, INT1_FIFO_OVR, INT2_FIFO_OVR).

8.1.1 FIFO_CTRL1 (06h)

The FIFO_CTRL1 register contains the lower part of the 11-bit FIFO threshold level. For the complete threshold level configuration, consider also the FTH_[10:8] bits of the FIFO_CTRL2 register. The value of the FIFO threshold level is referred to data having 16-bit format.

The FIFO watermark flag (WaterM bit in FIFO_STATUS2 register) rises when the number of bytes stored in the FIFO is equal to or higher than the threshold level.

In order to limit the FIFO depth to the watermark level, the STOP_ON_FTH bit must be set to 1 in the FIFO CTRL4 register.

Table 51. FIFO_CTRL1 register

b7	b6	b5	b4	b3	b2	b1	b0
FTH_7	FTH_6	FTH_5	FTH_4	FTH_3	FTH_2	FTH_1	FTH_0

8.1.2 FIFO_CTRL2 (07h)

Table 52. FIFO_CTRL2 register

b7	b6	b5	b4	b3	b2	b1	b0
TIMER_ PEDO_ FIFO_EN	TIMER_ PEDO_ FIFO_ DRDY	0	0	FIFO_ TEMP_ EN	FTH_10	FTH_9	FTH_8

- TIMER_PEDO_FIFO_EN enables step counter and timestamp data to be stored as the 4th FIFO data set. The content of the 6 bytes stored in the FIFO when this bit is set to 1 is described in Section 8.8 Step counter and timestamp data in FIFO.
- TIMER_PEDO_FIFO_DRDY. When this bit is set to 1 and the DATA_VALID_SEL_FIFO bit in the
 MASTER_CONFIG register is set to 0, all the data are stored in the FIFO every time a new step has been
 detected by the step counter. See Section 8.3 Setting the FIFO trigger, FIFO ODR and decimation factors for
 details.
- FIFO_TEMP_EN bit enables temperature data to be stored as the 4th FIFO data set. The content of the 6 bytes stored in the FIFO when this bit is set to 1 is described in Section 8.9 Temperature data in FIFO.
- FTH_[10:8] contains the upper part of the FIFO threshold level. For the complete threshold level configuration, consider also the FTH_[7:0] bits in the FIFO_CTRL1 register.

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8.1.3 FIFO_CTRL3 (08h)

The FIFO_CTRL3 register contains the accelerometer and gyroscope FIFO decimation factors, used to choose if the data of these sensors have to be stored in the FIFO and at which rate they are stored.

When the DEC_FIFO_GYRO[2:0] bits are set to 000b, the 1st FIFO data set (reserved for gyroscope data) is not stored in the FIFO. When the DEC_FIFO_XL[2:0] bits are set to 000b, the 2nd FIFO data set (reserved for accelerometer data) is not stored in the FIFO.

Table 53. FIFO_CTRL3 register

b7	b6	b5	b4	b3	b2	b1	b0
		DEC_	DEC_	DEC_	DEC_	DEC_	DEC_
0	0	FIFO_	FIFO_	FIFO_	FIFO_	FIFO_	FIFO_
		GYRO2	GYRO1	GYRO0	XL2	XL1	XL0

Table 54. Gyroscope FIFO decimation setting

DEC_FIFO_GYRO [2:0]	Configuration
000	Gyroscope sensor not in FIFO
001	No decimation
010	Decimation with factor 2
011	Decimation with factor 3
100	Decimation with factor 4
101	Decimation with factor 8
110	Decimation with factor 16
111	Decimation with factor 32

Table 55. Accelerometer FIFO decimation setting

DEC_FIFO_XL [2:0]	Configuration
000	Accelerometer sensor not in FIFO
001	No decimation
010	Decimation with factor 2
011	Decimation with factor 3
100	Decimation with factor 4
101	Decimation with factor 8
110	Decimation with factor 16
111	Decimation with factor 32

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8.1.4 FIFO_CTRL4 (09h)

The FIFO_CTRL4 register contains the decimation factors used to define at which data rate the data associated to the 3rd FIFO and the 4th FIFO data sets are stored in the FIFO.

When the DEC_DS3_FIFO[2:0] bits are set to 000b, the 3rd FIFO data set is not stored in the FIFO. When the DEC_DS4_FIFO[2:0] bits are set to 000b, the 4th FIFO data set is not stored in the FIFO.

The FIFO_CTRL4 register also contains the bit ONLY_HIGH_DATA, which allows storing in the FIFO only the upper part (Most Significant Byte) of the accelerometer and gyroscope data in order to increase the maximum number of accelerometer and gyroscope samples in the FIFO. See Section 8.7 High part of gyroscope and accelerometer data for more details about this functionality.

The FIFO_CTRL4 register contains the bit STOP_ON_FTH, which allows limiting the FIFO depth to the watermark level.

b7 b6 b5 b4 b3 b2 b1 b0 ONLY_ DEC_ DEC_ DEC_ DEC_ DEC_ DEC_ STOP_ HIGH DS4 DS4 DS4 DS3 DS3 DS3 ON_FTH _DATA _FIFO2 FIFO1 FIFO0 FIFO2 FIFO1 FIFO0

Table 56. FIFO_CTRL4 register

Table 57. 3 ^r	d FIFO	data se	t decimation	setting
---------------------------------	--------	---------	--------------	---------

DEC_DS3_FIFO [2:0]	Configuration
000	3 rd FIFO data set not in FIFO
001	No decimation
010	Decimation with factor 2
011	Decimation with factor 3
100	Decimation with factor 4
101	Decimation with factor 8
110	Decimation with factor 16
111	Decimation with factor 32

Table 58. 4th FIFO data set decimation setting

DEC_DS4_FIFO [2:0]	Configuration
000	4 th FIFO data set not in FIFO
001	No decimation
010	Decimation with factor 2
011	Decimation with factor 3
100	Decimation with factor 4
101	Decimation with factor 8
110	Decimation with factor 16
111	Decimation with factor 32

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8.1.5 FIFO_CTRL5 (0Ah)

The FIFO_CTRL5 register contains the FIFO operating mode bits (FIFO_MODE_[2:0]) and the FIFO output data rate bits (ODR_FIFO_[3:0]).

FIFO operating modes are described in Section 8.2 FIFO modes.

When the internal trigger (accelerometer/gyroscope data-ready) is used, the ODR_FIFO_[3:0] bits define the maximum data rate at which data are stored in FIFO. Data can be stored in FIFO at a lower data rate using the FIFO decimation factors. For more information about FIFO trigger and FIFO ODR configuration see Section 8.3 Setting the FIFO trigger, FIFO ODR and decimation factors.

Note: When the FIFO is used, the IF_INC bit of the CTRL3_C register must be equal to 1.

Table 59. FIFO_CTRL5 register

b7	b6	b5	b4	b3	b2	b1	b0
0	ODR_	ODR_	ODR_	ODR_	FIFO_	FIFO_	FIFO_
	FIFO_3	FIFO_2	FIFO_1	FIFO_0	MODE_2	MODE_1	MODE_0

Table 60. FIFO ODR selection setting

ODR_FIFO [3:0]	Configuration
0000	FIFO disabled
0001	FIFO ODR is set to 12.5 Hz
0010	FIFO ODR is set to 26 Hz
0011	FIFO ODR is set to 52 Hz
0100	FIFO ODR is set to 104 Hz
0101	FIFO ODR is set to 208 Hz
0110	FIFO ODR is set to 416 Hz
0111	FIFO ODR is set to 833 Hz
1000	FIFO ODR is set to 1.66 kHz
1001	FIFO ODR is set to 3.33 kHz
1010	FIFO ODR is set to 6.66 kHz

Table 61. FIFO mode selection

FIFO_MODE [2:0]	Configuration
000	Bypass mode. FIFO disabled.
001	FIFO mode. Stops collecting data when FIFO is full.
010	Reserved
011	Continuous mode until trigger is deasserted, then FIFO mode.
100	Bypass mode until trigger is deasserted, then Continuous mode.
101	Reserved
110	Continuous mode. If the FIFO is full, the new sample overwrites the older one.
111	Reserved

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8.1.6 FIFO_STATUS1 (3Ah)

The FIFO_STATUS1 register, together with the FIFO_STATUS2 register, provides information about the number of samples stored in the FIFO. Each sample is represented as 16-bit data.

Table 62. FIFO_STATUS1 register

b7	b6	b5	b4	b3	b2	b1	b0
DIFF_							
FIFO_7	FIFO_6	FIFO_5	FIFO_4	FIFO_3	FIFO_2	FIFO_1	FIFO_0

8.1.7 FIFO_STATUS2 (3Bh)

The FIFO_STATUS2 register, together with the FIFO_STATUS1 register, provides information about the number of samples stored in the FIFO and about the current status (watermark, overrun, full, empty) of the FIFO buffer.

Table 63. FIFO_STATUS2 register

b7	b6	b5	b4	b3	b2	b1	b0
WaterM	OVER	FIFO_FULL	FIFO_	0	DIFF_	DIFF_	DIFF_
vvalenvi	_RUN	_SMART	EMPTY	0	FIFO_10	FIFO_9	FIFO_8

- WaterM represents the watermark status. This bit is set high when the number of bytes already stored in the FIFO is equal to or higher than the watermark level (each sample is represented as 16-bit data). The watermark status can be driven to the two interrupt pins by setting to 1 the INT1_FTH bit of the INT1_CTRL register or the INT2_FTH bit of the INT2_CTRL register.
- OVER_RUN is set high when the FIFO is completely filled and at least one sample has already been
 overwritten to store the new data. This signal can be driven to the two interrupt pins by setting to 1 the
 INT1_FIFO_OVR bit of the INT1_CTRL register or the INT2_FIFO_OVR bit of the INT2_CTRL register.
- FIFO_FULL_SMART is set high when the next set of data that will be stored in FIFO will make the FIFO full.
 This signal can be driven to the two interrupt pins by setting to 1 the INT1_FULL_FLAG bit of the INT1_CTRL register or the INT2_FULL_FLAG bit of the INT2_CTRL register.
- FIFO_EMPTY is set high when the FIFO is empty.
- DIFF_FIFO_[10:8] contains the upper part of the number of unread words (16-bit data) stored in the FIFO.
 The lower part is represented by the DIFF_FIFO_[7:0] bits in FIFO_STATUS1. The value of
 DIFF_FIFO_[10:0] field corresponds to the number of samples in the FIFO (each sample is represented as
 16-bit data). When a FIFO overrun event occurs (OVER_RUN bit is set high), the value of the
 DIFF_FIFO_[10:0] field is set to 0.

Register content is updated synchronously to the FIFO write and read operations, as illustrated in Table 64. FIFO_STATUS2 behavior (case with one sensor in FIFO, STOP_ON_FTH = 0).

Table 64. FIFO_STATUS2 behavior (case with one sensor in FIFO, STOP_ON_FTH = 0)

FIFO_OVER_RUN	FIFO_FULL	FIFO_EMPTY	DIFF_FIFO_ [10:0]	Number of FIFO samples	FIFO trigger timing
0	0	1	0	0	t0
0	0	0	3	3	t1
0	0	0	6	6	t2
0	0	0	2044	2044	t_full - 2
0	1	0	2047	2047	t_full - 1
1	1	0	0	2048 (old sample overwritten)	t_full

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8.1.8 FIFO_STATUS3 (3Ch)

The FIFO_STATUS3 register, together with FIFO_STATUS4 register, specifies which axis of which sensor data will be read at the next reading. For more information on how to retrieve data from the FIFO see Section 8.5 FIFO pattern.

Table 65. FIFO_STATUS3 register

b7	b6	b5	b4	b3	b2	b1	b0
FIFO_							
PATTERN							
_7	_6	_5	_4	_3	_2	_1	_0

8.1.9 FIFO_STATUS4 (3Dh)

The FIFO_STATUS4 register, together with the FIFO_STATUS3 register, specifies which axis of which sensor data will be read at the next reading. For more information on how to retrieve data from the FIFO see Section 8.5 FIFO pattern.

Table 66. FIFO_STATUS4 register

b7	b6	b5	b4	b3	b2	b1	b0
						FIFO_	FIFO_
0	0	0	0	0	0	PATTERN	PATTERN
						_9	_8

8.1.10 FIFO_DATA_OUT_L (3Eh)

The FIFO_DATA_OUT_L register is the least significant byte of the FIFO output data. The most significant byte is stored in the FIFO_DATA_OUT_H register. For more information on how to retrieve data from the FIFO, see Section 8.4 Retrieving data from the FIFO.

Table 67. FIFO_DATA_OUT_L register

b7	b6	b5	b4	b3	b2	b1	b0
DATA_							
OUT_FIFO							
_L_7	_L_6	_L_5	_L_4	_L_3	_L_2	_L_1	_L_0

8.1.11 FIFO_DATA_OUT_H (3Fh)

The FIFO_DATA_OUT_H register is the most significant byte of the FIFO output data. The least significant byte is stored in the FIFO_DATA_OUT_L register. For more information on how to retrieve data from the FIFO, see Section 8.4 Retrieving data from the FIFO.

Table 68. FIFO_DATA_OUT_H register

b7	b6	b5	b4	b3	b2	b1	b0
DATA_							
OUT_FIFO							
_H_7	_H_6	_H_5	_H_4	_H_3	_H_2	_H_1	_H_0

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8.2 FIFO modes

The LSM6DS3TR-C FIFO buffer can be configured to operate in five different modes selectable through the FIFO_MODE_[2:0] field of the FIFO_CTRL5 register. The available configurations ensure a high level of flexibility and extend the number of functions usable in application development.

Bypass, FIFO, Continuous, Continuous-to-FIFO and Bypass-to-Continuous modes are described in the following paragraphs.

Note: When the FIFO is used, the IF_INC bit of the CTRL3_C register must be equal to 1.

8.2.1 Bypass mode

When Bypass mode is enabled, the FIFO is not used, the buffer content is cleared, and it remains empty until another mode is selected.

Bypass mode is selected when the FIFO_MODE_[2:0] bits are set to 000b. When this mode is enabled, the FIFO_STATUS2 register contains the value 10h (FIFO empty).

Bypass mode must be used in order to stop and reset the FIFO buffer when a different mode is operating. Note that by placing the FIFO buffer into Bypass mode, the whole buffer content is cleared.

8.2.2 FIFO mode

In FIFO mode, the buffer continues filling until it becomes full. Then it stops collecting data and the FIFO content remains unchanged until a different mode is selected.

Follow these steps for FIFO mode configuration (if the accelerometer/gyroscope data-ready is used as the FIFO trigger):

- Choose the decimation factor for each sensor through the decimation bits in the FIFO_CTRL3 and FIFO_CTRL4 registers (see Section 8.3 Setting the FIFO trigger, FIFO ODR and decimation factors for details);
- 2. Choose the FIFO ODR through the ODR_FIFO_[3:0] bits in the FIFO_CTRL5 register;
- 3. Set the FIFO_MODE_[2:0] bits in the FIFO_CTRL5 register to 001b to enable FIFO mode.

When this mode is selected, the FIFO starts collecting data. The FIFO_STATUS1 and FIFO_STATUS2 registers are updated according to the number of samples stored.

When the next stored set of data will make the FIFO full, the FIFO_FULL_SMART bit of the FIFO_STATUS2 register is set to 1 and no more data are stored in the FIFO buffer. Data can be retrieved after the FIFO_FULL_SMART event by reading the FIFO_DATA_OUT_L and FIFO_DATA_OUT_H registers for the number of times specified by the DIFF_FIFO_[10:0] bits of the FIFO_STATUS1 and FIFO_STATUS2 registers.

Using the WaterM bit of the FIFO_STATUS2 register, data can also be retrieved when a threshold level (FTH_[10:0] in FIFO_CTRL1 and FIFO_CTRL2 registers) is reached if the application requires a lower number of samples in the FIFO.

If the STOP_ON_FTH bit of the FIFO_CTRL4 register is set to 1, the FIFO size is limited to the value of the FTH_[10:0] bits in the FIFO_CTRL1 and FIFO_CTRL2 registers: in this case, the FIFO_FULL_SMART bit of the FIFO_STATUS2 register is set high when the number of samples in FIFO will reach or exceed the FTH_[10:0] value on the next FIFO write operation.

Communication speed is not very important in FIFO mode because the data collection is stopped and there is no risk of overwriting data already acquired. Before restarting the FIFO mode, it is necessary to set to Bypass mode first in order to completely clear the FIFO content.

Figure 28. FIFO mode (STOP_ON_FTH = 0) shows an example of FIFO mode usage. In the example X-Y-Z data (green cells indicate the sample number) from just one sensor are stored in the FIFO. In these conditions, the number of 16-bit samples that can be stored in the FIFO buffer is 2046.

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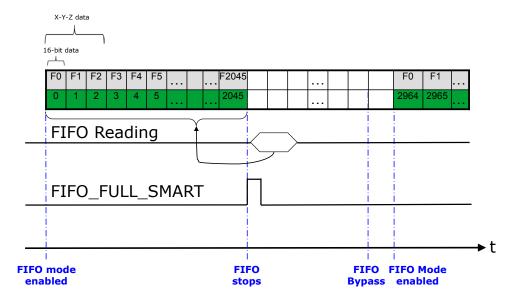


Figure 28. FIFO mode (STOP_ON_FTH = 0)

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8.2.3 Continuous mode

In Continuous mode, the FIFO continues filling. When the buffer is full, the FIFO index restarts from the beginning, and older data are replaced by the new data. The oldest values continue to be overwritten until a read operation frees FIFO slots. The host processor's reading speed is important in order to free slots faster than new data is made available. To stop this configuration, Bypass mode must be selected.

Follow these steps for Continuous mode configuration (if the accelerometer/gyroscope data-ready is used as the FIFO trigger):

- Choose the decimation factor for each sensor through the decimation bits in the FIFO_CTRL3 and FIFO_CTRL4 registers (see Section 8.3 Setting the FIFO trigger, FIFO ODR and decimation factors for details):
- 2. Choose the FIFO ODR through the ODR FIFO [3:0] bits in the FIFO CTRL5 register;
- 3. Set the FIFO MODE [2:0] bits in the FIFO CTRL5 register to 110b to enable FIFO Continuous mode.

When this mode is selected, the FIFO collects data continuously. The FIFO_STATUS1 and FIFO_STATUS2 registers are updated according to the number of samples stored.

When the next stored set of data will make the FIFO full, the FIFO_FULL_SMART bit of the FIFO_STATUS2 register is set to 1. The OVER_RUN bit in the FIFO_STATUS2 register indicates when at least one sample has been overwritten to store the new data.

Data can be retrieved after the FIFO_FULL_SMART event by reading the FIFO_DATA_OUT_L and FIFO_DATA_OUT_H registers for the number of times specified by the DIFF_FIFO_[10:0] bits in the FIFO_STATUS1 and FIFO_STATUS2 registers.

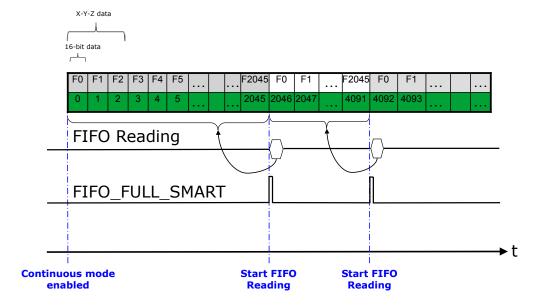
Using the WaterM bit of the FIFO_STATUS2 register, data can also be retrieved when a threshold level (FTH [10:0] in FIFO CTRL1 and FIFO CTRL2 registers) is reached.

If the STOP_ON_FTH bit of FIFO_CTRL4 register is set to 1, the FIFO size is limited to the value of the FTH_[10:0] bits in the FIFO_CTRL1 and FIFO_CTRL2 registers: in this case, the FIFO_FULL_SMART bit of the FIFO_STATUS2 register is set high when the number of samples in FIFO will reach the FTH_[10:0] value on the next FIFO write operation.

It is recommended to read faster than 1*ODR at least three times the number of the enabled FIFO data set in order to free FIFO slots for the new data: this allows avoiding loss of data.

Figure 29. Continuous mode shows an example of the Continuous mode usage. In the example, X-Y-Z data (green cells indicate the sample number) from just one sensor are stored in the FIFO and the FIFO samples are read faster than 1 * ODR so that no data is lost. In these conditions, the number of 16-bit samples stored is 2046.

Figure 29. Continuous mode



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8.2.4 Continuous-to-FIFO mode

This mode is a combination of the Continuous and FIFO modes previously described. In Continuous-to-FIFO mode, the FIFO buffer starts operating in Continuous mode and switches to FIFO mode when an event condition occurs.

The event condition can be one of the following:

- Significant motion: event detection has to be configured and the INT1_SIG_MOT bit of the INT1_CTRL register has to be set to 1;
- Tilt: event detection has to be configured and the INT2_TILT bit of the MD2_CFG register has to be set to 1;
- Step detection: event detection has to be configured and the INT1_STEP_DETECTOR bit of the INT1_CTRL register has to be set to 1;
- Single tap: event detection has to be configured and the INT2_SINGLE_TAP bit of the MD2_CFG register
 has to be set to 1;
- Double tap: event detection has to be configured and the INT2_DOUBLE_TAP bit of the MD2_CFG register
 has to be set to 1;
- Free-fall: event detection has to be configured and the INT2_FF bit of the MD2_CFG register has to be set to 1:
- Wake-up: event detection has to be configured and the INT2_WU bit of the MD2_CFG register has to be set to 1;
- 6D: event detection has to be configured and the INT2 6D bit of the MD2 CFG register has to be set to 1.

Continuous-to-FIFO mode is sensitive to the edge of the interrupt signal: at the first interrupt event, FIFO changes from Continuous mode to FIFO mode and maintains it until Bypass mode is set.

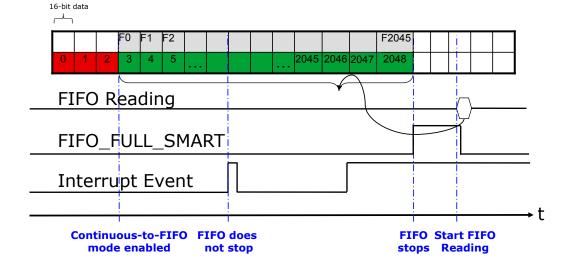


Figure 30. Continuous-to-FIFO mode

Follow these steps for Continuous-to-FIFO mode configuration (if the accelerometer/gyroscope data-ready is used as the FIFO trigger):

- 1. Configure one of the events as previously described;
- Choose the decimation factor for each sensor through the decimation bits in the FIFO_CTRL3 and FIFO_CTRL4 registers (see Section 8.3 Setting the FIFO trigger, FIFO ODR and decimation factors for details);
- 3. Choose the FIFO ODR through the ODR FIFO [3:0] bits in the FIFO CTRL5 register;
- Set the FIFO_MODE_[2:0] bits in the FIFO_CTRL5 register to 011b to enable FIFO Continuous-to-FIFO mode.

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In Continuous-to-FIFO mode the FIFO buffer continues filling; when the next stored set of data will make the FIFO full, the FIFO_FULL_SMART bit is set high.

If the STOP_ON_FTH bit of the FIFO_CTRL4 register is set to 1, the FIFO size is limited to the value of the FTH_[10:0] bits in the FIFO_CTRL1 and FIFO_CTRL2 registers: in this case, the FIFO_FULL_SMART bit of the FIFO_STATUS2 register is set high when the number of samples in FIFO will reach or exceed the FTH_[10:0] value on the next FIFO write operation.

When the trigger event occurs, two different cases can be observed:

- 1. If the FIFO buffer is already full (FIFO_FULL_SMART = 1), it stops collecting data at the first sample after the event trigger. The FIFO content is composed of the samples collected before the event.
- 2. If FIFO buffer is not full yet (initial transient), it continues filling until it becomes full (FIFO_FULL_SMART = 1) and then, if the trigger is still present, it stops collecting data.

Continuous-to-FIFO can be used in order to analyze the history of the samples which have generated an interrupt; the standard operation is to read the FIFO content when the FIFO mode is triggered and the FIFO buffer is full and stopped.

8.2.5 Bypass-to-Continuous mode

This mode is a combination of the Bypass and Continuous modes previously described. In Bypass-to-Continuous mode, the FIFO buffer starts operating in Bypass mode and switches to Continuous mode when a trigger condition occurs.

The event condition can be one of the following:

- Significant motion: event detection has to be configured and the INT1_SIG_MOT bit of the INT1_CTRL register has to be set to 1;
- Tilt: event detection has to be configured and the INT2_TILT bit of the MD2_CFG register has to be set to 1;
- Step detection: event detection has to be configured and the INT1_STEP_DETECTOR bit of the INT1_CTRL register has to be set to 1;
- Single tap: event detection has to be configured and the INT2_SINGLE_TAP bit of MD2_CFG register has to be set to 1;
- Double tap: event detection has to be configured and the INT2_DOUBLE_TAP bit of the MD2_CFG register
 has to be set to 1;
- Free-fall: event detection has to be configured and the INT2_FF bit of the MD2_CFG register has to be set to 1.
- Wake-up: event detection has to be configured and the INT2_WU bit of the MD2_CFG register has to be set to 1;
- 6D: event detection has to be configured and the INT2_6D bit of the MD2_CFG register has to be set to 1.

Bypass-to-Continuous mode is sensitive to the edge of the interrupt signal: at the first interrupt event, FIFO changes from Bypass mode to Continuous mode and maintains it until Bypass mode is set.

Follow these steps for Bypass-to-Continuous mode configuration (if the accelerometer / gyroscope data-ready is used as the FIFO trigger):

- 1. Configure one of the events as previously described;
- 2. Choose the decimation factor for each sensor through the decimation bits in the FIFO_CTRL3 and FIFO CTRL4 registers (see Section 8.3 Setting the FIFO trigger, FIFO ODR and decimation factors for details);
- 3. Choose the FIFO ODR through the ODR_FIFO_[3:0] bits in the FIFO_CTRL5 register.
- 4. Set the FIFO_MODE_[2:0] bits in the FIFO_CTRL5 register to 100b to enable FIFO Bypass-to-Continuous mode.

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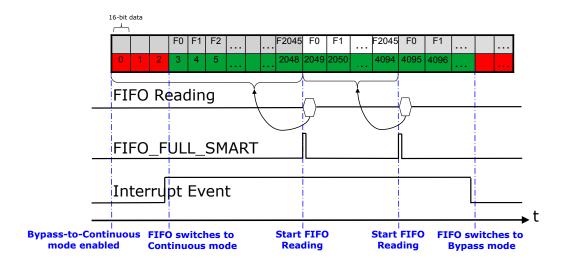


Figure 31. Bypass-to-Continuous mode

Once the trigger condition appears and the buffer switches to Continuous mode, the FIFO buffer continues filling. When the next stored set of data will make the FIFO full, the FIFO_FULL_SMART bit is set high.

Bypass-to-Continuous can be used in order to start the acquisition when the configured interrupt is generated.

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DATA SET DECIMATOR

DEC_DS4_FIFO[2:0]



8.3 Setting the FIFO trigger, FIFO ODR and decimation factors

Writing data in the FIFO can be configured to be triggered by three different sources.

 $F(odr) = min (MAX(ODR_XL, ODR_G), ODR_FIFO)$ 1st FIFO DATA SET DECIMATOR ODR_XL DATA_VALID_SEL_FIFO = 0 TIMER_PEDO_FIFO_DRDY = 0 DEC_FIFO_GYRO[2:0] ODR_G F(odr) ODR_FIFO 2nd FIFO DATA SET **FIFO** DECIMATOR SIGNAL DATA_VALID_SEL_FIFO = 0 TIMER_PEDO_FIFO_DRDY = 1 DEC_FIFO_XL[2:0] **FIFO** STEP DETECTED 3rd FIFO DATA SET DECIMATOR DATA VALID SEL FIFO = 1 DEC_DS3_FIFO[2:0] SENSORHUB END OP TIMER_PEDO_FIFO_DRDY = X 4th FIFO

Figure 32. FIFO trigger signal selection

As described in Figure 32. FIFO trigger signal selection, the DATA_VALID_SEL_FIFO bit of the MASTER_CONFIG register and the TIMER_PEDO_FIFO_DRDY bit of the FIFO_CTRL2 register are used for this purpose:

- If both the DATA_VALID_SEL_FIFO bit and the TIMER_PEDO_FIFO_DRDY bit are set to 0, writing data in the FIFO is triggered by the accelerometer/gyroscope data-ready. The ODR_FIFO_[3:0] bits of FIFO_CTRL5 define the maximum data rate at which data are stored in FIFO; the latter is limited to the maximum value between the accelerometer ODR (defined by the ODR_XL[3:0] bits of the CTRL1_XL register) and the gyroscope ODR (defined by the ODR_G[3:0] bits of the CTRL2_G register);
- If the DATA_VALID_SEL_FIFO bit is set to 0 and the TIMER_PEDO_FIFO_DRDY bit is set to 1, writing data in the FIFO is triggered by step detection (corresponding to the behavior of the STEP_DETECTED bit of the FUNC SRC1 register): the data are stored in FIFO every time a step is detected;
- If the DATA_VALID_SEL_FIFO bit is set to 1, writing data in the FIFO is triggered by the sensor hub (corresponding to the behavior of the SENSORHUB_END_OP bit of the FUNC_SRC1 register), regardless of the configuration of the TIMER_PEDO_FIFO_DRDY bit: the data are stored in FIFO when the sensor hub routine is complete.

Using the FIFO decimation factors, data can be stored in FIFO at a rate lower than the rate of the FIFO trigger signal. Four decimation factors can be configured, one for each FIFO data set:

- The DEC_FIFO_G[2:0] bits of the FIFO_CTRL3 register define if the gyroscope data (associated to the 1st FIFO data set) are stored in FIFO and the relative rate;
- The DEC_FIFO_XL[2:0] bits of the FIFO_CTRL3 register define if the accelerometer data (associated to the 2nd FIFO data set) are stored in FIFO and the relative rate;
- The DEC_DS3_FIFO[2:0] bits of the FIFO_CTRL4 register define if the data associated to the 3rd FIFO data set are stored in FIFO and the relative rate;
- The DEC_DS4_FIFO[2:0] bits of the FIFO_CTRL4 register define if the data associated to the 4th FIFO data set are stored in FIFO and the relative rate.

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8.3.1 Procedure for ODR or FIFO configuration changes when using FIFO

Apply the following procedure when an accelerometer/gyroscope ODR or FIFO configuration change has to be performed:

- Read all the data stored in the FIFO to empty it (see Section 8.4 Retrieving data from the FIFO for details);
- 2. Set the FIFO in Bypass mode (set the FIFO MODE bits of the FIFO CTRL5 register to 000b);
- Set the target ODR for the accelerometer and gyroscope through the ODR_XL bits of the CTRL1_XL
 register and the ODR_G bits of the CTRL2_G register respectively;
- 4. Set the target ODR for the FIFO through the ODR_FIFO bits of the FIFO_CTRL5 register;
- 5. Set the gyroscope decimation factor in the DEC_FIFO_G[2:0] bits of the FIFO_CTRL3 register and the accelerometer decimation factor in the DEC_FIFO_XL[2:0] bits of the FIFO_CTRL3 register (see Table 54. Gyroscope FIFO decimation settingand Table 55. Accelerometer FIFO decimation setting for the values to be set in the DEC_FIFO_G[2:0] bits and the DEC_FIFO_XL[2:0] bits of FIFO_CTRL3).
- 6. Set the desired FIFO operating mode (see Section 8.3 Setting the FIFO trigger, FIFO ODR and decimation factors for details).

8.4 Retrieving data from the FIFO

Note: When data are stored in the FIFO, the configuration must not be changed in order to be able to retrieve data correctly.

When FIFO is enabled and the mode is different from Bypass, reading the FIFO output registers (FIFO_DATA_OUT_L and FIFO_DATA_OUT_H) returns the oldest FIFO sample set. Whenever these registers are read, their content is moved to the SPI/I²C output buffer. FIFO slots are ideally shifted up one level in order to release room for a new sample, and the FIFO output registers load the current oldest value stored in the FIFO buffer.

The recommended way to retrieve data from the FIFO is the following:

- 1. Read the FIFO_STATUS1 and FIFO_STATUS2 registers to check how many words (16-bit data) are stored in the FIFO. This information is contained in the DIFF_FIFO_[10:0] bits.
- Read the FIFO_STATUS3 and FIFO_STATUS4 registers. The FIFO_PATTERN_[9:0] bits allows
 understanding which sensor and which couple of bytes are being read (see Section 8.5 FIFO pattern for
 more details).
- 3. Read the FIFO_DATA_OUT_L and FIFO_DATA_OUT_H registers to retrieve the oldest sample (16-bits format) in the FIFO. They are respectively the lower and the upper part of the oldest sample.

The entire FIFO content is retrieved by performing a certain number of read operations from the FIFO output registers until the buffer becomes empty (FIFO_EMPTY bit of FIFO_STATUS2 register is set high).

Note: Once the FIFO is empty, data must not be retrieved from the FIFO_DATA_OUT_L and FIFO_DATA_OUT_H registers.

It is recommended to read faster than 1*ODR at least three times the number of the enabled FIFO data set in order to free FIFO slots for the new data: this allows avoiding loss of data.

The rounding function (see Section 4.7 Rounding functions for details) is automatically enabled when applying a multiple read operation to the FIFO output registers FIFO DATA OUT L and FIFO DATA OUT H.

8.5 FIFO pattern

Data are stored in the FIFO without any tag in order to maximize the number of samples stored. To understand which couple of data and which FIFO data set is going to be read, it is necessary to check the content of the FIFO_PATTERN_[9:0] bits in the FIFO_STATUS3 and FIFO_STATUS4 registers.

Data are written to the FIFO with a specific pattern (for example GyroX, GyroY, GyroZ, AccX, AccX, AccX). This pattern changes depending on the ODRs and decimation factors assigned to the four FIFO data sets. The FIFO_PATTERN_[9:0] bits contain a number from 0 to the index of the last sample of the pattern, then the pattern is repeated in all FIFO content.

The first sequence of data stored in the FIFO buffer contains the data of all the enabled FIFO data sets, from the first one to the fourth one. Then, data are repeated depending on the value of the decimation factor set for each FIFO data set.

The examples in the next sections explain how to use the information contained in the FIFO_PATTERN_[9:0] bits.

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8.5.1 Example 1

Supposing the FIFO is storing data from the gyroscope and accelerometer at the same ODR:

Gyroscope ODR = 104 Hz, Accelerometer ODR = 104 Hz.

If the internal trigger (accelerometer/gyroscope data-ready) is used, it's recommended to set the ODR_FIFO_[3:0] bits of the FIFO_CTRL5 register to 0100b in order to set the FIFO trigger ODR to 104 Hz.

Both the DEC_FIFO_GYRO[2:0] and the DEC_FIFO_XL[2:0] fields of the FIFO_CTRL3 register have to be set to 001b (no decimation).

The following data pattern is repeated every 6 samples (each sample is represented as 16-bit data):

Gx Gy Gz XLx XLy XLz (gyroscope and accelerometer data)

The FIFO_PATTERN_[9:0] bits will contain a number from 0 to 5, as shown in Table 69. Example 1: FIFO_PATTERN_[9:0] bits and next reading.

Time	FIFO_PATTERN_[9:0]	Next reading from FIFO output registers
t0	0	Gx
tO	1	Gy
t0	2	Gz
tO	3	XLx
tO	4	XLy
tO	5	XLz

Table 69. Example 1: FIFO_PATTERN_[9:0] bits and next reading

8.5.2 Example 2

Supposing the FIFO is storing data from the gyroscope and accelerometer at different ODRs:

Gyroscope ODR = 208 Hz, Accelerometer ODR = 104 Hz.

If the internal trigger (accelerometer/gyroscope data-ready) is used, it's recommended to set the ODR_FIFO_[3:0] bits of the FIFO_CTRL5 register to 0101b in order to set the FIFO trigger ODR to 208 Hz.

The DEC_FIFO_GYRO[2:0] field of the FIFO_CTRL3 register has to be set to 001b (no decimation applied to gyroscope data) and the DEC_FIFO_XL[2:0] field has to be set to 010b (decimation with factor 2 applied to accelerometer data).

Since the gyroscope ODR is twice the accelerometer ODR, the following data pattern is repeated every 9 samples (each sample is represented as 16-bit data):

• Gx Gy Gz XLx XLy XLz Gx Gy Gz

The FIFO_PATTERN_[9:0] bits will contain a number from 0 to 8, as shown in Table 70. Example 2: FIFO_PATTERN_[9:0] bits and next reading.

Table 70. Example 2: FIFO	_PATTERN_[9:0]] bits and next reading
---------------------------	----------------	-------------------------

Time	FIFO_PATTERN_[9:0]	Next reading from FIFO output registers
t0	0	Gx
tO	1	Gy
tO	2	Gz
tO	3	XLx
t0	4	XLy
tO	5	XLz
t1	6	Gx
t1	7	Gy
t1	8	Gz

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8.5.3 **Example 3**

Supposing the FIFO is storing data from the gyroscope, accelerometer and magnetometer at different ODRs:

Gyroscope ODR = 104 Hz, Accelerometer ODR = 208 Hz, Magnetometer ODR = 52 Hz.

If the internal trigger (accelerometer/gyroscope data-ready) is used, it's recommended to set the ODR_FIFO_[3:0] bits of the FIFO_CTRL5 register to 0101b in order to set the FIFO trigger ODR to 208 Hz.

The DEC_FIFO_GYRO[2:0] field of the FIFO_CTRL3 register has to be set to 010b (decimation with factor 2 applied to gyroscope data) and the DEC_FIFO_XL[2:0] field has to be set to 001b (no decimation applied to accelerometer data). Assuming that the magnetometer is associated to the 3rd FIFO data set, the DEC_DS3_FIFO[2:0] field of the FIFO_CTRL4 register has to be set to 100b (decimation with factor 4 applied to magnetometer data).

The following data pattern is repeated every 21 samples:

- Gx Gy Gz XLx XLy XLz Mx My Mz (gyroscope, accelerometer, mag. data 9 samples)
- XLx XLy XLz (accelerometer data 3 samples)
- Gx Gy Gz XLx XLy XLz (gyroscope and accelerometer data 6 samples)
- XLx XLy XLz (accelerometer data 3 samples)

The FIFO_PATTERN_[9:0] bits will contain a number from 0 to 20, as shown in Table 71. Example 3: FIFO_PATTERN_[9:0] bits and next reading.

Table 71. Example 3: FIFO_PATTERN_[9:0] bits and next reading

Time	FIFO_PATTERN_[9:0]	Next reading from FIFO output registers
t0	0	Gx
t0	1	Gy
tO	2	Gz
tO	3	XLx
t0	4	XLy
tO	5	XLz
tO	6	Mx
t0	7	My
tO	8	Mz
t1	9	XLx
t1	10	XLy
t1	11	XLz
t2	12	Gx
t2	13	Gy
t2	14	Gz
t2	15	XLx
t2	16	XLy
t2	17	XLz
t3	18	XLx
t3	19	XLy
t3	20	XLz

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8.6 FIFO threshold

The FIFO threshold is a functionality of the LSM6DS3TR-C FIFO which can be used to check when the number of samples in the FIFO reaches a defined threshold level.

The bits FTH_[10:0] in the FIFO_CTRL1 and FIFO_CTRL2 registers contain the threshold level. The resolution of the FTH_[10:0] field is two bytes (1 LSB = 2 bytes, each sample is represented as 16-bit data). So, the user can select the desired level in a range between 0 and 2047.

The bit WaterM in the FIFO_STATUS2 register represents the watermark status. This bit is set high if the number of samples in the FIFO reaches or exceeds the watermark level (each sample is represented as 16-bit data).

FIFO size can be limited to the threshold level by setting the STOP_ON_FTH bit in the FIFO_CTRL4 register to 1.

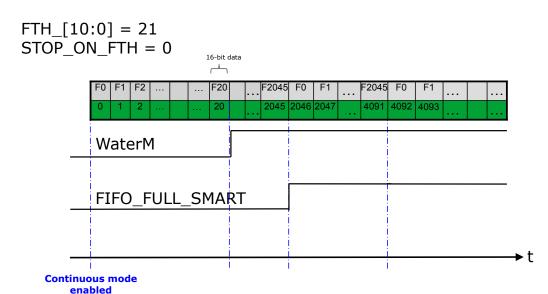


Figure 33. FIFO threshold (STOP_ON_FTH = 0)

Figure 33. FIFO threshold (STOP_ON_FTH = 0) shows an example of FIFO threshold level usage when just accelerometer (or gyroscope) data are stored. The STOP_ON_FTH bit set to 0 in the FIFO_CTRL4 register. The threshold level is set to 21 through the FTH_[10:0] bits. The WaterM bit of the FIFO_STATUS2 register rises after the 21st level has been reached (21 samples in the FIFO). Since the STOP_ON_FTH bit is set to 0, the FIFO will not stop at the 21st sample, but will keep storing data until the FIFO_FULL_SMART flag is set high.

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Figure 34. FIFO threshold (STOP_ON_FTH = 1) in FIFO mode

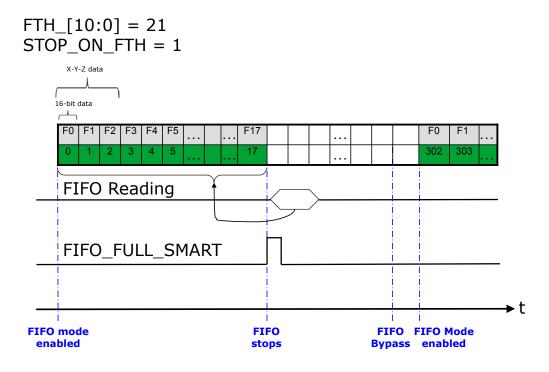


Figure 34. FIFO threshold (STOP_ON_FTH = 1) in FIFO mode shows an example of FIFO threshold level usage in FIFO mode with the STOP_ON_FTH bit set to 1 in the FIFO_CTRL4 register; just accelerometer (or gyroscope) data are stored in this example. The threshold level is set to 21 through the FTH_[10:0] bits and defines the current FIFO size. In FIFO mode, data are stored in the FIFO buffer until the FIFO_FULL_SMART signal rises; the FIFO_FULL_SMART bit of the FIFO_STATUS2 register rises when the next data stored in the FIFO will make the FIFO full, so in this example it rises after the first 18 data (16-bit each) are stored in FIFO. The WaterM bit of the FIFO_STATUS2 register cannot go to 1 since the FTH threshold level is never reached (data are no longer stored in FIFO after the FIFO is full).

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Figure 35. FIFO threshold (STOP_ON_FTH = 1) in Continuous mode

Figure 35. FIFO threshold (STOP_ON_FTH = 1) in Continuous mode shows an example of FIFO threshold level usage in Continuous mode with the STOP_ON_FTH bit set to 1 in the FIFO_CTRL4 register; just accelerometer (or gyroscope) data are stored in this example. The threshold level is set to 21 through the FTH_[10:0] bits. The FIFO_FULL_SMART bit of the FIFO_STATUS2 register rises when the next data stored in the FIFO will make the FIFO full, so in this example it rises after the first 18 data (16-bit each) are stored in FIFO. The WaterM bit of the FIFO STATUS2 register rises after the 21st level has been reached (21 samples in the FIFO).

8.7 High part of gyroscope and accelerometer data

Continuous mode enabled

It is possible to increase the number of samples stored in the FIFO by storing just the high part (8 bits) of the gyroscope and accelerometer data. This feature is not valid for the other (external) sensors.

To the enable this feature, the bit ONLY_HIGH_DATA must be set to 1 in the FIFO_CTRL4 register. Gyroscope and accelerometer data will be written in the FIFO at the same ODR in the order shown in Table 72. High part of gyroscope and accelerometer data in FIFO.

Table 72. High part of gyroscope and accelerometer data in FIFO

Byte 1	Byte 2	Byte 3	Byte 4	Byte 5	Byte 6
Accel_X_H	Gyro_X_H	Accel_Y_H	Gyro_Y_H	Accel_Z_H	Gyro_Z_H

When this feature is enabled, the 6 bytes containing the high part (8 bits) of the gyroscope and accelerometer data are associated to the 1st FIFO data set and the 2nd FIFO data set is not used.

The DEC_FIFO_G[2:0] field of the FIFO_CTRL3 register has to be set to a value different from 000b (1st FIFO data set stored in FIFO).

The DEC_FIFO_XL[2:0] field of the FIFO_CTRL3 register has to be set to 000b (2nd FIFO data set not in FIFO).

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8.8 Step counter and timestamp data in FIFO

It is possible to store timestamp and step counter data in the FIFO. These data are stored as a 4th FIFO data set in the 6-byte data format shown in Table 73. Timestamp and pedometer data in FIFO.

- 3 bytes for the timestamp;
- 1 byte is not used;
- 2 bytes for the number of steps.

Table 73. Timestamp and pedometer data in FIFO

Byte 1	Byte 2	Byte 3	Byte 4	Byte 5	Byte 6
TIMESTAMP	TIMESTAMP		TIMESTAMP	STEPS	STEPS
[15:8]	[23:16]	-	[7:0]	[7:0]	[15:8]

To enable this feature, the bit TIMER_PEDO_FIFO_EN must be set to 1 in the FIFO_CTRL2 register.

When this feature is enabled, the 6 bytes containing the timestamp and step counter data are associated to the 4th FIFO data set: the DEC_DS4_FIFO[2:0] field of the FIFO_CTRL4 register has to be used to define the decimation factor.

When this feature is enabled and the DATA_VALID_SEL_FIFO bit of the MASTER_CONFIG register is set to 0, data can be stored in the FIFO in two ways depending on the configuration of the TIMER_PEDO_FIFO_DRDY bit in FIFO_CTRL2:

- When the TIMER_PEDO_FIFO_DRDY bit is set to 0, data are written to the FIFO at the ODR_FIFO rate set in the FIFO_CTRL5 register.
- When the TIMER_PEDO_FIFO_DRDY bit is set to 1, data are stored in the FIFO every time a new step is detected.

Follow these steps to store timestamp and pedometer data in the FIFO using either the internal trigger (accelerometer/gyroscope data ready) or the 'step detected' method:

- 1. Turn on the accelerometer;
- 2. Enable the timestamp and pedometer (see Section 6.1 Pedometer functions: step detector and step counter and Section 6.5 Timestamp);
- 3. Choose the decimation factor for the 4th FIFO data set through the DEC_DS4_FIFO[2:0] bits of the FIFO_CTRL4 register;
- Set to 1 the TIMER_PEDO_FIFO_EN bit in the FIFO_CTRL2 register;
- 5. Configure the bit TIMER_PEDO_FIFO_DRDY in the FIFO_CTRL2 register in order to choose the method of storing data in the FIFO (internal trigger or every step detected);
- If an internal trigger is used, choose the FIFO ODR through the ODR_FIFO_[3:0] bits of the FIFO_CTRL5
 register. If 'step detected' trigger is used, no need to set the ODR_FIFO_[3:0] bits;
- 7. Configure the FIFO operating mode through the FIFO MODE [2:0] field of the FIFO CTRL5 register.

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8.9 Temperature data in FIFO

It is possible to store only temperature data as the 4th FIFO data set.

To enable this feature:

- Bit TIMER_PEDO_FIFO_EN of the FIFO_CTRL2 register has to be set to 0;
- Bit FIFO_TEMP_EN of the FIFO_CTRL2 register has to be set to 1.

Temperature samples (16-bit) are stored in FIFO in the 6-byte data format shown in Table 74. Temperature data in FIFO .

Table 74. Temperature data in FIFO

Byte 1	Byte 2	Byte 3	Byte 4	Byte 5	Byte 6
-	-	TEMP [7:0]	TEMP [15:8]	-	-

Follow these steps to store 16-bit temperature data in the FIFO using the internal trigger (accelerometer/gyroscope data-ready):

- 1. Turn on the accelerometer or the gyroscope;
- Choose the decimation factor (different from 000b) for the 4th FIFO data set through the DEC_DS4_FIFO[2:0] bits in the FIFO_CTRL4 register;
- 3. Set to 1 the FIFO_TEMP_EN bit in the FIFO_CTRL2 register and to 0 the bit TIMER_PEDO_FIFO_EN of the FIFO_CTRL2 register;
- 4. Choose the FIFO ODR through the ODR FIFO [3:0] bits of the FIFO CTRL5 register;
- 5. Configure the FIFO operating mode through the FIFO_MODE_[2:0] field of the FIFO_CTRL5 register.

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9 Temperature sensor

The LSM6DS3TR-C is provided with an internal temperature sensor that is suitable for ambient temperature measurement.

If both the accelerometer and the gyroscope sensors are in Power-Down mode, the temperature sensor is off. The maximum output data rate of the temperature sensor is 52 Hz and its value depends on how the accelerometer and gyroscope sensors are configured:

- If the gyroscope is in Power-Down mode:
 - the temperature data rate is equal to 12.5 Hz if the accelerometer ODR is equal to 12.5 Hz Low-Power mode;
 - the temperature data rate is equal to 26 Hz if the accelerometer configuration is 26 Hz Low-Power mode;
 - the temperature data rate is equal to 52 Hz for all other accelerometer configurations.
- If the gyroscope is not in Power-Down mode, the temperature data rate is equal to 52 Hz, regardless of the accelerometer and gyroscope configuration.

For the temperature sensor, the data-ready signal is represented by the TDA bit of the STATUS_REG register. The signal can be driven to the INT2 pin by setting the INT2 DRDY TEMP bit of the INT2 CTRL register to 1.

The temperature data is given by the concatenation of the OUT_TEMP_H and OUT_TEMP_L registers and it is represented as a number of 16 bits in two's complement format with a sensitivity of 256 LSB/°C. The output zero level corresponds to 25 °C.

The LSM6DS3TR-C allows swapping, by setting the BLE bit of the CTRL3_C register to 1, the content of the lower and the upper part of the temperature output data registers (i.e. OUT_TEMP_H with OUT_TEMP_L).

Temperature sensor data can also be stored in FIFO with a configurable decimation factor (see Section 8.9 Temperature data in FIFO for details).

9.1 Example of temperature data calculation

Table 75. Output data registers content vs. temperature provides a few basic examples of the data that is read from the temperature data registers at different ambient temperature values. The values listed in this table are given under the hypothesis of perfect device calibration (i.e. no offset, no gain error,....).

Table 75. Output data registers content vs. temperature

	BLE	≣ = 0	BLE = 1		
Temperature values	Register address				
remperature values	OUT_TEMP_H	OUT_TEMP_L	OUT_TEMP_H	OUT_TEMP_L	
	(21h)	(20h)	(21h)	(20h)	
0°C	E7h	00h	00h	E7	
25°C	00h	00h	00h	00h	
50°C	19h	00h	00h	19h	

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10 Self-test

The embedded self-test functions allows checking the device functionality without moving it.

10.1 Gyroscope self-test

The gyroscope self-test allows testing the mechanical and electrical parts of the gyroscope sensor: when it is activated, an actuation force is applied to the sensor, emulating a definite Coriolis force and the seismic mass is moved by means of this electrostatic test-force. In this case, the sensor output exhibits an output change.

The gyroscope self-test function is off when the ST[1:0]_G bits of the CTRL5_C register are programmed to 00b; it is enabled when the ST[1:0]_G bits are set to 01b (positive sign self-test) or 11b (negative sign self-test).

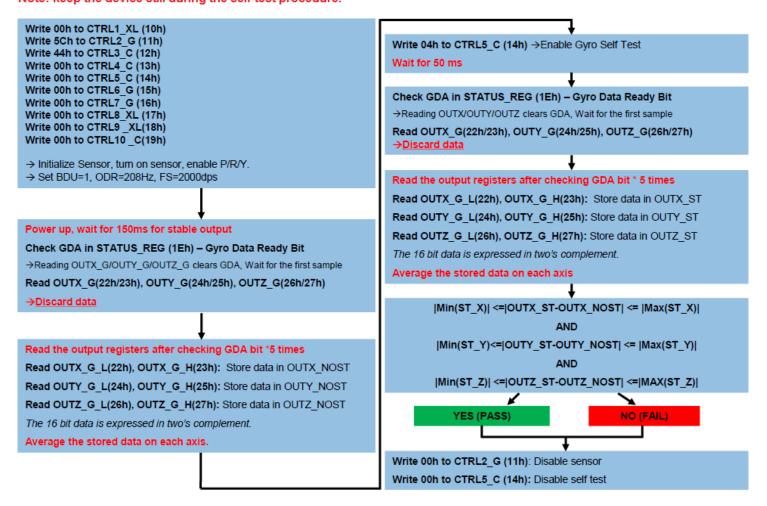
When the gyroscope self-test is active, the sensor output level is given by the algebraic sum of the signals produced by the velocity acting on the sensor and by the electrostatic test-force.

The complete gyroscope self-test procedure is indicated in Figure 36. Gyroscope self-test procedure.

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Figure 36. Gyroscope self-test procedure

Note: keep the device still during the self-test procedure.







10.2 Accelerometer self-test

When the accelerometer self-test is enabled, an actuation force is applied to the sensor, simulating a definite input acceleration. In this case, the sensor outputs exhibit a change in their DC levels which are related to the selected full scale through the sensitivity value.

The accelerometer self-test function is off when the ST[1:0] _XL bits of the CTRL5_C register are programmed to 00b; it is enabled when the ST[1:0] XL bits are set to 01b (positive sign self-test) or 10b (negative sign self-test).

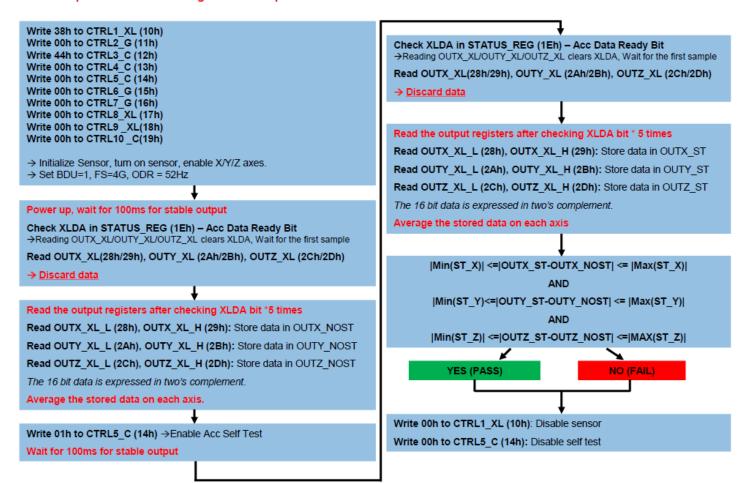
When the accelerometer self-test is activated, the sensor output level is given by the algebraic sum of the signals produced by the acceleration acting on the sensor and by the electrostatic test-force.

The complete accelerometer self-test procedure is indicated in Figure 37. Accelerometer self-test procedure.

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Figure 37. Accelerometer self-test procedure

Note: keep the device still during the self-test procedure.







Revision history

Table 76. Document revision history

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20-Mar-2018	1	Initial release

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